



PXD20



PXD20 Microcontroller Data Sheet

The PXD20 represents a new generation of 32-bit microcontrollers targeting single-chip industrial HMI applications. PXD20 devices are part of the PX family of Power Architecture[®]-based devices. This family has been designed with an emphasis on providing cost-effective and high quality graphics capabilities.

PXD20 devices contain 2 MB internal flash memory. Serial flash memory and DRAM interfaces are provided to allow even greater system flexibility.

The PXD20:

- Includes 2 MB internal flash memory, 1 MB internal graphics SRAM, and 64 KB system SRAM
- Offers high processing performance operating at speeds up to 125 MHz
- Is optimized for low power consumption

The PXD20 is designed to reduce development and production costs of TFT-based displays by providing a single-chip solution with the processing and storage capacity to host and execute real-time application software and drive TFT displays directly.

The PXD20 features a 2D OpenVG 1.1 graphics accelerator, Video Input Unit (VIU2) and two on-chip display control units (DCU3 and DCULite) designed to drive two color TFT displays simultaneously. The PXD20 includes an enhanced QuadSPI serial flash controller and an optional DRAM controller allowing graphics RAM expansion externally.

The PXD20 is compatible with the existing development infrastructure of current Power Architecture devices and are supported with software drivers, operating systems and configuration code to assist with application development.

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Preliminary—Subject to Change Without Notice

1 Overview

1.1 Device comparison

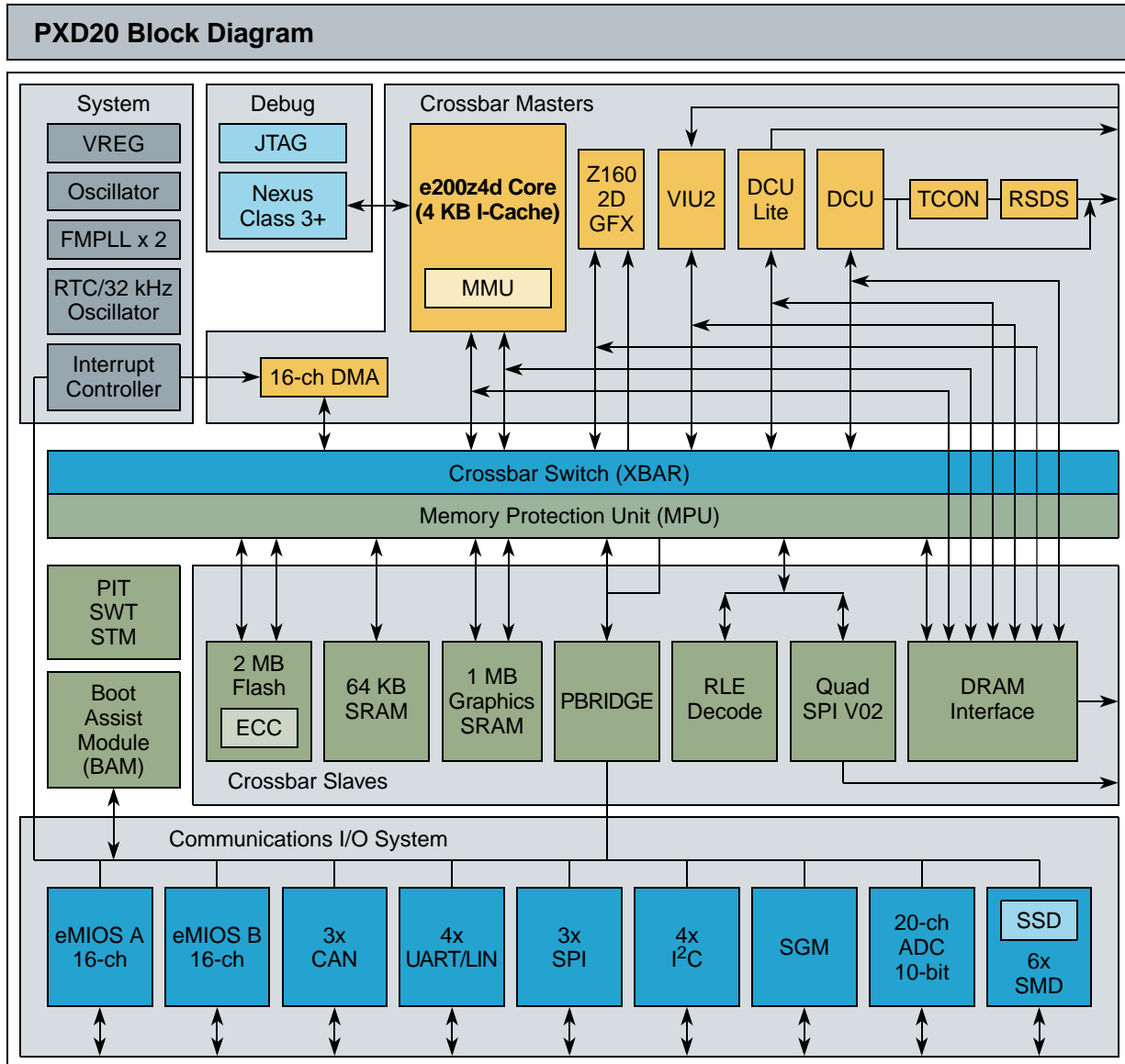
Table 1. PXD20 Family Feature Set

| Feature | PXD20 | | |
|---|--|----------|------------|
| Package | 176 LQFP | 208 LQFP | 416 MAPBGA |
| CPU | e200z4d 4 KB Instruction-Cache 16-entry Memory Management Unit (MMU) Floating Point Unit (FPU) Signal Processing Extension (SPE) | | |
| Execution speed | Static–125 MHz | | |
| Flash memory (ECC) | 2 MB | | |
| RAM (ECC) | 64 KB | | |
| On-chip graphics RAM (no ECC) | 1 MB | | |
| MPU | 16 entry | | |
| eDMA | 16 channels | | |
| DRAM controller | No | | Yes |
| OpenVG Graphics Accelerator (GFX2D) | Yes (OpenVG 1.1) | | |
| Display Control Unit (DCU3) | Yes | | |
| Display Control Unit Lite (DCULite) | No | Yes | |
| Timing Controller (TCON) and RSDS interface | No | Yes | |
| Video Input Unit (VIU2) | Yes | | |
| QuadSPI serial flash interface | Yes | | |
| Stepper Motor Controller (SMC) | 4 motors | 6 motors | |
| Stepper Stall Detect (SSD) | Yes | | |
| Sound Generator Module (SGM) | Yes | | |
| 32 kHz external crystal oscillator | Yes | | |
| Real Time Counter and Autonomous Periodic Interrupt (RTC/API) | Yes | | |
| Periodic interrupt timer (PIT) | 8 ch, 32-bit | | |
| Software Watchdog Timer (SWT) | Yes | | |
| System Timer Module (STM) | 4 ch, 32-bit | | |
| Timed I/O | 20 ch, 16-bit: IC / OC / OPWM 8 ch, 16-bit: IC / OC 4 ch, 16-bit: IC / OC / OPWM / QDEC | | |

Table 1. PXD20 Family Feature Set (continued)

| Feature | PXD20 | | |
|-----------------------------------|-----------------------|---------------------|------------------------|
| Package | 176 LQFP | 208 LQFP | 416 MAPBGA |
| Analog-to-Digital Converter (ADC) | 16 channels, 10-bit | 20 channels, 10-bit | |
| CAN (64 mailboxes) | 3 x CAN | | |
| CAN sampler | Yes | | |
| Serial communication interface | 3 x LIN | 4 x LIN | |
| SPI | 2 x SPI | 3 x SPI | |
| I ² C | 4 | | |
| GPIO | 128 | 150 | 177 |
| Debug | Nexus Class 3 (4xMDO) | | Nexus Class 3 (12xMDO) |

1.2 Block diagram



- | | | | |
|-----------------------|---|-----------------|--|
| ADC | – Analog-to-digital converter | RTC | – Real time clock |
| CAN | – Controller area network controller | RSDS | – Reduced-swing differential signal interface |
| DCU | – Display control unit | SGM | – Sound generator module |
| DMA | – Direct memory access controller | SMD SSD | – Stepper motor driver/stepper stall detect |
| DRAM | – Dynamic random-access memory | SPI | – Serial peripheral interface controller |
| ECC | – Error correction code | SRAM | – Sramic random-access memory |
| eMIOS | – Timed input/output | STM | – System timer module |
| FMPLL | – Frequency-modulated phase-locked loop | SWT | – Software watchdog timer |
| GFX | – OpenVG graphics accelerator | TCON | – Timing controller |
| I²C | – Inter-integrated circuit controller | UART/LIN | – Universal asynchronous receiver/transmitter/ local interconnect network |
| JTAG | – Joint Test Action Group interface | VIU2 | – Video input unit |
| MMU | – Memory management unit | VLE | – Variable-length execution set |
| PBRIDGE | – Peripheral I/O bridge | VREG | – Voltage regulator |
| PIT | – Periodic interrupt timer | | |
| RLE | – Run length encoding | | |

Figure 1. PXD20 block diagram

1.3 Feature list

- Dual-issue, 32-bit Power Architecture Book E compliant CPU core complex (e200z4d)
 - Memory Management Unit (MMU)
 - 4 KB, 2/4-way instruction cache
- 2 MB on-chip ECC flash memory with:
 - Flash memory controller
 - Prefetch buffers
- 64 KB on-chip ECC SRAM
- 1 MB on-chip non-ECC graphics SRAM with two-port graphics SRAM controller
- Memory Protection Unit (MPU) with up to 16 region descriptors and 32-byte region granularity to provide basic memory access permission and ensure separation between different codes and data
- Interrupt Controller (INTC) with 181 peripheral interrupt sources and eight software interrupts
- Two Frequency-Modulated Phase-Locked Loops (FMPLLs)
 - Primary FMPLL (FMPLL0) provides a system clock up to 125 MHz
 - Auxiliary FMPLL (FMPLL1) is available for use as an alternate, modulated or non-modulated clock source to eMIOS modules, QuadSPI and as alternate clock to the DCU and DCU-Lite for pixel clock generation
- Crossbar switch architecture enables concurrent access of peripherals, flash memory or RAM from multiple bus masters
- 16-channel Enhanced Direct Memory Access controller (eDMA) with multiple transfer request sources using a DMA channel multiplexer
- Boot Assist Module (BAM) with 8 KB dedicated ROM for embedded boot code supports boot options including download of boot code via a serial link (CAN or SCI)
- Two Display Control Units (DCU3 and DCULite) for direct drive of up to two TFT LCD displays up to XGA resolution
- Timing Controller (TCON) and RSDS interface for the DCU3 module
- 2D OpenVG 1.1 and raster graphics accelerator (GFX2D)
- Video Input Unit (VIU2) supporting 8/10-bit ITU656 video input, YUV to RGB conversion, video down-scaling, de-interlacing, contrast adjustment and brightness adjustment.
- DRAM controller supporting DDR1, DDR2, LPDDR1 and SDR DRAMs
- Stepper Motor Controller (SMC)
 - High-current drivers for as many as six stepper motors driven in full dual H-bridge configuration
 - Stepper motor return-to-zero and stall detection module
 - Stepper motor short circuit detection
- Sound Generator Module (SGM)
 - 4-channel mixer
 - Supports PCM wave playback and synthesized tones
 - Optional PWM or I²S outputs
- Two 16-channel Enhanced Modular Input Output System (eMIOS) modules
 - Support a range of 16-bit Input Capture, Output Compare, Pulse Width Modulation and Quadrature Decode functions
- 10-bit Analog-to-Digital Converter (ADC) with a maximum conversion time of 1 μ s
 - Up to 20 internal channels
 - Up to 8 external channels
- Three Deserial Serial Peripheral Interface (DSPI) modules for full-duplex, synchronous, communications with external devices
- QuadSPI serial flash memory controller
 - Supports single, dual and quad IO serial flash memory

Overview

- Interfaces to external, memory-mapped serial flash memories
- Supports simultaneous addressing of 2 external serial flashes to achieve up to 80 MB/s read bandwidth
- RLE decoder supporting memory to memory decoding of RLE data in conjunction with eDMA
- Four local interconnect network (LINFlex) controller modules
 - Capable of autonomous message handling (master), autonomous header handling (slave mode), and UART support
 - Compliant with LIN protocol rev 2.1
- Three controller-area network (FlexCAN) modules
 - Compliant with the CAN protocol version 2.0 C
 - 64 configurable buffers
 - Programmable bit rate of up to 1 Mb/s
- Four Inter-Integrated Circuit (I²C) internal bus controllers with master/slave bus interface
- Low-power loop controlled pierce crystal oscillator supporting 4–16MHz external crystal or resonator
- Real Time Counter (RTC) with clock source from internal 128 kHz or 16 MHz oscillator supporting autonomous wake-up with 1 ms resolution with maximum timeout of 2 seconds
 - Support for real time counter (RTC) with clock source from external 32 KHz crystal oscillator, supporting wake-up with 1 s resolution and maximum timeout of one hour
 - RTC optionally clocked by fast 4–16 MHz external oscillator
- System timers:
 - Four-channel 32-bit System Timer Module (STM)
 - Eight-channel 32-bit Periodic Interrupt Timer (PIT) module (including ADC trigger)
 - Software Watchdog Timer (SWT)
- System Integration Unit Lite (SIUL) module to manage external interrupts, GPIO and pad control
- System Status and Configuration Module (SSCM)
 - Provides information for identification of the device, last boot mode, or debug status
 - Provides an entry point for the censorship password mechanism
- Clock Generation Module (MC_CGM) to generate system clock sources and provide a unified register interface, enabling access to all clock sources
- Clock Monitor Unit (CMU)
 - Monitors the integrity of the fast (4–16 MHz) external crystal oscillator and the primary FMPLL (FMPLL0)
 - Acts as a frequency meter, measuring the frequency of one clock source and comparing it to a reference clock
- Mode Entry Module (MC_ME)
 - Controls the device power mode, i.e., RUN, HALT, STOP, or STANDBY
 - Controls mode transition sequences
 - Manages the power control, voltage regulator, clock generation and clock management modules
- Power Control Unit (MC_PCU) to implement standby mode entry/exit and control connections to power domains
- Reset Generation Module (MC_RGM) to manage reset assertion and release to the device at initial power-up
- Nexus Development Interface (NDI) per IEEE-ISTO 5001-2008 Class 3 standard with additional Class 4 features:
 - Watchpoint Triggering
 - Processor Overrun Control
- Device/board boundary-scan testing supported per Joint Test Action Group (JTAG) of IEEE (IEEE 1149.1)
- On-chip voltage regulator controller for regulating the 3.3–5 V supply voltage down to 1.2 V for core logic (requires external ballast transistor)
- Package:¹
 - 176 LQFP, 0.5 mm pitch, 24 mm × 24 mm outline

1. See the device comparison table for package offerings for each device in the family.

- 208 LQFP, 0.5 mm pitch, 28 mm × 28 mm outline
- 416 TEPBGA, 1mm ball pitch, 27 mm × 27 mm outline

1.4 Feature details

1.4.1 Low-power operation

The PXD20 is designed for optimized low-power operation and dynamic power management of the CPU and peripherals. Power management features include software-controlled clock gating of peripherals and multiple power domains to minimize leakage in low-power modes.

There are three low-power modes:

- STANDBY
- STOP
- HALT

and five dynamic power modes — RUN[0..3] and DRUN. All low-power modes use clock gating to halt the clock for all or part of the device.

STANDBY mode turns off the power to the majority of the chip to offer the lowest power consumption mode.

The device can be awakened from STANDBY mode via from any of up to 23 I/O pins, a reset or from a periodic wake-up using a low power oscillator. If required, it is possible to enable the internal 16 MHz oscillator, the external 4–16 MHz oscillator and the external 32 KHz oscillator.

In STANDBY mode the contents of the CPU, on-chip peripheral registers and potentially some of the volatile memory are lost. The two possible configurations in STANDBY mode are:

- The device retains 64 KB of the on-chip SRAM, but the content of the graphics SRAM is lost.
- The device retains 8 KB of the on-chip SRAM, but the content of the graphics SRAM is lost.

STOP mode maintains power to the entire device allowing the retention of all on-chip registers and memory, and providing a faster recovery low power mode than the lowest-power STANDBY mode. There is no need to reconfigure the device before executing code. The clocks to the CPU and peripherals are halted and can be optionally stopped to the oscillator or PLL at the expense of a slower start-up time.

STOP is entered from RUN mode only. Wake-up from STOP mode is triggered by an external event or by the internal periodic wake-up, if enabled.

RUN modes are the main operating modes where the entire device can be powered and clocked and from which most processing activity is done. Four dynamic RUN modes are supported—RUN0 - RUN3. The ability to configure and select different RUN modes enables different clocks and power configurations to be supported with respect to each other and to allow switching between different operating conditions. The necessary peripherals, clock sources, clock speed and system clock prescalers can be independently configured for each of the four RUN modes of the device.

HALT mode is a reduced activity, low power mode intended for moderate periods of lower processing activity. In this mode the CPU system clocks are stopped but user-selected peripheral tasks can continue to run. It can be configured to provide more efficient power management features (switch-off PLL, flash memory, main regulator, etc.) at the cost of longer wake up latency. The system returns to RUN mode as soon as an event or interrupt is pending.

[Table 2](#) summarizes the operating modes of the PXD20.

Table 2. Operating mode summary¹

| Operating mode | SoC features | | | | | Clock sources | | | | | | Periodic Wake-up | Wake-up input | VREG mode | Wake-up time ² | | | | | | |
|----------------|---|-------------|-------|--------------------|--------------|---------------|---------------|------------|--------------|-------------|--------------|------------------|---------------|-----------|---------------------------|-------------|----------------|-------------------|----------|--------------|------------------|
| | CPU GFX accelerator DRAM controller | Peripherals | Flash | RAM | Graphics RAM | Primary PLL | Auxiliary PLL | 16 MHz IRC | 4–16 MHz OSC | 128 kHz IRC | 32 KHz X OSC | | | | VREG start-up | IRC Wake-up | Flash Recovery | OSC Stabilization | PLL Lock | SAW Reconfig | Mode switch over |
| RUN | On | OP | OP | OP ₃ | On | OP | OP | On | OP | On | OP | — | — | FP | — | — | — | — | — | — | — |
| HALT | CG | OP | OP | OP ₃ | On | OP | OP | On | OP | On | OP | OP | OP | FP | — | — | — | — | — | — | TBD |
| STOP | CG | CG | CG | OP ₃ | On | CG | CG | OP | OP | On | OP | OP | OP | LP | 350 μs | 4 μs | 20 μs | 1 ms | 200 μs | — | 24 μs |
| STANDBY | Off | Off | Off | 64 KB ⁴ | Off | Off | Off | OP | OP | OP | OP | OP | OP | LP | 350 μs | 8 μs | 100 μs | 1 ms | 200 μs | Var | 28 μs |
| | Off | Off | Off | 8 KB ⁵ | Off | Off | Off | OP | OP | OP | OP | OP | OP | LP | 200 μs | 8 μs | 100 μs | 1 ms | 200 μs | Var | 28 μs |
| POR | | | | | | | | | | | | | | | 500 μs | 8 μs | 100 μs | 1 ms | 200 μs | | BAM ⁶ |

¹ Table Key:

- On—Powered and clocked
- OP—Optionally configurable to be enabled or disabled (clock gated)
- CG—Clock Gated, Powered but clock stopped
- Off—Powered off and clock gated
- FP—VREG Full Performance mode
- LP—VREG Low Power mode, reduced output capability of VREG but lower power consumption
- Var—Variable duration, based on the required reconfiguration and execution clock speed
- BAM—Boot Assist Module Software and Hardware used for device start-up and configuration

² A high level summary of some key durations that need to be considered when recovering from low power modes. This does not account for all durations at wake up. Other delays will be necessary to consider including, but not limited to the external supply start-up time.

IRC Wake-up time must not be added to the overall wake-up time as it starts in parallel with the VREG.

All other wake-up times must be added to determine the total start-up time.

³ Either 64 KB or 8 KB available.

⁴ 64 KB of the RAM contents is retained, but not accessible in STANDBY mode.

⁵ 8 KB of the RAM contents is retained, but not accessible in STANDBY mode.

⁶ Dependent on boot option after reset.

Additional notes on low power operation:

- Fast wake-up using the on-chip 16 MHz internal RC oscillator allows rapid execution from RAM on exit from low power modes
- The 16 MHz internal RC oscillator supports low speed code execution and clocking of peripherals when it is selected as the system clock and can also be used as the PLL input clock source to provide fast start-up without the external oscillator delay
- The device includes an internal voltage regulator that includes the following features:

- Regulates input to generate all internal supplies
- Manages power gating
- External ballast transistor for high power regulator
- Low-Power and Ultra-Low-Power regulators support operation when in STOP and STANDBY modes, respectively, to minimize power consumption
- Startup on-chip regulators in <math><350\ \mu\text{s}</math> for rapid exit of STOP and STANDBY modes
- Low voltage detection on main supply and 1.2 V regulated supplies.

1.4.2 e200z4d core

The e200z4d Power Architecture core provides the following features:

- Dual issue, 32-bit *Power Architecture Book E* compliant CPU
- Implements the VLE APU for reduced code footprint
- In-order execution and retirement
- Precise exception handling
- Branch processing unit
 - Dedicated branch address calculation adder
 - Branch target prefetching using 8-entry BTB
- Supports independent instruction and data accesses to different memory subsystems, such as SRAM and Flash memory via independent Instruction and Data BIUs.
- Load/store unit
 - 2 cycle load latency
 - Fully pipelined
 - Big and Little endian support
 - Misaligned access support
- 64-bit General Purpose Register file
- Dual AHB 2.v6 64-bit System buses
- Memory Management Unit (MMU) with 16-entry fully-associative TLB and multiple page size support
- 4 KB, 2/4-Way Set Associative Instruction Cache
- Signal Processing Extension (SPE1.1) APU supporting SIMD fixed-point operations using the 64-bit General Purpose Register file.
- Embedded Floating-Point (EFP2) APU supporting scalar and vector SIMD single-precision floating-point operations, using the 64-bit General Purpose Register file.
- Nexus Class 3 real-time Development Unit
- Dynamic power management of execution units, cache and MMU

1.4.3 Crossbar switch (XBAR)

The XBAR multi-port crossbar switch supports simultaneous connections between seven master ports and eight slave ports. The crossbar supports a 32-bit address bus width and a 64-bit data bus width.

The crossbar allows concurrent transactions to occur from any master port to any slave port but one of those transfers must be an instruction fetch from internal flash. If a slave port is simultaneously requested by more than one master port, arbitration logic selects the higher priority master and grants it ownership of the slave port. All other masters requesting that slave port are stalled until the higher priority master completes its transactions. Requesting masters having equal priority are granted access to a slave port in round-robin fashion, based upon the ID of the last master to be granted access.

The crossbar provides the following features:

Overview

- Seven master ports:
 - e200z4d core instruction port
 - e200z4d core complex load/store data port
 - eDMA controller
 - DCU
 - DCU-Lite
 - VIU
 - 2D Graphics Accelerator (GFX2D)
- Seven slave ports:
 - Platform Flash Controller (2 Ports)
 - Platform SRAM Controller
 - Graphics SRAM Controller (2 Ports)
 - QuadSPI serial flash Controller and RLE Decoder
 - Peripheral Bridge
- 32-bit internal address bus, 64-bit internal data bus
- Programmable Arbitration Priority
 - Requesting masters can be treated with equal priority and will be granted access to a slave port in round-robin fashion, based upon the ID of the last master to be granted access or a priority order can be assigned by software at application run time
- Temporary dynamic priority elevation of masters

1.4.4 Enhanced Direct Memory Access (eDMA)

The eDMA module is a controller capable of performing complex data movements via 16 programmable channels, with minimal intervention from the host processor. The hardware micro architecture includes a DMA engine which performs source and destination address calculations, and the actual data movement operations, along with an SRAM-based memory containing the transfer control descriptors (TCD) for the channels. This implementation is utilized to minimize the overall block size. The eDMA module provides the following features:

- 16 channels support independent 8-, 16- or 32-bit single value or block transfers
- Supports variable sized queues and circular queues
- Source and destination address registers are independently configured to post-increment or remain constant
- Each transfer is initiated by a peripheral, CPU, periodic timer interrupt or eDMA channel request
- Each DMA channel can optionally send an interrupt request to the CPU on completion of a single value or block transfer
- DMA transfers possible between system memories, QuadSPI, RLE Decoder, SPIs, I²C, ADC, eMIOS and General Purpose I/Os (GPIOs)
- Programmable DMA Channel Mux allows assignment of any DMA source to any available DMA channel with up to a total of 64 potential request sources.

1.4.5 Interrupt Controller (INTC)

The INTC (interrupt controller) provides priority-based preemptive scheduling of interrupt requests, suitable for statically scheduled hard real-time systems.

For high priority interrupt requests, the time from the assertion of the interrupt request from the peripheral to when the processor is executing the interrupt service routine (ISR) has been minimized. The INTC provides a unique vector for each interrupt request source for quick determination of which ISR needs to be executed. It also provides an ample number of priorities so that

lower priority ISRs do not delay the execution of higher priority ISRs. To allow the appropriate priorities for each source of interrupt request, the priority of each interrupt request is software configurable.

When multiple tasks share a resource, coherent accesses to that resource need to be supported. The INTC supports the priority ceiling protocol for coherent accesses. By providing a modifiable priority mask, the priority can be raised temporarily so that all tasks which share the resource can not preempt each other.

Multiple processors can assert interrupt requests to each other through software settable interrupt requests. These same software settable interrupt requests also can be used to break the work involved in servicing an interrupt request into a high priority portion and a low priority portion. The high priority portion is initiated by a peripheral interrupt request, but then the ISR asserts a software settable interrupt request to finish the servicing in a lower priority ISR. Therefore these software settable interrupt requests can be used instead of the peripheral ISR scheduling a task through the RTOS. The INTC provides the following features:

- Unique 9-bit vector for each of the possible 128 separate interrupt sources
- Eight software triggerable interrupt sources
- 16 priority levels with fixed hardware arbitration within priority levels for each interrupt source
- Ability to modify the ISR or task priority.
 - Modifying the priority can be used to implement the Priority Ceiling Protocol for accessing shared resources.
- External non maskable interrupt directly accessing the main CPU critical interrupt mechanism
- 32 external interrupts

1.4.6 QuadSPI serial flash memory controller

The QuadSPI module enables use of external serial flash memories supporting single, dual and quad modes of operation. It features the following:

- Maximum serial clock frequency 80 MHz
- Memory mapped read access for AHB crossbar switch masters
- Automatic serial flash read command generation by CPU, eDMA, DCU, or DCU-Lite read access on AHB bus
- Supports single, dual and quad serial flash read commands
- Simultaneous mode:
 - Supports concurrent read of two external serial flashes
 - The quad data streams from the two flashes can be recombined in the QuadSPI to achieve up to 80 MB/s read bandwidth with 80 MHz serial flash
- 16×64-bit buffer with speculative fetch and buffer flush mechanisms to maximize read bandwidth of serial flash
- DMA support
- All Serial Flash program, erase, read and configuration commands available via IP bus interface.

1.4.7 System Integration Unit Lite (SIUL)

The SIUL controls MCU reset configuration, pad configuration, external interrupt, general purpose I/O (GPIO), internal peripheral multiplexing, and the system reset operation.

The GPIO features the following:

- Up to four levels of internal pin multiplexing, allowing exceptional flexibility in the allocation of device functions for each package
- Centralized general purpose input output (GPIO) control
- All GPIO pins can be independently configured to support pull-up, pull down, or no pull
- Reading and writing to GPIO supported both as individual pins and 16-bit wide ports
- All peripheral pins can be alternatively configured as both general purpose input or output pins except ADC channels which support alternative configuration as general purpose inputs

Overview

- Direct readback of the pin value supported on all digital output pins through the SIU
- Configurable digital input filter that can be applied to up to 24 general purpose input pins for noise elimination on external interrupts
- Register configuration protected against change with soft lock for temporary guard or hard lock to prevent modification until next reset.

1.4.8 On-chip flash memory with ECC

The PXD20 microcontroller has the following flash memory features:

- 2 MB of flash memory
 - Typical flash memory access time: 0 wait-state for buffer hits, 3 wait-states for page buffer miss at 125 MHz
 - Two 4 × 128-bit page buffers with programmable prefetch control
 - One set of page buffers can be allocated for code-only, fixed partitions of code and data, all available for any access
 - One set of page buffers allocated to Display Controller Units, Graphics Accelerator and the eDMA
 - 64-bit ECC with single-bit correction, double-bit detection for data integrity
- Small block flash arrangement to support features such as boot block, EEPROM Emulation, operating system block.
 - 8×16 KB
 - 2×64 KB
 - 2×128 KB
 - 6×256 KB
- Hardware managed Flash writes, erase and verify sequence
- Censorship protection scheme to prevent Flash content visibility

1.4.9 Static random-access memory (SRAM)

The PXD20 microcontroller has 64 KB general-purpose on-chip SRAM with the following features:

- Typical SRAM access time: 1 wait-state for reads and 32-bit writes
- 32-bit ECC with single-bit correction, double bit detection for data integrity
- Supports byte (8-bit), half word (16-bit), word (32-bit) and double-word (64-bit) writes for optimal use of memory
- User transparent ECC encoding and decoding for byte, half word, and word accesses
- Separate internal power domains applied to 56 KB and 8 KB SRAM blocks during STANDBY modes to retain contents during low power mode.

1.4.10 On-chip graphics SRAM

The PXD20 microcontroller has 1 MB on-chip graphics SRAM with the following features:

- Two crossbar slave ports:
 - One dedicated to the 2D Graphics Accelerator (GFX2D) access
 - One dedicated to all other crossbar masters
- Usable as general purpose SRAM
- Supports byte (8-bit), half word (16-bit), word (32-bit) and double-word (64-bit) writes for optimal use of memory
- RAM controller with hardware RAM fill function supporting all-zeroes or all-ones SRAM initialization
- Independent data buffers (one per AHB port) for maximum system performance
 - Optimized for burst transfers (read + write)
 - Programmable read prefetch capabilities

1.4.11 Memory Protection Unit (MPU)

The MPU features the following:

- Sixteen region descriptors for per master protection
- Start and end address defined with 32-byte granularity
- Overlapping regions supported
- Protection attributes can optionally include process ID
- Protection offered for 4 concurrent read ports
- Read and write attributes for all masters
- Execute and supervisor/user mode attributes for processor masters

1.4.12 2D graphics accelerator (GFX2D)

- Native vector graphics rendering
 - Compatible with OpenVG1.1
 - Complete hardware OpenVG 1.1 rendering pipeline
 - Both geometry and pixel processing
 - Adaptive processing of Bezier curves and strokes
- 16-sample edge anti-aliasing
 - High image quality, font scalability, etc.
 - 4× Rotated Grid Supersampling (RGSS) AA for Flash
- 3D perspective texturing, reflections, and shadowing
- Shading (linear or radial gradient)
- Separate 2D engine for BitBlit, fill and ROP operations
- Significant performance improvement when compared to software or 3D GPU-based OpenVG implementations

1.4.13 Display Control Unit (DCU3)

The DCU3 is a display controller designed to drive TFT LCD displays up to WVGA resolution using direct blit graphics and video.

The DCU3 generates all the necessary signals required to drive the TFT LCD displays: up to 24-bit RGB data bus, Pixel Clock, Data Enable, Horizontal-Sync and Vertical-Sync.

The flexible architecture of the DCU3 enables the display of OpenVG-rendered frame buffer content and direct blit rendered graphics simultaneously.

An optional Timing Controller (TCON) and RSDS interface is available to directly drive the row and column drivers of a display panel.

Internal memory resource of the device allows to easily handle complex graphics contents (pictures, icons, languages, fonts).

The DCU3 supports 4-plane blending and 16 graphics layers. Control Descriptors (CDs) associated with each of the 16 layers enable effective merging of different resolutions into one plane to optimize use of internal memory buffers. A layer may be constructed from graphic content of various resolutions including indexed colors of 1, 2, 4 and 8 bpp, direct colors of 16, 24 and 32 bpp, and a YUV 4:2:2 color space. The ability of the DCU3 to handle input data in resolutions as low as 1bpp, 2bpp and 4bpp enables a highly efficient use of internal memory resources of the PXD20. A special tiled mode can be enabled on any of the 16 layers to repeat a pattern optimizing graphic memory usage.

A hardware cursor can be managed independently of the layers at blending level increasing the efficient use of the internal DCU3 resources.

Overview

To secure the content of all critical information to be displayed, a safety mode can be activated to check the integrity of critical data along the whole system data path from the memory to the TFT pads.

The DCU3 features the following:

- Display color depth: up to 24 bpp
- Generation of all RGB and control signals for TFT
- Four-plane blending
- Maximum number of Input Layers: 16 (fixed priority)
- Dynamic Look-Up-Table (Color and Gamma Look-Up)
- α -blending range: up to 256 levels
- Transparency Mode
- Gamma Correction
- Tiled mode on all the layers
- Hardware Cursor
- Supports YCrCb 4:2:2 input data format
- RLE decode inline supporting direct read of RLE compressed images from system memory
- Critical display content integrity monitoring for Functional Safety support
- Internal Direct Memory Access (DMA) module to transfer data from internal and / or external memory.

The DCU3 also features a Parallel Data Interface (PDI) to receive external digital video or graphic content into the DCU3. The PDI input is directly injected into the DCU3 background plane FIFO. When the PDI is activated, all the DCU3 synchronization is extracted from the external video stream to guarantee the synchronization of the two video sources.

The PDI can be used to:

- Connect a video camera output directly to the PDI
- Connect a secondary display driver as slave with a minimum of extra cost
- Connect a device gathering various Video sources
- Provide flexibility to allow the DCU to be used in slave mode (external synchronization)

The PDI features the following:

- Supported color modes:
 - 8-bit mono
 - 8-bit color multiplexed
 - RGB565
 - 16-bit/18-bit RAW color
- Supported synchronization modes:
 - embedded ITU-R BT.656-4 (RGB565 mode 2)
 - HSYNC, VSYNC
 - Data Enable
- Direct interface with DCU3 background plane FIFO
- Synchronization generation for the DCU3

1.4.14 Display Control Unit Lite (DCULite)

The DCULite is a display controller designed to enable the PXD20 to drive a second TFT LCD display up to XGA resolution using direct blit graphics and video. The DCULite includes all features of the DCU3, including the PDI with the following exceptions:

- Reduced from 4-plane to 2-plane blending
- Reduced from 16 layers to 4 layers
- Reduced CLUT size

1.4.15 Timing controller (TCON) and RSDS interface

The TCON enables direct drive of the row and column drivers of display panels enabling emulation of TCON ICs used in display panels.

- Programmable Timing Generation unit featuring 12 waveform generators allowing high degree of flexibility in panel waveform generation
- Reduced Swing Differential Signaling (RSDS) interface for RGB data and pixel clock
- Conforms to “RSDS ‘Intra Panel’ Interface Specification” Rev. 1.0 (National Semiconductor)

1.4.16 RLE decoder

The RLE decoder is a crossbar slave sharing a slave port with the QuadSPI module. The platform eDMA is used to stream compressed image data into and extract decompressed data out of the RLE Decoder.

- Lossless decompression
- Pixel formats supported: 8bpp, 16bpp, 24bpp and 32bpp
- AHB mapped read and write registers in RLE_DEC to achieve higher throughput
- Programmable fill levels of read and write buffers for initiating burst transfers
- Crop feature: Support for selectively reading out a part of decompressed image data taking complete compressed data for the full image as input.

1.4.17 DRAM controller

The DRAM controller is a multi-port DRAM controller supporting SDR, LPDDR1, DDR-1, and DDR-2 memories. The DRAM controller listens to the incoming requests to the seven buses in parallel and then sends commands to the DRAM from the highest priority bus at the current time

The seven incoming 64-bit buses are:

- DCU3
- DCULite
- e200z4d core - instruction bus
- e200z4d core - data bus
- VIU2
- GFX2D
- eDMA

The DRAM controller features the following:

- Supports CAS latency of 2, 3, and 4 clock cycles.
- Master buses
 - 7 incoming master buses
 - Supports 16-byte and 32-byte bursts
 - Supports byte enables
 - Supports 4-bit priority signal for each bus
- Write buffer contains five 32-byte entries
- Supports 16-wide and 32-wide SDR, DDR1, DDR2 and LPDDR1 DRAM devices
- Controller supports one chip select, 8-bank DRAM system
- Supports dynamic on-die termination in the host device and in the DRAM.
- Supports memory sizes as small as 64Mbit

1.4.18 Video Input Unit (VIU2)

The VIU2 is a crossbar master module accepting an ITU656 compatible video input stream on a parallel interface, converting the pixel data to RGB or YUV format and transferring the video image to internal frame buffer memory or external DRAM if available.

- Supports 8-bit/10-bit ITU656 video input
- Output formats:
 - RGB888
 - RGB565
 - 8-bit monochrome
 - YCrCb 4:2:2
- Video downscaling
- Contrast and Brightness adjustment
- De-interlace for interlaced video image
- Internal DMA engine for data transfer to memory

1.4.19 Boot assist module (BAM)

The BAM is a block of read-only memory that is programmed once by Freescale. The BAM program is executed every time the MCU is powered-on or reset in normal mode. The BAM supports different modes of booting. They are:

- Booting from internal flash memory
- Serial boot loading (A program is downloaded into RAM via CAN or LIN and then executed)
- Booting from external memory

Additionally the BAM:

- Enables and manages the transition of the MCU from reset to user code execution
- Configures device for serial bootloader
- Enables multiple bootcode starting locations out of reset through implementation of search for valid Reset Configuration Halfword
- Enables or disables software watchdog timer out of reset through BAM read of Reset Configuration Halfword option bit

1.4.20 Enhanced Modular Input/Output System (eMIOS)

This device has two eMIOS modules, each with 16 channels supporting a range of 16-bit Input Capture, Output Compare, Pulse Width Modulation, and Quadrature Decode functions.

- Selectable clock source from primary FMPLL, secondary FMPLL, external 4–16 MHz oscillator or 16 MHz Internal RC oscillator on a per module basis
- Timed I/O channels with 16-bit counter resolution
- Buffered updates
- Support for shifted PWM outputs to minimize occurrence of concurrent edges
- Edge aligned output pulse width modulation
 - Programmable pulse period and duty cycle
 - Supports 0% and 100% duty cycle
 - Shared or independent time bases
- Programmable phase shift between channels
- 4 channels of Quadrature Decode
- DMA transfer support

1.4.21 Analog-to-digital converter (ADC)

The ADC features the following:

- 10-bit A/D resolution
- 0–5 V or 0–3.3 V common mode conversion range
- Supports conversions speeds of up to 1 μ s
- 20 internal and 8 external channels support
- Up to 20 single-ended inputs channels
 - 10 channels configured as input only pins
 - 10-bit \pm 2 counts accuracy (TUE)
 - 10 channels configured to have alternate function as general purpose input/output pins
 - 10-bit \pm 3 counts accuracy (TUE)
- External multiplexer support to increase up to 27 channels
 - Automatic 1 \times 8 multiplexer control
 - External multiplexer connected to a dedicated input channel
 - Shared register between the 8 external channels
- Result register available for every non-multiplexed channel
- Configurable Left or Right aligned result format
- Supports for one-shot, scan and injection conversion modes
- Injection mode status bit implemented on adjacent 16-bit register for each result
 - Supports Access to Result and injection status with single 32-bit read
- Independently enabling of function for channels:
 - Pre-sampling
 - Offset error cancellation
 - Offset Refresh
- Conversion Triggering support
 - Internal conversion triggering from periodic interrupt timer (PIT)
- Four configurable analog comparator channels offering range comparison with triggered alarm
 - Greater than
 - Less than
 - Out of range
- All unused analog pins available as general purpose input pins
- Selected unused analog pins available as general purpose pins
- Power Down mode
- Optional support for DMA transfer of results

1.4.22 Serial Peripheral Interface (SPI)

The SPI modules provide a synchronous serial interface for communication between the MCU and external devices.

The SPI features:

- Full duplex, synchronous transfers
- Master or slave operation
- Programmable master bit rates
- Programmable clock polarity and phase
- End-of-transmission interrupt flag
- Programmable transfer baud rate

Overview

- Programmable data frames from 4 to 16 bits
- Up to 3 chip select lines available, depending on package and pin multiplexing, enable 8 external devices to be selected using external muxing from a single SPI
- Eight clock and transfer attributes registers
- Chip select strobe available as alternate function on one of the chip select pins for de-glitching
- FIFOs for buffering up to 4 transfers on the transmit and receive side
- General purpose I/O functionality on pins when not used for SPI
- Queuing operation possible through use of eDMA

1.4.23 Controller Area Network (CAN) module

The PXD20 includes up to three controller area network (CAN) modules. The CAN module is a communication controller implementing the CAN protocol according to Bosch Specification version 2.0B. The CAN protocol was designed to be used primarily as a vehicle serial data bus, meeting the specific requirements of this field: real-time processing, reliable operation in the EMI environment of a vehicle, cost-effectiveness and required bandwidth.

Each CAN module offers the following:

- Compliant with CAN protocol specification, Version 2.0B active
- 64 mailboxes, each configurable as transmit or receive
 - Mailboxes configurable while module remains synchronized to CAN bus
- Transmit features
 - Supports configuration of multiple mailboxes to form message queues of scalable depth
 - Arbitration scheme according to message ID or message buffer number
 - Internal arbitration to guarantee no inner or outer priority inversion
 - Transmit abort procedure and notification
- Receive features
 - Individual programmable filters for each mailbox
 - 8 mailboxes configurable as a 6-entry receive FIFO
 - 8 programmable acceptance filters for receive FIFO
- Programmable clock source
 - System clock
 - Direct oscillator clock to avoid PLL jitter
- Listen only mode capabilities
- CAN Sampler
 - Can catch the 1st message sent on the CAN network while the MCU is stopped. This guarantees a clean startup of the system without missing messages on the CAN network.
 - The CAN sampler is connected to one of the CAN RX pins.

1.4.24 Serial communication interface module (UART)

The PXD20 devices include up to four UART modules and support for UART Master mode, UART Slave mode and UART mode. The modules are UART state machine compliant to the LIN 1.3 and 2.0 and 2.1 Specifications and handle UART frame transmission and reception without CPU intervention.

The serial communication interface module offers the following:

- UART features:
 - Full-duplex operation
 - Standard non return-to-zero (NRZ) mark/space format

- Data buffers with 4-byte receive, 4-byte transmit
- Configurable word length (8-bit or 9-bit words)
- Error detection and flagging
 - Parity, noise and framing errors
- Interrupt driven operation with 4 interrupts sources
- Separate transmitter and receiver CPU interrupt sources
- 16-bit programmable baud-rate modulus counter and 16-bit fractional
- 2 receiver wake-up methods
- LIN features:
 - Autonomous LIN frame handling
 - Message buffer to store identifier and up to eight data bytes
 - Supports message length of up to 64 bytes
 - Detection and flagging of LIN errors
 - Sync field; Delimiter; ID parity; Bit, Framing; Checksum and Timeout errors
 - Classic or extended checksum calculation
 - Configurable Break duration of up to 36-bit times
 - Programmable Baud rate prescalers (13-bit mantissa, 4-bit fractional)
 - Diagnostic features
 - Loop back
 - Self Test
 - LIN bus stuck dominant detection
 - Interrupt driven operation with 16 interrupt sources
 - LIN slave mode features
 - Autonomous LIN header handling
 - Autonomous LIN response handling
 - Discarding of irrelevant LIN responses using up to 16 ID filters

1.4.25 Inter-Integrated Circuit (I²C) controller modules

The PXD20 includes four I²C modules. Each module features the following:

- Two-wire bi-directional serial bus for on-board communications
- Compatibility with I²C bus standard
- Multi-master operation
- Software-programmable for one of 256 different serial clock frequencies
- Software-selectable acknowledge bit
- Interrupt-driven, byte-by-byte data transfer
- Arbitration-lost interrupt with automatic mode switching from master to slave
- Calling address identification interrupt
- Start and stop signal generation/detection
- Repeated START signal generation
- Acknowledge bit generation/detection
- Bus-busy detection

1.4.26 System clocks and clock generation modules

The system clock on the PXD20 can be derived from an external oscillator, an on-chip FMPLL, or the internal 16 MHz oscillator.

The source system clock frequency can be changed via an on-chip programmable clock divider ($\div 1$ to $\div 32$). An additional programmable peripheral bus clock divider (ratios $\div 1$ to $\div 15$) is also available.

The PXD20 has two on-chip FMPLLs (primary and secondary). Each features the following:

- Input clock frequency from 4 MHz to 16 MHz
- Lock detect circuitry continuously monitors lock status
- Loss Of Clock (LOC) detection for reference and feedback clocks
- On-chip loop filter (for improved electromagnetic interference performance and reduction of number of external components required)
- Support for frequency ramping from PLL

The primary FMPLL module is for use as a system clock source. The secondary FMPLL is available for use as an alternate, modulated or non-modulated clock source to eMIOS modules and as alternate clock to the DCU for pixel clock generation.

The main oscillator provides the following features:

- Input frequency range 4–16 MHz
- Square-wave input mode
- Oscillator input mode 3.3 V (5.0 V)
- Automatic level control
- Low power consumption
- PLL reference

The PXD20 also includes the following oscillators:

- 32 KHz low power external oscillator for slow execution, low power, and RTC
- Dedicated internal 128 kHz RC oscillator for low power mode operation and self wake-up
 - $\pm 10\%$ accuracy across voltage and temperature (after factory trimming)
 - Trimming registers to support improved accuracy with in-application calibration
- Dedicated 16 MHz internal RC oscillator
 - Used as default clock source out of reset
 - Provides a clock for rapid start-up from low power modes
 - Provides a back-up clock in the event of PLL or External Oscillator clock failure
 - Offers an independent clock source for the SWT
 - $\pm 5\%$ accuracy across voltage and temperature (after factory trimming)
 - Trimming registers to support frequency adjustment with in-application calibration

1.4.27 Periodic interrupt timer (PIT)

The PIT features the following:

- Eight general purpose interrupt timers
- Two dedicated interrupt timers for triggering ADC conversions
- 32-bit counter resolution
- Clocked by system clock frequency

1.4.28 Real time counter (RTC)

The Real Timer Counter supports wake-up from Low Power modes or Real Time Clock generation

- Configurable resolution for different timeout periods
 - 1 s resolution for >1 hour period
 - 1 ms resolution for 2 second period
- Selectable clock sources from external 32 KHz crystal, external 4–16 MHz crystal, internal 128 kHz RC oscillator or divided internal 16 MHz RC oscillator

1.4.29 System timer module (STM)

The STM is a 32-bit timer designed to support commonly required system and application software timing functions. The STM includes a 32-bit up counter and four 32-bit compare channels with a separate interrupt source for each channel. The counter is driven by the system clock divided by an 8-bit prescale value (1 to 256).

- One 32-bit up counter with 8-bit prescaler
- Four 32-bit compare channels
- Independent interrupt source for each channel
- Counter can be stopped in debug mode

1.4.30 Software watchdog timer (SWT)

The SWT features the following:

- Watchdog supporting software activation or enabled out of Reset
- Supports normal or windowed mode
- Watchdog timer value writable once after reset
- Watchdog supports optional halting during low power modes
- Configurable response on timeout: reset, interrupt, or interrupt followed by reset
- Clock source: 128 kHz RC oscillator

1.4.31 Stepper motor controller (SMC)

The SMC module is a PWM motor controller suitable to drive instruments in a cluster configuration or any other loads requiring a PWM signal. The motor controller has twelve PWM channels associated with two pins each (24 pins in total) driving up to 6 stepper motors.

The SMC module includes the following features:

- 10/11-bit PWM counter
- 11-bit resolution with selectable PWM dithering function
- Left, right, or center aligned PWM
- Output slew rate control
- Output Short Circuit Detection

This module is suited for, but not limited to, driving small stepper and air core motors used in instrumentation applications. This module can be used for other motor control or PWM applications that match the frequency, resolution, and output drive capabilities of the module.

1.4.32 Stepper stall detect (SSD) module

The SSD module provides a circuit to measure and integrate the induced voltage on the non-driven coil of a stepper motor using full steps when the gauge pointer is returning to zero (RTZ).

The SSD module features the following:

- Programmable full step state
- Programmable integration polarity
- Blanking (recirculation) state
- 16-bit integration accumulator register
- 16-bit modulus down counter with interrupt

1.4.33 Sound generator module (SGM)

The SGM features the following:

- 4-channel audio mixer
- Each channel capable of independent Tone generation or Wave playback
- Individual channel volume control (8-bit resolution)
- Tone Mode:
 - Programmable Tone frequency
 - Programmable amplitude envelope: attack, duration and decay
 - Programmable number of tone pulses and inter-tone duration
- Wave Mode:
 - One FIFO per channel working in conjunction with eDMA
 - Supports standard audio sampling rates (4 kHz, 8 kHz, 11.025 kHz, 16 kHz, 22.050 kHz, 32 kHz, 44.100 kHz, 48 kHz)
 - Same sample rate applies to all channels
 - 8-bit, 12-bit, 16-bit input data formats
 - Programmable wave duration and inter-wave duration
 - Repeat mode with programmable number of wave playbacks
- SGM Output:
 - 16-bit PWM channel
 - Integrated I²S master interface for connection to external audio DAC

1.4.34 IEEE 1149.1 JTAG controller (JTAGC)

JTAGC features the following:

- Backward compatible to standard JTAG IEEE 1149.1-2001 test access port (TAP) interface
- Support for boundary scan testing

1.4.35 Nexus Development Interface (NDI)

The Nexus 3 module is compliant with Class 3 of the IEEE-ISTO 5001-2008 standard, with additional Class 4 features available. The following features are implemented:

- Program Trace via Branch Trace Messaging (BTM). Branch trace messaging displays program flow discontinuities (direct and indirect branches, exceptions, etc.), allowing the development tool to interpolate what transpires between the discontinuities. Thus static code may be traced.

- Data Trace via Data Write Messaging (DWM) and Data Read Messaging (DRM). This provides the capability for the development tool to trace reads and/or writes to selected internal memory resources.
- Ownership Trace via Ownership Trace Messaging (OTM). OTM facilitates ownership trace by providing visibility of which process ID or operating system task is activated. An Ownership Trace Message is transmitted when a new process/task is activated, allowing the development tool to trace ownership flow.
- Run-time access to embedded processor memory map via the JTAG port. This allows for enhanced download/upload capabilities.
- Watchpoint Messaging via the auxiliary pins
- Watchpoint Trigger enable of Program and/or Data Trace Messaging
- Data Acquisition Messaging (DQM) allows code to be instrumented to export customized information to the Nexus Auxiliary Output Port.
- Address Translation Messaging via program correlation messages displays updates to the TLB for use by the debugger in correlating virtual and physical address information
- Auxiliary interface for higher data input/output
- Registers for Program Trace, Data Trace, Ownership Trace and Watchpoint Trigger.
- All features controllable and configurable via the JTAG port

2 Pinout and signal descriptions

2.1 176 LQFP package pinout

Figure 2 shows the pinout for the 176-pin LQFP package.

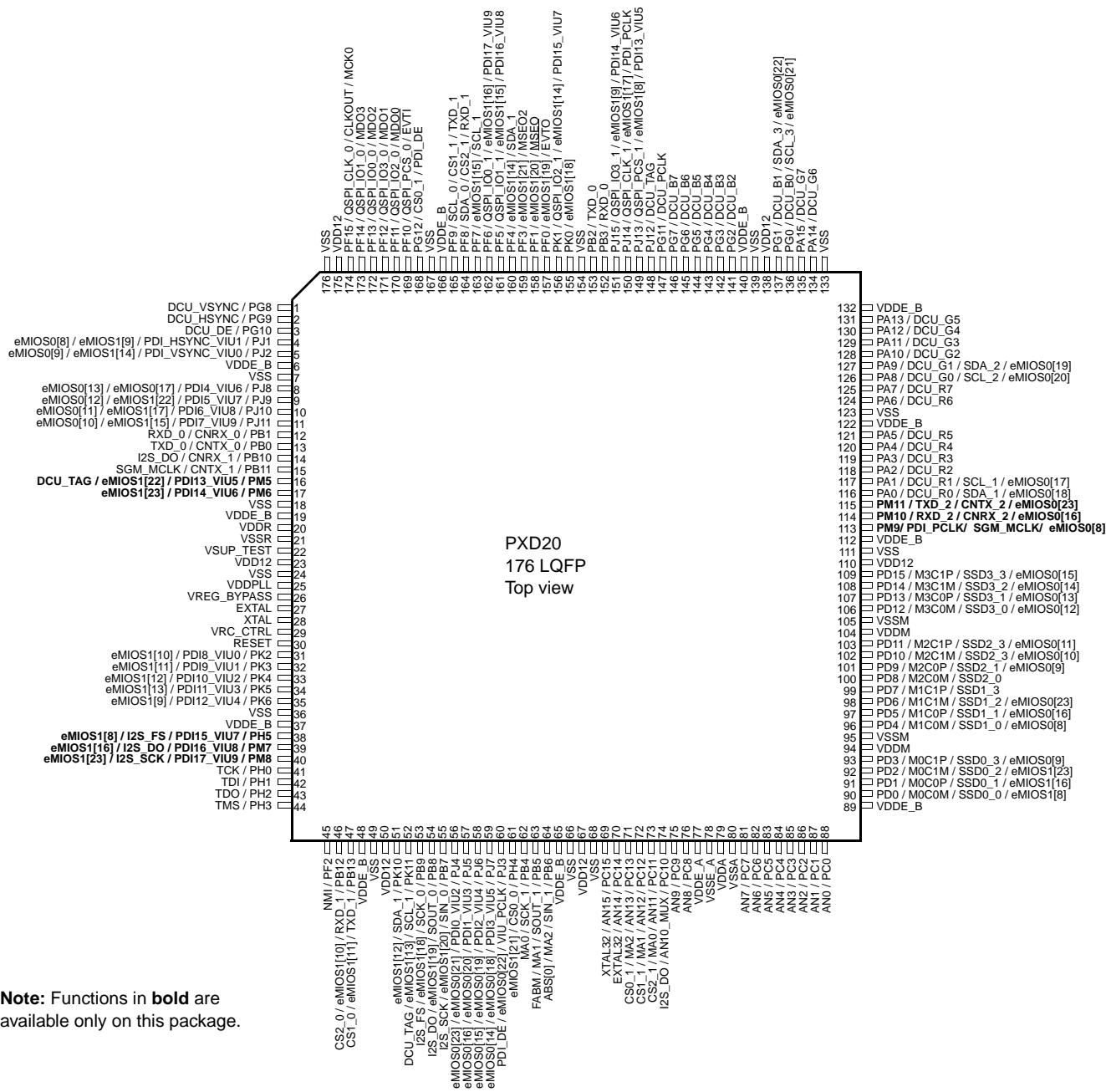


Figure 2. 176-pin LQFP pinout

2.2 208 LQFP package pinout

Figure 3 shows the pinout for the 208-pin LQFP package.

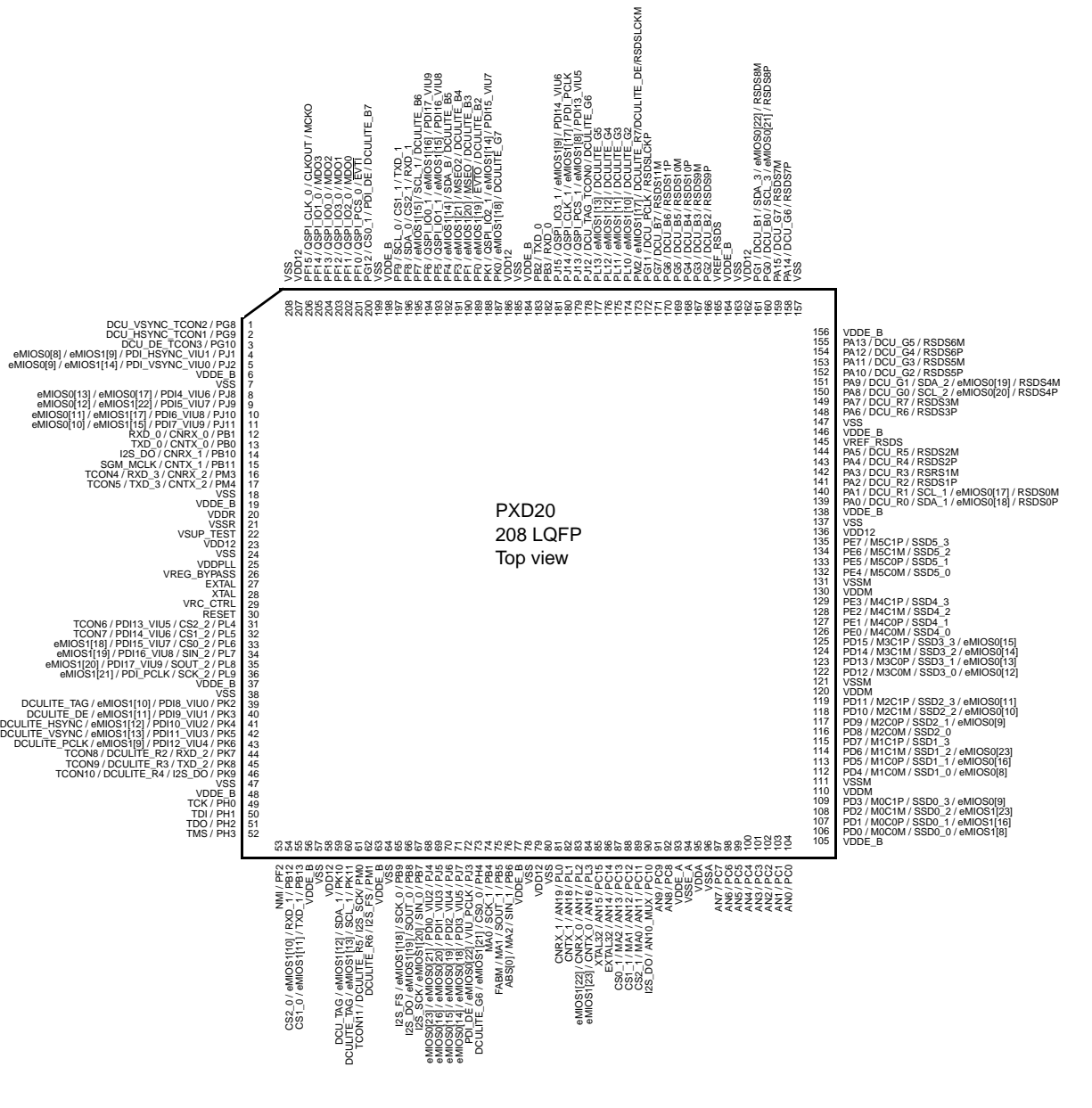


Figure 3. 208-pin LQFP pinout

2.3 416 TEPBGA package pinout–40 to 105°C

Figure 4 shows the pinout for the 416 TEPBGA package.

| | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
|----|------------|--------------|------------|------------|----------|----------|---------------|-----------|-----------|-----------------|-----------------|-----------------|------------------|------------------|------------------|-------|-------|-------|-------|-------|------|------|----------|-------------|------|------|------|------|-----|---|
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 | 17 | 18 | 19 | 20 | 21 | 22 | 23 | 24 | 25 | 26 | | | | |
| A | ddr_dq[26] | ddr_dq[27] | ddr_dq[28] | ddr_dq[29] | 30] | 31] | ddr_ba[0] | ddr_ba[1] | ddr_ba[2] | ddr_addr_ess[0] | ddr_addr_ess[4] | ddr_addr_ess[6] | ddr_addr_ess[8] | ddr_addr_ess[12] | PG12 | PF14 | PF10 | PF8 | PF5 | PF3 | PK0 | PB3 | PJ12 | PL11 | PG7 | PG6 | A | | | |
| B | ddr_dq[25] | VSS | ddr_dqs[3] | ddr_dm[3] | VSS | ddr_cas | ddr_ras | VSS | ddr_web | ddr_addr_ess[1] | VSS | ddr_addr_ess[7] | ddr_addr_ess[9] | VSS | ddr_addr_ess[15] | PF13 | VDDE | PF15 | VSS | PF1 | VDDE | PJ15 | PL13 | VDDE | VSS | PG5 | B | | | |
| C | ddr_dq[23] | VDDE_DDR | VSS | ddr_dq[24] | VDDE_DDR | VSS | ddr_dram_clk | VDDE_DDR | VSS | ddr_addr_ess[2] | VDDE_DDR | VSS | ddr_addr_ess[10] | VDDE_DDR | VSS | PF12 | VSS | PF7 | VDDE | PF0 | VSS | PJ14 | PL12 | PL10 | PG3 | PG4 | C | | | |
| D | ddr_dq[19] | ddr_dq[20] | ddr_dq[21] | ddr_dq[22] | ddr_odt | VDD33_DR | ddr_dram_clkb | ddr_cke | ddr_cs | ddr_addr_ess[3] | ddr_addr_ess[5] | VDD33_DR | ddr_addr_ess[11] | ddr_addr_ess[13] | ddr_addr_ess[14] | PF11 | PF9 | PF6 | PF4 | PK1 | PB2 | PJ13 | PM2 | VREF_RS_DS2 | PG2 | PG1 | D | | | |
| E | ddr_dq[17] | VSS | VDDE_DDR | ddr_dq[18] | | | | | | | | | | | | | | | | | | | PG11 | VSS | VDDE | PG0 | E | | | |
| F | ddr_dq[16] | MVTT3 | VSS | VDD33_DR | | | | | | | | | | | | | | | | | | | PA15 | PA14 | PA13 | PA12 | F | | | |
| G | ddr_dq[15] | ddr_dqs[2] | ddr_dm[2] | ddr_dq[14] | | | | | | | | | | | | | | | | | | | PA11 | PA9 | PA8 | PA7 | G | | | |
| H | ddr_dq[13] | VSS | VDDE_DDR | ddr_dq[12] | | | | | | | | | | | | | | | | | | | PA10 | VDDE | VSS | VA6 | H | | | |
| J | ddr_dq[11] | MVTT2 | VSS | MVREF | | | | | | | | | | | | | | | | | | | PA3 | VREF_RS_DS1 | PA5 | PA4 | J | | | |
| K | ddr_dq[9] | ddr_dqs[1] | ddr_dm[1] | ddr_dq[10] | VDD12 | | | | | | | | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | | | | | PA2 | VSS | PA1 | PA0 | K |
| L | ddr_dq[8] | VSS | VDDE_DDR | ddr_dq[7] | VSS | | | | | | | | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | | | | | PM13 | PM12 | VDDE | PJ0 | L | |
| M | ddr_dq[5] | MVTT1 | VSS | ddr_dq[6] | VDD12 | | | | | | | | VSS | VSS | VSS | VSS | VSS | VSS | VDD12 | VSS | | | | | PO7 | PO6 | PO5 | PO4 | M | |
| N | ddr_dq[3] | ddr_dqs[0] | VDDE_DDR | ddr_dq[4] | VSS | | | | | | | | VDD12 | VSS | VSS | VSS | VSS | VSS | VSS | VDD12 | | | | | PO3 | VDDE | PO2 | PO1 | N | |
| P | ddr_dq[1] | VSS | ddr_dm[0] | ddr_dq[2] | VDD12 | | | | | | | | VSS | VSS | VSS | VSS | VSS | VSS | VDD12 | VSS | | | | | PO0 | PN15 | VSS | PN14 | P | |
| R | ddr_dq[0] | MVTT0 | VSS | VDD33_DR | VSS | | | | | | | | VDD12 | VSS | VSS | VSS | VSS | VSS | VSS | VDD12 | | | | | PE7 | PE6 | PN13 | PN12 | R | |
| T | PG10 | PG9 | VDDE_DDR | PG8 | VDD12 | | | | | | | | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | | | | | PE5 | PE4 | PE3 | PE2 | T | | |
| U | PJ9 | PJ8 | PJ2 | PJ1 | VSS | | | | | | | | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | | | | | PE1 | VSSM | VDDM | PE0 | U | | |
| V | PB1 | VSS | PJ11 | PJ10 | | | | | | | | | | | | | | | | | | | | | PD15 | PD14 | PD13 | PD12 | V | |
| W | RESET | PB10 | VDDE | PB0 | | | | | | | | | | | | | | | | | | | | | PD11 | VDDM | VSSM | PD10 | W | |
| Y | VSS | PM4 | PM3 | PB11 | | | | | | | | | | | | | | | | | | | | | PD9 | PD8 | PD7 | PD6 | Y | |
| AA | XTAL | VREG_BY_PASS | VRC_CTRL | VDDREG | | | | | | | | | | | | | | | | | | | | | PD5 | VSSM | VDDM | PD4 | AA | |
| AB | EXTAL | PL4 | VSS | VDDPLL | | | | | | | | | | | | | | | | | | | | | PD3 | PD2 | PD1 | PD0 | AB | |
| AC | VSUP_TEST | PL5 | PNO | PK4 | PK6 | PH0 | PF2 | PB13 | PK11 | PN2 | PN4 | PN8 | PB9 | PB7 | PJ7 | PB5 | MCKO | MDO6 | MDO10 | MVO0 | PC0 | VDDA | VSSEH_DC | PC3 | PC1 | PC2 | AC | | | |
| AD | PL6 | VDDE | PN1 | VSS | PK7 | PH1 | VDDE | EVTI | MSEO | VSS | PN5 | PN9 | VDDE | PJ4 | PJ3 | VSS | MSEO2 | MDO7 | VDDE | MDO1 | PC6 | VSSA | VDDEH_DC | PC4 | PC7 | PC5 | AD | | | |
| AE | PL7 | VSS | PK2 | VDDE | PK8 | PH2 | VSS | EVTO | PM0 | VDDE | PN6 | PN10 | VSS | PJ5 | PH4 | VDDE | MDO4 | MDO8 | VSS | MDO2 | PL1 | PL0 | PC10 | PC11 | PC9 | PC8 | AE | | | |
| AF | PL8 | PL9 | PK3 | PK5 | PK9 | PH3 | PB12 | PK10 | PM1 | PN3 | PN7 | PN11 | PB8 | PJ6 | PB4 | PB6 | MDO5 | MDO9 | MDO11 | MDO3 | PL3 | PL2 | PC15 | PC14 | PC13 | PC12 | AF | | | |
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 | 17 | 18 | 19 | 20 | 21 | 22 | 23 | 24 | 25 | 26 | | | | |

Figure 4. 416 TEPBGA pinout

2.4 Signal description

The following sections provide signal descriptions and related information about the signals' functionality and configuration.

2.4.1 Pad configuration during reset phases

All pads have a fixed configuration under reset.

During the power-up phase, all pads are forced to tristate.

After power-up phase, all pads are floating with the following exceptions:

- PB[5] (FAB) is pull-down. Without external strong pull-up the device starts fetching from flash memory.
- RESET pad is driven low. This is released only after PHASE2 reset completion.
- Fast (4-16 MHz) external oscillator pads (EXTAL, XTAL) are tristate.
- The following pads are pull-up:
 - PB[6]
 - PH[0]
 - PH[1]
 - PH[3]

2.4.2 Voltage supply pins

Voltage supply pins are used to provide power to the device. Two dedicated pins are used for 1.2 V regulator stabilization.

Table 3. Voltage supply pin descriptions

| Supply pin | Function | Pin number | | |
|--------------|-------------------------------------|---------------------------|--------------------------------|---|
| | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| V_{DD12}^1 | 1.2 V core supply (1.08 V - 1.32 V) | 23, 50, 67, 110, 138, 175 | 23, 58, 79, 136, 162, 186, 207 | K10,K12,K14,K16,L11,L13,L15,L17,M10,M16,N11,N17,P10,P16,R11,R17,T10,T12,T14,T16,U11,U13,U15,U17 |

Table 3. Voltage supply pin descriptions (continued)

| Supply pin | Function | Pin number | | |
|------------------------------------|--|--|--|--|
| | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| V _{SS} | 1.2 V ground | 7, 18, 36, 49, 66, 68, 111, 123, 133, 139, 154, 167, 176 | 7, 18, 38, 47, 57, 64, 78, 80, 137, 147, 157, 163, 185, 199, 208 | AB3,AD10,AD16,A D4,AE13,AE19,AE2 ,AE7,B11,B14,B19, B2,B25,B5,B8,C12, C15,C17,C21,C3,C 6,C9,E2,E24,F3,H2 ,H25,J3,K11,K13,K 15,K17,K24,L10,L1 2,L14,L16,L2,M11, M12,M13,M14,M15, M17,M3,N10,N12,N 13,N14,N15,N16,P 11,P12,P13,P14,P1 5,P17,P2,P25,R10, R12,R13,R14,R15, R16,R3,T11,T13,T1 5,T17,U10,U12,U14 ,U16,V2,Y1 |
| | VDD12 ground and VDDPLL ground (VSSPLL) | 24 | 24 | — |
| V _{DDE_B} | 3.3 V I/O supply. This supply is shared with internal flash, 16 MHz IRC oscillator and 4–16MHz crystal oscillator. | 6, 19, 37, 48, 65, 89, 112, 122, 132, 140, 166 | 6, 19, 37, 48, 56, 63, 77, 105, 138, 146, 156, 164, 184, 198 | AD13,AD19,AD2,A D7,AE10,AE16,AE4 ,B17,B21,B24,C19, E25,H24,L25,N24, W3 |
| V _{DDA} ² | 3.3 V/5 V reference voltage and analog supply for A/D converter. This supply is shared with the SXOSC. | 79 | 95 | AC22 |
| V _{SSA} | Reference ground and analog ground for A/D converter | 80 | 96 | AD22 |
| V _{DDR} | Voltage regulator VREG supply | 20 | 20 | AA4 |
| V _{SSR} | Voltage regulator ground | 21 | 21 | — |
| V _{DDE_A} ² | 3.3 V/5 V I/O supply. This supply is shared with the SXOSC. | 77 | 93 | AD23 |
| V _{SSE_A} | 3.3 V/5 V I/O supply ground | 78 | 94 | AC23 |
| V _{DDM} | Stepper motor 3.3 V/5 V pad supply. SSD shares this supply. | 94, 104 | 110, 120, 130 | U25,W24,AA25 |
| V _{SSM} | Stepper motor ground | 95, 105 | 111, 121, 131 | U24,W24,AA24 |
| V _{DDPLL} | 1.2 V PLL supply | 25 | 25 | AB4 |
| V _{SUP_TEST} ³ | 9 V - 12 V flash test analog write signal | 22 | 22 | AC1 |
| V _{DD_DR} | 1.8V, 2.5V, and 3.3V DDR SDRAM supply | — | — | C2,C5,C8,C11,C14, E3,H3,L3,N3,T3 |
| V _{DD33_DR} | Functional supply for SDRAM pads (where available must be >= VDD_DR) | — | — | D6, D12, F4, R4 |

- ¹ Decoupling capacitors must be connected between these pins and the nearest V_{SS} pin.
- ² VDDA must be at the same voltage as VDDE_A.
- ³ This signal needs to be connected to ground during normal operation.

2.4.3 Pad types

The pads available for system pins and functional port pins are described in:

- The port pin summary in [Table 1](#);
- The pad type descriptions in [Table 3-6](#);
- [Section 43.5.3.8, “Pad Configuration Registers \(PCR0–PCR184\) and Section 43.5.3.9, “Pad Configuration Registers \(PCR185–PCR281\);](#)
- The device data sheet.

2.4.4 System pins

The system pins are listed in [Table 4](#).

Table 4. System pin descriptions

| System pin | Function | I/O direction | Pad type | RESET configuration ¹ | Pin number | | |
|---------------------------|--|---------------|----------|----------------------------------|------------|----------|------------|
| | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| $\overline{\text{RESET}}$ | Bidirectional reset with Schmitt-Trigger characteristics and noise filter. | I/O | M | Input, weak pull up | 30 | 30 | W1 |
| EXTAL | Analog input to the oscillator amplifier circuit. Input for the clock generator in bypass mode. | I | X | — | 27 | 27 | AB1 |
| XTAL | Analog output of the oscillator amplifier circuit. Needs to be grounded if oscillator bypass mode is used. | O | X | — | 28 | 28 | AA1 |
| EXTAL32 | Analog input of the 32KHz oscillator amplifier circuit. | O | S | — | 70 | 86 | AF24 |
| XTAL32 | Analog output of the 32 KHz oscillator amplifier circuit. Input for the clock generator in bypass mode. | I | S | — | 69 | 85 | AF23 |
| NMI | Non-Maskable Interrupt | I/O | S | Input, none | 45 | 53 | AC7 |
| VRC_CTRL | Voltage Regulator external NPN Ballast base control pin | | Analog | — | 29 | 29 | AA3 |
| VREF_RSDS ² | RSDS interface reference voltage | | Analog | — | — | 145, 165 | J24,D24 |
| VREG_BYPASS ³ | Pin used for factory testing | I | — | — | 26 | 26 | AA2 |

Pinout and signal descriptions

- ¹ Reset configuration is given as I/O direction and pull direction (for example, “Input, pullup”).
- ² Although this signal is not a supply for RSDS pads, it needs to be terminated in an external capacitor with a value of 47 pF.
- ³ VREG_BYPASS should be pulled down externally.

2.4.5 Nexus pins

On the 176 LQFP and the 208 LQFP package options a reduced set of Nexus pins are optionally available, multiplexed with GPIO pins.

On the 416 TEPBGA package option all Nexus pins are dedicated to Nexus only.

Table 5. Nexus pins

| System pin | Function | Pad type | PCR | Pin number ¹ | | |
|------------|-------------------------|----------|----------|-------------------------|----------|------------|
| | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| EVTI | Nexus Event In | M | PCR[80] | 169 | 201 | A17 |
| EVTO | Nexus Event Out | M | PCR[70] | 157 | 189 | C20 |
| MCKO | Nexus Msg Clock Out | F | PCR[85] | 174 | 206 | B18 |
| MSEO[0] | Nexus Msg Start/End Out | M | PCR[71] | 158 | 190 | B20 |
| MSEO[2] | Nexus Msg Start/End Out | M | PCR[73] | 159 | 191 | A20 |
| MDO[0] | Nexus Msg Data Out | M | PCR[81] | 170 | 202 | D16 |
| MDO[1] | Nexus Msg Data Out | M | PCR[82] | 171 | 203 | C16 |
| MDO[2] | Nexus Msg Data Out | M | PCR[83] | 172 | 204 | B16 |
| MDO[3] | Nexus Msg Data Out | M | PCR[84] | 173 | 205 | A16 |
| EVTI | Nexus Event In | M | PCR[197] | n/a | n/a | AD8 |
| EVTO | Nexus Event Out | M | PCR[198] | n/a | n/a | AE8 |
| MCKO | Nexus Msg Clock Out | F | PCR[200] | n/a | n/a | AC17 |
| MSEO[0] | Nexus Msg Start/End Out | M | PCR[199] | n/a | n/a | AD9 |
| MSEO[2] | Nexus Msg Start/End Out | M | PCR[201] | n/a | n/a | AD17 |
| MDO[0] | Nexus Msg Data Out | M | PCR[185] | n/a | n/a | AC20 |
| MDO[1] | Nexus Msg Data Out | M | PCR[186] | n/a | n/a | AD20 |
| MDO[2] | Nexus Msg Data Out | M | PCR[187] | n/a | n/a | AE20 |
| MDO[3] | Nexus Msg Data Out | M | PCR[188] | n/a | n/a | AF20 |
| MDO[4] | Nexus Msg Data Out | M | PCR[189] | n/a | n/a | AE17 |
| MDO[5] | Nexus Msg Data Out | M | PCR[190] | n/a | n/a | AF17 |
| MDO[6] | Nexus Msg Data Out | M | PCR[191] | n/a | n/a | AC18 |
| MDO[7] | Nexus Msg Data Out | M | PCR[192] | n/a | n/a | AD18 |

Table 5. Nexus pins (continued)

| System pin | Function | Pad type | PCR | Pin number ¹ | | |
|------------|--------------------|----------|----------|-------------------------|----------|------------|
| | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| MDO[8] | Nexus Msg Data Out | M | PCR[193] | n/a | n/a | AE18 |
| MDO[9] | Nexus Msg Data Out | M | PCR[194] | n/a | n/a | AF18 |
| MDO[10] | Nexus Msg Data Out | M | PCR[195] | n/a | n/a | AC19 |
| MDO[11] | Nexus Msg Data Out | M | PCR[196] | n/a | n/a | AF19 |

¹ On the 176 LQFP and 208 LQFP package options the Nexus pins are multiplexed with other GPIO. On the 416 TEPBGA package, there are additional dedicated Nexus pins.

2.4.6 DRAM interface

The DRAM interface pins are listed in [Table 6](#).

Table 6. DRAM interface pin summary

| Port pin ¹ | Function | I/O direction | Pad type | PCR | RESET config ² | Pin number |
|-----------------------|--------------------|---------------|----------|----------|---------------------------|------------|
| | | | | | | 416 TEPBGA |
| DRAM Data Bus | | | | | | |
| DDR_DQ[31] | DRAM Data Bus [31] | I/O | DDR | PCR[237] | None, None | A6 |
| DDR_DQ[30] | DRAM Data Bus [30] | I/O | DDR | PCR[238] | None, None | A5 |
| DDR_DQ[29] | DRAM Data Bus [29] | I/O | DDR | PCR[239] | None, None | A4 |
| DDR_DQ[28] | DRAM Data Bus [28] | I/O | DDR | PCR[240] | None, None | A3 |
| DDR_DQ[27] | DRAM Data Bus [27] | I/O | DDR | PCR[241] | None, None | A2 |
| DDR_DQ[26] | DRAM Data Bus [26] | I/O | DDR | PCR[242] | None, None | A1 |
| DDR_DQ[25] | DRAM Data Bus [25] | I/O | DDR | PCR[243] | None, None | B1 |
| DDR_DQ[24] | DRAM Data Bus [24] | I/O | DDR | PCR[244] | None, None | C4 |
| DDR_DQ[23] | DRAM Data Bus [23] | I/O | DDR | PCR[245] | None, None | C1 |
| DDR_DQ[22] | DRAM Data Bus [22] | I/O | DDR | PCR[246] | None, None | D4 |
| DDR_DQ[21] | DRAM Data Bus [21] | I/O | DDR | PCR[247] | None, None | D3 |
| DDR_DQ[20] | DRAM Data Bus [20] | I/O | DDR | PCR[248] | None, None | D2 |
| DDR_DQ[19] | DRAM Data Bus [19] | I/O | DDR | PCR[249] | None, None | D1 |
| DDR_DQ[18] | DRAM Data Bus [18] | I/O | DDR | PCR[250] | None, None | E4 |
| DDR_DQ[17] | DRAM Data Bus [17] | I/O | DDR | PCR[251] | None, None | E1 |
| DDR_DQ[16] | DRAM Data Bus [16] | I/O | DDR | PCR[252] | None, None | F1 |
| DDR_DQ[15] | DRAM Data Bus [15] | I/O | DDR | PCR[253] | None, None | G1 |
| DDR_DQ[14] | DRAM Data Bus [14] | I/O | DDR | PCR[254] | None, None | G4 |
| DDR_DQ[13] | DRAM Data Bus [13] | I/O | DDR | PCR[255] | None, None | H1 |
| DDR_DQ[12] | DRAM Data Bus [12] | I/O | DDR | PCR[256] | None, None | H4 |

Table 6. DRAM interface pin summary (continued)

| Port pin ¹ | Function | I/O direction | Pad type | PCR | RESET config ² | Pin number |
|--------------------------|----------------------|---------------|----------|----------|---------------------------|------------|
| | | | | | | 416 TEPBGA |
| DDR_DQ[11] | DRAM Data Bus [11] | I/O | DDR | PCR[257] | None, None | J1 |
| DDR_DQ[10] | DRAM Data Bus [10] | I/O | DDR | PCR[258] | None, None | K4 |
| DDR_DQ[9] | DRAM Data Bus [9] | I/O | DDR | PCR[259] | None, None | K1 |
| DDR_DQ[8] | DRAM Data Bus [8] | I/O | DDR | PCR[260] | None, None | L1 |
| DDR_DQ[7] | DRAM Data Bus [7] | I/O | DDR | PCR[261] | None, None | L4 |
| DDR_DQ[6] | DRAM Data Bus [6] | I/O | DDR | PCR[262] | None, None | M4 |
| DDR_DQ[5] | DRAM Data Bus [5] | I/O | DDR | PCR[263] | None, None | M1 |
| DDR_DQ[4] | DRAM Data Bus [4] | I/O | DDR | PCR[264] | None, None | N4 |
| DDR_DQ[3] | DRAM Data Bus [3] | I/O | DDR | PCR[265] | None, None | N1 |
| DDR_DQ[2] | DRAM Data Bus [2] | I/O | DDR | PCR[266] | None, None | P4 |
| DDR_DQ[1] | DRAM Data Bus [1] | I/O | DDR | PCR[267] | None, None | P1 |
| DDR_DQ[0] | DRAM Data Bus [0] | I/O | DDR | PCR[268] | None, None | R1 |
| DRAM Data Strobes | | | | | | |
| DDR_DQS[3] | DRAM Data Strobe [3] | I/O | DDR | PCR[232] | None, None | B3 |
| DDR_DQS[2] | DRAM Data Strobe [2] | I/O | DDR | PCR[231] | None, None | G2 |
| DDR_DQS[1] | DRAM Data Strobe [1] | I/O | DDR | PCR[230] | None, None | K2 |
| DDR_DQS[0] | DRAM Data Strobe [0] | I/O | DDR | PCR[229] | None, None | N2 |
| DRAM Data Enables | | | | | | |
| DDR_DM[3] | DRAM Data Enable [3] | Output | DDR | PCR[236] | Output, None | B4 |
| DDR_DM[2] | DRAM Data Enable [2] | Output | DDR | PCR[235] | Output, None | G3 |
| DDR_DM[1] | DRAM Data Enable [1] | Output | DDR | PCR[234] | Output, None | K3 |
| DDR_DM[0] | DRAM Data Enable [0] | Output | DDR | PCR[233] | Output, None | P3 |
| DRAM Address | | | | | | |
| DDR_A[15] | DRAM address [15] | Output | DDR | PCR[217] | Output, None | B15 |
| DDR_A[14] | DRAM address [14] | Output | DDR | PCR[216] | Output, None | D15 |
| DDR_A[13] | DRAM address [13] | Output | DDR | PCR[215] | Output, None | D14 |
| DDR_A[12] | DRAM address [12] | Output | DDR | PCR[214] | Output, None | A14 |
| DDR_A[11] | DRAM address [11] | Output | DDR | PCR[213] | Output, None | D13 |

Table 6. DRAM interface pin summary (continued)

| Port pin ¹ | Function | I/O direction | Pad type | PCR | RESET config ² | Pin number |
|--------------------------|-------------------------|---------------|----------|----------|---------------------------|------------|
| | | | | | | 416 TEPBGA |
| DDR_A[10] | DRAM address [10] | Output | DDR | PCR[212] | Output, None | C13 |
| DDR_A[9] | DRAM address [9] | Output | DDR | PCR[211] | Output, None | B13 |
| DDR_A[8] | DRAM address [8] | Output | DDR | PCR[210] | Output, None | A13 |
| DDR_A[7] | DRAM address [7] | Output | DDR | PCR[209] | Output, None | B12 |
| DDR_A[6] | DRAM address [6] | Output | DDR | PCR[208] | Output, None | A12 |
| DDR_A[5] | DRAM address [5] | Output | DDR | PCR[207] | Output, None | D11 |
| DDR_A[4] | DRAM address [4] | Output | DDR | PCR[206] | Output, None | A11 |
| DDR_A[3] | DRAM address [3] | Output | DDR | PCR[205] | Output, None | D10 |
| DDR_A[2] | DRAM address [2] | Output | DDR | PCR[204] | Output, None | C10 |
| DDR_A[1] | DRAM address [1] | Output | DDR | PCR[203] | Output, None | B10 |
| DDR_A[0] | DRAM address [0] | Output | DDR | PCR[202] | Output, None | A10 |
| DRAM Bank Address | | | | | | |
| DDR_BA[2] | DRAM Bank Address[2] | Output | DDR | PCR[220] | Output, None | A9 |
| DDR_BA[1] | DRAM Bank Address[1] | Output | DDR | PCR[219] | Output, None | A8 |
| DDR_BA[0] | DRAM Bank Address[0] | Output | DDR | PCR[218] | Output, None | A7 |
| DRAM Control | | | | | | |
| DDR_CAS | Column Address Strobe | Output | DDR | PCR[221] | Output, None | B6 |
| DDR_RAS | Row Address Strobe | Output | DDR | PCR[227] | Output, None | B7 |
| DDR_WEB | Write Enable | Output | DDR | PCR[228] | Output, None | B9 |
| DDR_ODT | DRAM On-die termination | Output | DDR | PCR[226] | Output, Pull Down | D5 |
| DDR_CLK | DRAM Clock | Output | DDR | PCR[225] | Output, None | C7 |

Table 6. DRAM interface pin summary (continued)

| Port pin ¹ | Function | I/O direction | Pad type | PCR | RESET config ² | Pin number |
|-----------------------|--------------------------|---------------|----------|----------|---------------------------|-------------|
| | | | | | | 416 TEPBGA |
| DDR_CLKB | DRAM Clock bar | Output | DDR | NA | Output, None | D7 |
| DDR_CK | DRAM Clock Enable | Output | DDR | PCR[222] | Output, Pull Down | D8 |
| DDR_CS | DRAM Chip Select | Output | DDR | PCR[223] | Output, None | D9 |
| MVREF | DDR Reference Voltage | Input | — | NA | — | J4 |
| MVTT | DRAM Termination Voltage | Input | — | NA | — | F2,J2,M2,R2 |

¹ These port pins are disabled and unpowered on packages where the DRAM interface is not bonded out.

² Reset configuration is given as I/O direction and pull direction (for example, “Input, pullup”).

2.4.7 VIU muxing

The DCU3, DCULite and VIU2 modules share the same pins for input video. It is, however, possible to feed independent video streams to VIU2 and DCU3 (operating in narrow mode). [Figure 5](#) explains the pin sharing arrangement.

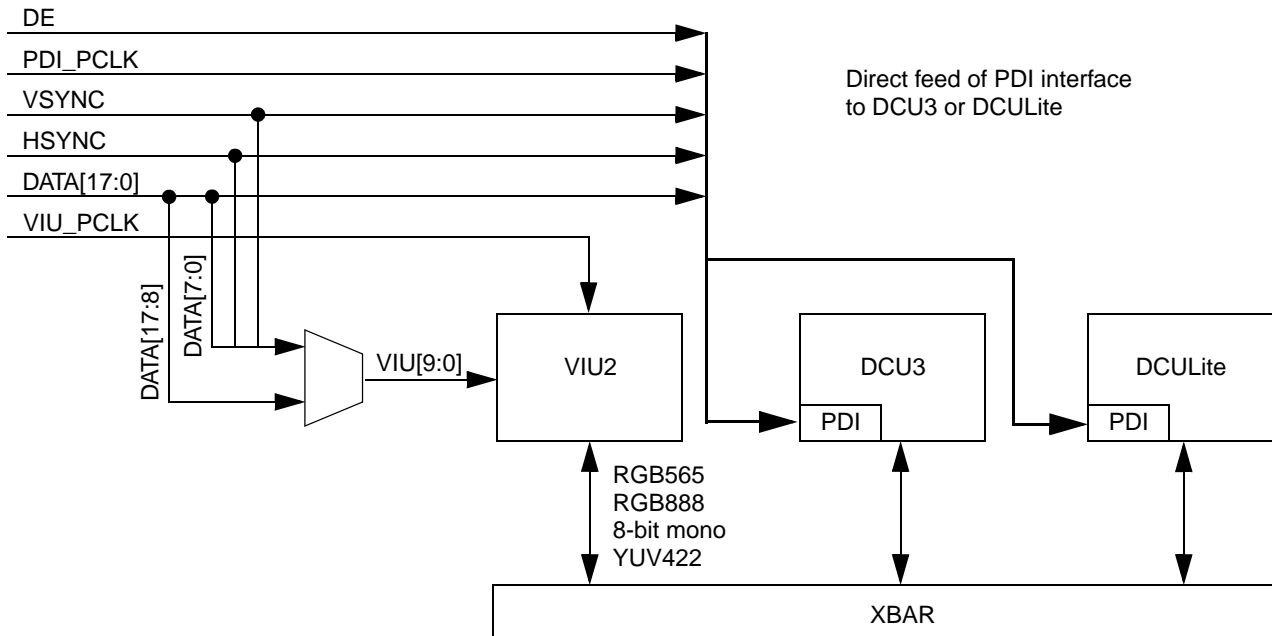


Figure 5. VIU2, DCU3, and DCULite pin sharing

VIU input data selection is done based on select bit (bit 0) of Miscellaneous control register (0xC3FE0340).

- VIU pix data: VIU[9:0]
- Select bit 1'b0: PDI[7:0], HSYNC, VSYNC
- Select bit 1'b1: PDI[17:8]

2.4.8 SGM muxing

The SGM shares pins between the PWM output signals and the I2S bus signals as shown in the “Port pin summary” table. When the PWM function is enabled in the SGM (SGMCTL[PWME]) the PWM (PWMO, PWMOA) signals are available. When the PWM function is disabled the I2S bus signals (I2S_DO, I2S_SCK) are available.

2.4.9 RSDS special function muxing

Ports PA[0:15], PG[0:7], PG[11] and PM[2] have the RSDS signalling option as a special function. The SIUL allocates pad control registers to these functions (PCR[270:282]), but because these pads share a common pin with the normal GPIO pins they do not operate in the same way as the normal GPIO ports. PG[11] in particular has a special configuration separate from the other pads.

The special-function pads are output-only, and the associated PCR[OBE] bit is controlled by the TCON_CTRL1 register (TCON_BYPASS and RSDS_MODE bits). However, the alternate function selection is taken from the associated normal GPIO pad. This allows selection of the DCU3 function as the alternate function of the pad and then the TCON module to select if the output style is TCON/RSDS or digital RGB format.

Therefore, when the TCON bypass is active (bypass disabled with or without RSDS active), it is important not to configure the normal GPIO ports for output operation with a non-DCU3 alternate function on ports PA[0:15] and PG[0:7].

For PG[11], the PCR[282] OBE bit is fully controlled by the TCON module and will become an output whenever the DCU3 alternate option is selected. Therefore, only select the DCU3 function on this pin when ready to configure it as a clock for a TFT panel.

2.4.10 Functional ports

The functional port pins are listed in [Table 7](#). The following pad types are available for system pins and functional port pins:

- S — Slow (pad_ssr, pad_ssr_hv)
- M — Medium (pad_msr, pad_msr_hv)
- F — Fast (pad_fc)
- J — Input/output with analog features (pad_tgate, pad_tgate_hv)
- Analog — Input only with analog features (pad_ae, pad_ae_hv)
- SMD — Stepper Motor Detector
- DDR — DDR pads
- RSDS — RSDS pads

Table 7. Port pin summary

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|--------|--|--|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PORT A | | | | | | | | | | | |
| PA[0] | PCR[0] | Option 0 Option 1 Option 2 Option 3 | GPIO[0] DCU_R0 SDA_1 eMIOS0[18] | RSDS0P | SIUL DCU3 I ² C_1 PWM/Timer | I/O | M / RSDS | None, none | 116 | 139 | K26 |
| PA[1] | PCR[1] | Option 0 Option 1 Option 2 Option 3 | GPIO[1] DCU_R1 SCL_1 eMIOS0[17] | RSDS0M | SIUL DCU3 I ² C_1 PWM/Timer | I/O | M / RSDS | None, none | 117 | 140 | K25 |
| PA[2] | PCR[2] | Option 0 Option 1 Option 2 Option 3 | GPIO[2] DCU_R2 — — | RSDS1P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 118 | 141 | K23 |
| PA[3] | PCR[3] | Option 0 Option 1 Option 2 Option 3 | GPIO[3] DCU_R3 — — | RSDS1M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 119 | 142 | J23 |
| PA[4] | PCR[4] | Option 0 Option 1 Option 2 Option 3 | GPIO[4] DCU_R4 — — | RSDS2P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 120 | 143 | J26 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|---------|--|--|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PA[5] | PCR[5] | Option 0 Option 1 Option 2 Option 3 | GPIO[5] DCU_R5 — — | RSDS2M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 121 | 144 | J25 |
| PA[6] | PCR[6] | Option 0 Option 1 Option 2 Option 3 | GPIO[6] DCU_R6 — — | RSDS3P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 124 | 148 | H26 |
| PA[7] | PCR[7] | Option 0 Option 1 Option 2 Option 3 | GPIO[7] DCU_R7 — — | RSDS3M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 125 | 149 | G26 |
| PA[8] | PCR[8] | Option 0 Option 1 Option 2 Option 3 | GPIO[8] DCU_G0 SCL_2 eMIOS0[20] | RSDS4P | SIUL DCU3 I ² C_2 PWM/Timer | I/O | M / RSDS | None, none | 126 | 150 | G25 |
| PA[9] | PCR[9] | Option 0 Option 1 Option 2 Option 3 | GPIO[9] DCU_G1 SDA_2 eMIOS0[19] | RSDS4M | SIUL DCU3 I ² C_2 PWM/Timer | I/O | M / RSDS | None, none | 127 | 151 | G24 |
| PA[10] | PCR[10] | Option 0 Option 1 Option 2 Option 3 | GPIO[10] DCU_G2 — — | RSDS5P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 128 | 152 | H23 |
| PA[11] | PCR[11] | Option 0 Option 1 Option 2 Option 3 | GPIO[11] DCU_G3 — — | RSDS5M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 129 | 153 | G23 |
| PA[12] | PCR[12] | Option 0 Option 1 Option 2 Option 3 | GPIO[12] DCU_G4 — — | RSDS6P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 130 | 154 | F26 |
| PA[13] | PCR[13] | Option 0 Option 1 Option 2 Option 3 | GPIO[13] DCU_G5 — — | RSDS6M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 131 | 155 | F25 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|-----------------------------------|-------------------------------|-------------------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PA[14] | PCR[14] | Option 0 Option 1 Option 2 Option 3 | GPIO[14] DCU_G6 — — | RSDS7P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 134 | 158 | F24 |
| PA[15] | PCR[15] | Option 0 Option 1 Option 2 Option 3 | GPIO[15] DCU_G7 — — | RSDS7M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 135 | 159 | F23 |
| PORT B | | | | | | | | | | | |
| PB[0] | PCR[16] | Option 0 Option 1 Option 2 Option 3 | GPIO[16] CANTX_0 TXD_0 — | — | SIUL FlexCAN_0 LINFlex_0 — | I/O | S | None, none | 13 | 13 | W4 |
| PB[1] | PCR[17] | Option 0 Option 1 Option 2 Option 3 | GPIO[17] CANRX_0 RXD_0 — | — | SIUL FlexCAN_0 LINFlex_0 — | I/O | S | None, none | 12 | 12 | V1 |
| PB[2] | PCR[18] | Option 0 Option 1 Option 2 Option 3 | GPIO[18] TXD_0 — — | — | SIUL LINFlex_0 — — | I/O | S | None, none | 153 | 183 | D21 |
| PB[3] | PCR[19] | Option 0 Option 1 Option 2 Option 3 | GPIO[19] RXD_0 — — | — | SIUL LINFlex_0 — — | I/O | S | None, none | 152 | 182 | A22 |
| PB[4] | PCR[20] | Option 0 Option 1 Option 2 Option 3 | GPIO[20] SCK_1 MA0 — | — | SIUL DSPI_1 ADC — | I/O | S | None, none | 62 | 74 | AF15 |
| PB[5] | PCR[21] | Option 0 Option 1 Option 2 Option 3 | GPIO[21] SOUT_1 MA1 FABM | — | SIUL DSPI_1 ADC Control | I/O | S | Input, pull- down | 63 | 75 | AC16 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|---------|--|--|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PB[6] | PCR[22] | Option 0 Option 1 Option 2 Option 3 | GPIO[22] SIN_1 MA2 ABS[0] | — | SIUL DSPI_1 ADC Control | I/O | S | Input, pull- up | 64 | 76 | AF16 |
| PB[7] | PCR[23] | Option 0 Option 1 Option 2 Option 3 | GPIO[23] SIN_0 eMIOS1[20] I2S_SCK/PWMOA | — | SIUL DSPI_0 PWM/Timer SGM | I/O | S | None, none | 55 | 67 | AC14 |
| PB[8] | PCR[24] | Option 0 Option 1 Option 2 Option 3 | GPIO[24] SOUT_0 eMIOS1[19] I2S_DO/PWMO | — | SIUL DSPI_0 PWM/Timer SGM | I/O | S | None, none | 54 | 66 | AF13 |
| PB[9] | PCR[25] | Option 0 Option 1 Option 2 Option 3 | GPIO[25] SCK_0 eMIOS1[18] I2S_FS | — | SIUL DSPI_0 PWM/Timer SGM | I/O | M | None, none | 53 | 65 | AC13 |
| PB[10] | PCR[26] | Option 0 Option 1 Option 2 Option 3 | GPIO[26] CANRX_1 I2S_DO/PWMO — | — | SIUL FlexCAN_1 SGM — | I/O | S | None, none | 14 | 14 | W2 |
| PB[11] | PCR[27] | Option 0 Option 1 Option 2 Option 3 | GPIO[27] CANTX_1 SGM_MCLK — | — | SIUL FlexCAN_1 SGM — | I/O | S | None, none | 15 | 15 | Y4 |
| PB[12] | PCR[28] | Option 0 Option 1 Option 2 Option 3 | GPIO[28] RXD_1 eMIOS1[10] CS2_0 | — | SIUL LINFlex_1 PWM/Timer DSPI_0 | I/O | S | None, none | 46 | 54 | AF7 |
| PB[13] | PCR[29] | Option 0 Option 1 Option 2 Option 3 | GPIO[29] TXD_1 eMIOS1[11] CS1_0 | — | SIUL LINFlex_1 PWM/Timer DSPI_0 | I/O | S | None, none | 47 | 55 | AC8 |
| PB[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PB[15] | — | — | Reserved | — | — | — | — | — | — | — | — |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|-------------------------|-------------------------------|-------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PORT C | | | | | | | | | | | |
| PC[0] | PCR[30] | Option 0 Option 1 Option 2 Option 3 | GPIO[30] — — — | ANS[0] | SIUL — — — | I/O | J | None, none | 88 | 104 | AC21 |
| PC[1] | PCR[31] | Option 0 Option 1 Option 2 Option 3 | GPIO[31] — — — | ANS[1] | SIUL — — — | I/O | J | None, none | 87 | 103 | AC25 |
| PC[2] | PCR[32] | Option 0 Option 1 Option 2 Option 3 | GPIO[32] — — — | ANS[2] | SIUL — — — | I/O | J | None, none | 86 | 102 | AC26 |
| PC[3] | PCR[33] | Option 0 Option 1 Option 2 Option 3 | GPIO[33] — — — | ANS[3] | SIUL — — — | I/O | J | None, none | 85 | 101 | AC24 |
| PC[4] | PCR[34] | Option 0 Option 1 Option 2 Option 3 | GPIO[34] — — — | ANS[4] | SIUL — — — | I/O | J | None, none | 84 | 100 | AD24 |
| PC[5] | PCR[35] | Option 0 Option 1 Option 2 Option 3 | GPIO[35] — — — | ANS[5] | SIUL — — — | I/O | J | None, none | 83 | 99 | AD26 |
| PC[6] | PCR[36] | Option 0 Option 1 Option 2 Option 3 | GPIO[36] — — — | ANS[6] | SIUL — — — | I/O | J | None, none | 82 | 98 | AD21 |
| PC[7] | PCR[37] | Option 0 Option 1 Option 2 Option 3 | GPIO[37] — — — | ANS[7] | SIUL — — — | I/O | J | None, none | 81 | 97 | AD25 |
| PC[8] | PCR[38] | Option 0 Option 1 Option 2 Option 3 | GPIO[38] — — — | ANS[8] | SIUL — — — | I/O | J | None, none | 76 | 92 | AE26 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|---|-------------------------------|---------------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PC[9] | PCR[39] | Option 0 Option 1 Option 2 Option 3 | GPIO[39] — — — | ANS[9] | SIUL — — — | I/O | J | None, none | 75 | 91 | AE25 |
| PC[10] | PCR[40] | Option 0 Option 1 Option 2 Option 3 | GPIO[40] — I2S_DO/PWMO — | ANS[10] | SIUL — SGM — | I/O | J | None, none | 74 | 90 | AE23 |
| PC[11] | PCR[41] | Option 0 Option 1 Option 2 Option 3 | GPIO[41] — MA0 CS2_1 | ANS[11] | SIUL — ADC DSPI_1 | I/O | J | None, None | 73 | 89 | AE24 |
| PC[12] | PCR[42] | Option 0 Option 1 Option 2 Option 3 | GPIO[42] — MA1 CS1_1 | ANS[12] | SIUL — ADC DSPI_1 | I/O | J | None, None | 72 | 88 | AF26 |
| PC[13] | PCR[43] | Option 0 Option 1 Option 2 Option 3 | GPIO[43] — MA2 CS0_1 | ANS[13] | SIUL — ADC DSPI_1 | I/O | J | None, None | 71 | 87 | AF25 |
| PC[14] | PCR[44] | Option 0 Option 1 Option 2 Option 3 | GPIO[44] — — — | ANS[14] EXTAL32 | SIUL — — — | I/O | J | None, None | 70 | 86 | AF24 |
| PC[15] | PCR[45] | Option 0 Option 1 Option 2 Option 3 | GPIO[45] — — — | ANS[15] XTAL32 | SIUL — — — | I/O | J | None, None | 69 | 85 | AF23 |
| PORT D | | | | | | | | | | | |
| PD[0] | PCR[46] | Option 0 Option 1 Option 2 Option 3 | GPIO[46] M0C0M SSD0_0 eMIOS1[8] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 90 | 106 | AB26 |
| PD[1] | PCR[47] | Option 0 Option 1 Option 2 Option 3 | GPIO[47] M0C0P SSD0_1 eMIOS1[16] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 91 | 107 | AB25 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|---------|--|---|-------------------------------|---------------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PD[2] | PCR[48] | Option 0 Option 1 Option 2 Option 3 | GPIO[48] M0C1M SSD0_2 eMIOS1[23] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 92 | 108 | AB24 |
| PD[3] | PCR[49] | Option 0 Option 1 Option 2 Option 3 | GPIO[49] M0C1P SSD0_3 eMIOS0[9] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 93 | 109 | AB23 |
| PD[4] | PCR[50] | Option 0 Option 1 Option 2 Option 3 | GPIO[50] M1C0M SSD1_0 eMIOS0[8] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 96 | 112 | AA26 |
| PD[5] | PCR[51] | Option 0 Option 1 Option 2 Option 3 | GPIO[51] M1C0P SSD1_1 eMIOS0[16] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 97 | 113 | AA23 |
| PD[6] | PCR[52] | Option 0 Option 1 Option 2 Option 3 | GPIO[52] M1C1M SSD1_2 eMIOS0[23] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 98 | 114 | Y26 |
| PD[7] | PCR[53] | Option 0 Option 1 Option 2 Option 3 | GPIO[53] M1C1P SSD1_3 — | — | SIUL SMD SSD — | I/O | SMD | None, None | 99 | 115 | Y25 |
| PD[8] | PCR[54] | Option 0 Option 1 Option 2 Option 3 | GPIO[54] M2C0M SSD2_0 — | — | SIUL SMD SSD — | I/O | SMD | None, None | 100 | 116 | Y24 |
| PD[9] | PCR[55] | Option 0 Option 1 Option 2 Option 3 | GPIO[55] M2C0P SSD2_1 eMIOS0[9] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 101 | 117 | Y23 |
| PD[10] | PCR[56] | Option 0 Option 1 Option 2 Option 3 | GPIO[56] M2C1M SSD2_2 eMIOS0[10] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 102 | 118 | W26 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|---|-------------------------------|---------------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PD[11] | PCR[57] | Option 0 Option 1 Option 2 Option 3 | GPIO[57] M2C1P SSD2_3 eMIOS0[11] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 103 | 119 | W23 |
| PD[12] | PCR[58] | Option 0 Option 1 Option 2 Option 3 | GPIO[58] M3C0M SSD3_0 eMIOS0[12] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 106 | 122 | V26 |
| PD[13] | PCR[59] | Option 0 Option 1 Option 2 Option 3 | GPIO[59] M3C0P SSD3_1 eMIOS0[13] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 107 | 123 | V25 |
| PD[14] | PCR[60] | Option 0 Option 1 Option 2 Option 3 | GPIO[60] M3C1M SSD3_2 eMIOS0[14] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 108 | 124 | V24 |
| PD[15] | PCR[61] | Option 0 Option 1 Option 2 Option 3 | GPIO[61] M3C1P SSD3_3 eMIOS0[15] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 109 | 125 | V23 |
| PORT E | | | | | | | | | | | |
| PE[0] | PCR[62] | Option 0 Option 1 Option 2 Option 3 | GPIO[62] M4C0M SSD4_0 — | — | SIUL SMD SSD — | I/O | SMD | None, None | — | 126 | U26 |
| PE[1] | PCR[63] | Option 0 Option 1 Option 2 Option 3 | GPIO[63] M4C0P SSD4_1 — | — | SIUL SMD SSD — | I/O | SMD | None, None | — | 127 | U23 |
| PE[2] | PCR[64] | Option 0 Option 1 Option 2 Option 3 | GPIO[64] M4C1M SSD4_2 — | — | SIUL SMD SSD — | I/O | SMD | None, None | — | 128 | T26 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|--|-------------------------------|---------------------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PE[3] | PCR[65] | Option 0 Option 1 Option 2 Option 3 | GPIO[65] M4C1P SSD4_3 — | — | SIUL SMD SSD — | I/O | SMD | None, None | — | 129 | T25 |
| PE[4] | PCR[66] | Option 0 Option 1 Option 2 Option 3 | GPIO[66] M5C0M SSD5_0 — | — | SIUL SMD SSD — | I/O | SMD | None, None | — | 132 | T24 |
| PE[5] | PCR[67] | Option 0 Option 1 Option 2 Option 3 | GPIO[67] M5C0P SSD5_1 — | — | SIUL SMD SSD — | I/O | SMD | None, None | — | 133 | T23 |
| PE[6] | PCR[68] | Option 0 Option 1 Option 2 Option 3 | GPIO[68] M5C1M SSD5_2 — | — | SIUL SMD SSD — | I/O | SMD | None, None | — | 134 | R24 |
| PE[7] | PCR[69] | Option 0 Option 1 Option 2 Option 3 | GPIO[69] M5C1P SSD5_3 — | — | SIUL SMD SSD — | I/O | SMD | None, None | — | 135 | R23 |
| PORT F | | | | | | | | | | | |
| PF[0] | PCR[70] | Option 0 Option 1 Option 2 Option 3 | GPIO[70] eMIOS1[19] EVTO DCULITE_B2 | — | SIUL PWM/Timer NEXUS DCULite | I/O | M | None, None | 157 | 189 | C20 |
| PF[1] | PCR[71] | Option 0 Option 1 Option 2 Option 3 | GPIO[71] eMIOS1[20] MSEO DCULITE_B3 | — | SIUL PWM/Timer NEXUS DCULite | I/O | M | None, None | 158 | 190 | B20 |
| PF[2] | PCR[72] | Option 0 Option 1 Option 2 Option 3 | GPIO[72] NMI — — | — | SIUL NMI — — | I/O | S | None, None | 45 | 53 | AC7 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|---------|--|---|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PF[3] | PCR[73] | Option 0 Option 1 Option 2 Option 3 | GPIO[73] eMIOS1[21] MSEO DCULITE_B4 | — | SIUL PWM/Timer NEXUS DCULite | I/O | M | None, None | 159 | 191 | A20 |
| PF[4] | PCR[74] | Option 0 Option 1 Option 2 Option 3 | GPIO[74] eMIOS1[14] SDA_1 DCULITE_B5 | — | SIUL PWM/Timer I ² C_1 DCULite | I/O | M | None, None | 160 | 192 | D19 |
| PF[5] | PCR[75] | Option 0 Option 1 Option 2 Option 3 | GPIO[75] QUADSPI_IO1_B eMIOS1[15] VIU8_PDI16 | — | SIUL QuadSPI PWM/Timer VIU2/PDI | I/O | M | None, None | 161 | 193 | A19 |
| PF[6] | PCR[76] | Option 0 Option 1 Option 2 Option 3 | GPIO[76] QUADSPI_IO0_B eMIOS1[16] VIU9_PDI17 | — | SIUL QuadSPI PWM/Timer VIU2/PDI | I/O | M | None, None | 162 | 194 | D18 |
| PF[7] | PCR[77] | Option 0 Option 1 Option 2 Option 3 | GPIO[77] eMIOS1[15] SCL_1 DCULITE_B6 | — | SIUL PWM/Timer I ² C_1 DCULite | I/O | M | None, None | 163 | 195 | C18 |
| PF[8] | PCR[78] | Option 0 Option 1 Option 2 Option 3 | GPIO[78] SDA_0 CS2_1 RXD_1 | — | SIUL I ² C_0 DSPI_1 LINFlex_1 | I/O | S | None, None | 164 | 196 | A18 |
| PF[9] | PCR[79] | Option 0 Option 1 Option 2 Option 3 | GPIO[79] SCL_0 CS1_1 TXD_1 | — | SIUL I ² C_0 DSPI_1 LINFlex_1 | I/O | S | None, None | 165 | 197 | D17 |
| PF[10] | PCR[80] | Option 0 Option 1 Option 2 Option 3 | GPIO[80] QUADSPI_PCS_A — EVTI | — | SIUL QuadSPI — NEXUS | I/O | M | None, None | 169 | 201 | A17 |
| PF[11] | PCR[81] | Option 0 Option 1 Option 2 Option 3 | GPIO[81] QUADSPI_IO2_A — MDO0 | — | SIUL QuadSPI — NEXUS | I/O | M | None, None | 170 | 202 | D16 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|---|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PF[12] | PCR[82] | Option 0 Option 1 Option 2 Option 3 | GPIO[82] QUADSPI_IO3_A — MDO1 | — | SIUL QuadSPI — NEXUS | I/O | M | None, None | 171 | 203 | C16 |
| PF[13] | PCR[83] | Option 0 Option 1 Option 2 Option 3 | GPIO[83] QUADSPI_IO0_A — MDO2 | — | SIUL QuadSPI — NEXUS | I/O | M | None, None | 172 | 204 | B16 |
| PF[14] | PCR[84] | Option 0 Option 1 Option 2 Option 3 | GPIO[84] QUADSPI_IO1_A — MDO3 | — | SIUL QuadSPI — NEXUS | I/O | M | None, None | 173 | 205 | A16 |
| PF[15] | PCR[85] | Option 0 Option 1 Option 2 Option 3 | GPIO[85] QUADSPI_CLK_A CLKOUT MCKO | — | SIUL QuadSPI Control NEXUS | I/O | F | None, None | 174 | 206 | B18 |
| PORT G | | | | | | | | | | | |
| PG[0] | PCR[86] | Option 0 Option 1 Option 2 Option 3 | GPIO[86] DCU_B0 SCL_3 eMIOS0[21] | RSDS8P | SIUL DCU3 I ² C_3 PWM/Timer | I/O | M | None, None | 136 | 160 | E26 |
| PG[1] | PCR[87] | Option 0 Option 1 Option 2 Option 3 | GPIO[87] DCU_B1 SDA_3 eMIOS0[22] | RSDS8M | SIUL DCU3 I ² C_3 PWM/Timer | I/O | M | None, None | 137 | 161 | D26 |
| PG[2] | PCR[88] | Option 0 Option 1 Option 2 Option 3 | GPIO[88] DCU_B2 — — | RSDS9P | SIUL DCU3 — — | I/O | M | None, None | 141 | 166 | D25 |
| PG[3] | PCR[89] | Option 0 Option 1 Option 2 Option 3 | GPIO[89] DCU_B3 — — | RSDS9M | SIUL DCU3 — — | I/O | M | None, None | 142 | 167 | C25 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|---------|--|---|-------------------------------|----------------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PG[4] | PCR[90] | Option 0 Option 1 Option 2 Option 3 | GPIO[90] DCU_B4 — — | RSDS10P | SIUL DCU3 — — | I/O | M | None, None | 143 | 168 | C26 |
| PG[5] | PCR[91] | Option 0 Option 1 Option 2 Option 3 | GPIO[91] DCU_B5 — — | RSDS10M | SIUL DCU3 — — | I/O | M | None, None | 144 | 169 | B26 |
| PG[6] | PCR[92] | Option 0 Option 1 Option 2 Option 3 | GPIO[92] DCU_B6 — — | RSDS11P | SIUL DCU3 — — | I/O | M | None, None | 145 | 170 | A26 |
| PG[7] | PCR[93] | Option 0 Option 1 Option 2 Option 3 | GPIO[93] DCU_B7 — — | RSDS11M | SIUL DCU3 — — | I/O | M | None, None | 146 | 171 | A25 |
| PG[8] | PCR[94] | Option 0 Option 1 Option 2 Option 3 | GPIO[94] DCU_VSYNC — — | — | SIUL DCU3 — — | I/O | M | None, None | 1 | 1 | T4 |
| PG[9] | PCR[95] | Option 0 Option 1 Option 2 Option 3 | GPIO[95] DCU_HSYNC — — | — | SIUL DCU3 — — | I/O | M | None, None | 2 | 2 | T2 |
| PG[10] | PCR[96] | Option 0 Option 1 Option 2 Option 3 | GPIO[96] DCU_DE — — | — | SIUL DCU3 — — | I/O | M | None, None | 3 | 3 | T1 |
| PG[11] | PCR[97] | Option 0 Option 1 Option 2 Option 3 | GPIO[97] DCU_PCLK — — | RSDSCLKP | SIUL DCU3 — — | I/O | F | None, None | 147 | 172 | E23 |
| PG[12] | PCR[98] | Option 0 Option 1 Option 2 Option 3 | GPIO[98] CS0_1 PDI_DE DCULITE_B7 | — | SIUL DSPL_1 PDI DCULite | I/O | M | None, None | 168 | 200 | A15 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|--------------------|----------|--|--|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PG[13] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PG[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PG[15] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PORT H | | | | | | | | | | | |
| PH[0] ⁶ | PCR[99] | Option 0 Option 1 Option 2 Option 3 | GPIO[99] TCK — — | — | SIUL JTAG — — | I/O | S | Input, Pull Up | 41 | 49 | AC6 |
| PH[1] ⁶ | PCR[100] | Option 0 Option 1 Option 2 Option 3 | GPIO[100] TDI — — | — | SIUL JTAG — — | I/O | S | Input, Pull Up | 42 | 50 | AD6 |
| PH[2] ⁶ | PCR[101] | Option 0 Option 1 Option 2 Option 3 | GPIO[101] TDO — — | — | SIUL JTAG — — | I/O | M | Output, None | 43 | 51 | AE6 |
| PH[3] ⁶ | PCR[102] | Option 0 Option 1 Option 2 Option 3 | GPIO[102] TMS — — | — | SIUL JTAG — — | I/O | S | Input, Pull Up | 44 | 52 | AF6 |
| PH[4] | PCR[103] | Option 0 Option 1 Option 2 Option 3 | GPIO[103] CS0_0 eMIOS1[21] DCULITE_G6 | — | SIUL DSPI_0 PWM/Timer DCULite | I/O | M | None, None | 61 | 73 | AE15 |
| PH[5] | PCR[104] | Option 0 Option 1 Option 2 Option 3 | GPIO[104] VIU7_PDI15 I2S_FS eMIOS1[8] | — | SIUL VIU2/PDI SGM PWM/Timer | I/O | S | None, None | 38 | — | — |
| PH[6] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[7] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[8] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[9] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[10] | — | — | Reserved | — | — | — | — | — | — | — | — |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|--|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PH[11] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[12] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[13] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[15] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PORT J | | | | | | | | | | | |
| PJ[0] | PCR[105] | Option 0 Option 1 Option 2 Option 3 | GPIO[105] DCULITE_B6 — I2S_DO / PWMO | — | SIUL DCULite — SGM | I/O | M | None, None | — | — | L26 |
| PJ[1] | PCR[106] | Option 0 Option 1 Option 2 Option 3 | GPIO[106] VIU1_PDI_HSYNC eMIOS1[9] eMIOS0[8] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 4 | 4 | U4 |
| PJ[2] | PCR[107] | Option 0 Option 1 Option 2 Option 3 | GPIO[107] VIU0_PDI_VSYNC eMIOS1[14] eMIOS0[9] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 5 | 5 | U3 |
| PJ[3] | PCR[108] | Option 0 Option 1 Option 2 Option 3 | GPIO[108] VIU_PCLK eMIOS0[22] PDI_DE | — | SIUL VIU2 PWM/Timer PDI | I/O | S | None, None | 60 | 72 | AD15 |
| PJ[4] | PCR[109] | Option 0 Option 1 Option 2 Option 3 | GPIO[109] VIU2_PDI0 eMIOS0[21] eMIOS0[23] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 56 | 68 | AD14 |
| PJ[5] | PCR[110] | Option 0 Option 1 Option 2 Option 3 | GPIO[110] VIU3_PDI1 eMIOS0[20] eMIOS0[16] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | M | None, None | 57 | 69 | AE14 |
| PJ[6] | PCR[111] | Option 0 Option 1 Option 2 Option 3 | GPIO[111] VIU4_PDI2 eMIOS0[19] eMIOS0[15] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 58 | 70 | AF14 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|----------|--|---|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PJ[7] | PCR[112] | Option 0 Option 1 Option 2 Option 3 | GPIO[112] VIU5_PDI3 eMIOS0[18] eMIOS0[14] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 59 | 71 | AC15 |
| PJ[8] | PCR[113] | Option 0 Option 1 Option 2 Option 3 | GPIO[113] VIU6_PDI4 eMIOS0[17] eMIOS0[13] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 8 | 8 | U2 |
| PJ[9] | PCR[114] | Option 0 Option 1 Option 2 Option 3 | GPIO[114] VIU7_PDI5 eMIOS1[22] eMIOS0[12] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 9 | 9 | U1 |
| PJ[10] | PCR[115] | Option 0 Option 1 Option 2 Option 3 | GPIO[115] VIU8_PDI6 eMIOS1[17] eMIOS0[11] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 10 | 10 | V4 |
| PJ[11] | PCR[116] | Option 0 Option 1 Option 2 Option 3 | GPIO[116] VIU9_PDI7 eMIOS1[15] eMIOS0[10] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 11 | 11 | V3 |
| PJ[12] | PCR[117] | Option 0 Option 1 Option 2 Option 3 | GPIO[117] DCU_TAG — DCULITE_G6 | — | SIUL DCU3 — DCULite | I/O | M | None, None | 148 | 178 | A23 |
| PJ[13] | PCR[118] | Option 0 Option 1 Option 2 Option 3 | GPIO[118] QUADSPI_PCS_B eMIOS1[8] VIU5_PDI13 | — | SIUL QuadSPI PWM/Timer VIU2/PDI | I/O | M | None, None | 149 | 179 | D22 |
| PJ[14] | PCR[119] | Option 0 Option 1 Option 2 Option 3 | GPIO[119] QUADSPI_CLK_B eMIOS1[17] PDI_PCLK | — | SIUL QuadSPI PWM/Timer PDI | I/O | F | None, None | 150 | 180 | C22 |
| PJ[15] | PCR[120] | Option 0 Option 1 Option 2 Option 3 | GPIO[120] QUADSPI_IO3_B eMIOS1[9] VIU6_PDI14 | — | SIUL QuadSPI PWM/Timer VIU2/PDI | I/O | M | None, None | 151 | 181 | B22 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|--|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PORT K | | | | | | | | | | | |
| PK[0] | PCR[121] | Option 0 Option 1 Option 2 Option 3 | GPIO[121] eMIOS1[18]] — — | — | SIUL PWM/Timer — — | I/O | M | None, None | 155 | 187 | A21 |
| PK[1] | PCR[122] | Option 0 Option 1 Option 2 Option 3 | GPIO[122] QUADSPI_IO2_B eMIOS1[14] VIU7_PDI15 | — | SIUL QuadSPI PWM/Timer VIU2/PDI | I/O | M | None, None | 156 | 188 | D20 |
| PK[2] | PCR[123] | Option 0 Option 1 Option 2 Option 3 | GPIO[123] VIU0_PDI8 eMIOS1[10] DCULITE_TAG | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | M | None, None | 31 | 39 | AE3 |
| PK[3] | PCR[124] | Option 0 Option 1 Option 2 Option 3 | GPIO[124] VIU1_PDI9 eMIOS1[11] DCULITE_DE | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | M | None, None | 32 | 40 | AF3 |
| PK[4] | PCR[125] | Option 0 Option 1 Option 2 Option 3 | GPIO[125] VIU2_PDI10 eMIOS1[12] DCULITE_HSYNC | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | M | None, None | 33 | 41 | AC4 |
| PK[5] | PCR[126] | Option 0 Option 1 Option 2 Option 3 | GPIO[126] VIU3_PDI11 eMIOS1[13] DCULITE_VSYNC | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | M | None, None | 34 | 42 | AF4 |
| PK[6] | PCR[127] | Option 0 Option 1 Option 2 Option 3 | GPIO[127] VIU4_PDI12 eMIOS1[9] DCULITE_PCLK | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | F | None, None | 35 | 43 | AC5 |
| PK[7] | PCR[128] | Option 0 Option 1 Option 2 Option 3 | GPIO[128] RXD_2 DCULITE_R2 TCON[8] | — | SIUL LINFlex_2 DCULite TCON | I/O | M | None, None | — | 44 | AD5 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|---|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PK[8] | PCR[129] | Option 0 Option 1 Option 2 Option 3 | GPIO[129] TXD_2 DCULITE_R3 TCON[9] | — | SIUL LINFlex_2 DCULite TCON | I/O | M | None, None | — | 45 | AE5 |
| PK[9] | PCR[130] | Option 0 Option 1 Option 2 Option 3 | GPIO[130] I2S_DO / PWMO DCULITE_R4 TCON[10] | — | SIUL SGM DCULite TCON | I/O | M | None, None | — | 46 | AF5 |
| PK[10] | PCR[131] | Option 0 Option 1 Option 2 Option 3 | GPIO[131] SDA_1 eMIOS1[12] DCULITE_TAG | — | SIUL I ² C_1 PWM/Timer DCULite | I/O | S | None, None | 51 | 59 | AF8 |
| PK[11] | PCR[132] | Option 0 Option 1 Option 2 Option 3 | GPIO[132] SCL_1 eMIOS1[13] DCU_TAG / TCON[3] | — | SIUL I ² C_1 PWM/Timer DCU3 / TCON | I/O | S | None, None | 52 | 60 | AC9 |
| PK[12] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PK[13] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PK[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PK[15] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PORT L | | | | | | | | | | | |
| PL[0] | PCR[133] | Option 0 Option 1 Option 2 Option 3 | GPIO[133] — CANRX_1 — | ANS[19] | SIUL — FlexCAN_1 — | I/O | M / ANALO G | None, None | — | 81 | AE22 |
| PL[1] | PCR[134] | Option 0 Option 1 Option 2 Option 3 | GPIO[134] — CANTX_1 — | ANS[18] | SIUL — FlexCAN_1 — | I/O | M / ANALO G | None, None | — | 82 | AE21 |
| PL[2] | PCR[135] | Option 0 Option 1 Option 2 Option 3 | GPIO[135] — CANRX_0 eMIOS1[22] | ANS[17] | SIUL — FlexCAN_0 PWM/Timer | I/O | S / ANALO G | None, None | — | 83 | AF22 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|----------|--|---|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PL[3] | PCR[136] | Option 0 Option 1 Option 2 Option 3 | GPIO[136] — CANTX_0 eMIOS1[23] | ANS[16] | SIUL — FlexCAN_0 PWM/Timer | I/O | S / ANALOG | None, None | — | 84 | AF21 |
| PL[4] | PCR[137] | Option 0 Option 1 Option 2 Option 3 | GPIO[137] CS2_2 VIU5_PDI13 TCON[6] | — | SIUL DSPI_2 VIU2/PDI TCON | I/O | M | None, None | — | 31 | AB2 |
| PL[5] | PCR[138] | Option 0 Option 1 Option 2 Option 3 | GPIO[138] CS1_2 VIU6_PDI14 TCON[7] | — | SIUL DSPI_2 VIU2/PDI TCON | I/O | M | None, None | — | 32 | AC2 |
| PL[6] | PCR[139] | Option 0 Option 1 Option 2 Option 3 | GPIO[139] CS0_2 VIU7_PDI15 eMIOS1[18] | — | SIUL DSPI_2 VIU2/PDI PWM/Timer | I/O | S | None, None | — | 33 | AD1 |
| PL[7] | PCR[140] | Option 0 Option 1 Option 2 Option 3 | GPIO[140] SIN_2 VIU8_PDI16 eMIOS1[19] | — | SIUL DSPI_2 VIU2/PDI PWM/Timer | I/O | S | None, None | — | 34 | AE1 |
| PL[8] | PCR[141] | Option 0 Option 1 Option 2 Option 3 | GPIO[141] SOUT_2 VIU9_PDI17 eMIOS1[20] | — | SIUL DSPI_2 VIU2/PDI PWM/Timer | I/O | S | None, None | — | 35 | AF1 |
| PL[9] | PCR[142] | Option 0 Option 1 Option 2 Option 3 | GPIO[142] SCK_2 PDI_PCLK eMIOS1[21] | — | SIUL DSPI_2 PDI PWM/Timer | I/O | S | None, None | — | 36 | AF2 |
| PL[10] | PCR[143] | Option 0 Option 1 Option 2 Option 3 | GPIO[143] eMIOS1[10] DCULITE_G2 — | — | SIUL PWM/Timer DCULite — | I/O | M | None, None | — | 174 | C24 |
| PL[11] | PCR[144] | Option 0 Option 1 Option 2 Option 3 | GPIO[144] eMIOS1[11] DCULITE_G3 — | — | SIUL PWM/Timer DCULite — | I/O | M | None, None | — | 175 | A24 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|--|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PL[12] | PCR[145] | Option 0 Option 1 Option 2 Option 3 | GPIO[145] eMIOS1[12] DCULITE_G4 — | — | SIUL PWM/Timer DCULite — | I/O | M | None, None | — | 176 | C23 |
| PL[13] | PCR[146] | Option 0 Option 1 Option 2 Option 3 | GPIO[146] eMIOS1[13] DCULITE_G5 — | — | SIUL PWM/Timer DCULite — | I/O | M | None, None | — | 177 | B23 |
| PL[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PL[15] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PORT M | | | | | | | | | | | |
| PM[0] | PCR[147] | Option 0 Option 1 Option 2 Option 3 | GPIO[147] I2S_SCK / PWMOA DCULITE_R5 TCON[11] | — | SIUL SGM DCULite TCON | I/O | M | None, None | — | 61 | AE9 |
| PM[1] | PCR[148] | Option 0 Option 1 Option 2 Option 3 | GPIO[148] I2S_FS DCULITE_R6 — | — | SIUL SGM DCULite — | I/O | M | None, None | — | 62 | AF9 |
| PM[2] | PCR[149] | Option 0 Option 1 Option 2 Option 3 | GPIO[149] eMIOS1[17] DCULITE_R7 DCULITE_DE | RSDSCLKM | SIUL PWM/Timer DCULite DCULite | I/O | M | None, None | — | 173 | D23 |
| PM[3] | PCR[150] | Option 0 Option 1 Option 2 Option 3 | GPIO[150] CANRX_2 RXD_3 TCON[4] | — | SIUL FlexCAN_2 LINFlex_3 TCON | I/O | M | None, None | — | 16 | Y3 |
| PM[4] | PCR[151] | Option 0 Option 1 Option 2 Option 3 | GPIO[151] CANTX_2 TXD_3 TCON[5] | — | SIUL FlexCAN_2 LINFlex_3 TCON | I/O | M | None, None | — | 17 | Y2 |
| PM[5] | PCR[152] | Option 0 Option 1 Option 2 Option 3 | GPIO[152] VIU5_PDI3 eMIOS1[22] DCU_TAG | — | SIUL VIU2/PDI PWM/Timer DCU3 | I/O | M | None, None | 16 | — | — |



Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|----------|--|--|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PM[6] | PCR[153] | Option 0 Option 1 Option 2 Option 3 | GPIO[153] VIU6_PDI14 eMIOS1[23] DCULITE_TAG | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | M | None, None | 17 | — | — |
| PM[7] | PCR[154] | Option 0 Option 1 Option 2 Option 3 | GPIO[154] VIU8_PDI16 I2S_DO / PWMO eMIOS1[16] | — | SIUL VIU2/PDI SGM PWM/Timer | I/O | S | None, None | 39 | — | — |
| PM[8] | PCR[155] | Option 0 Option 1 Option 2 Option 3 | GPIO[155] VIU9_PDI17 I2S_SCK / PWMOA eMIOS1[23] | — | SIUL VIU2/PDI SGM PWM/Timer | I/O | S | None, None | 40 | — | — |
| PM[9] | PCR[156] | Option 0 Option 1 Option 2 Option 3 | GPIO[156] PDI_PCLK SGM_MCLK eMIOS0[8] | — | SIUL PDI SGM PWM/Timer | I/O | M | None, None | 113 | — | — |
| PM[10] | PCR[157] | Option 0 Option 1 Option 2 Option 3 | GPIO[157] RXD_2 CANRX_2 eMIOS0[16] | — | SIUL LINFlex_2 FlexCAN_2 PWM/Timer | I/O | S | None, None | 114 | — | — |
| PM[11] | PCR[158] | Option 0 Option 1 Option 2 Option 3 | GPIO[158] TXD_2 CANTX_2 eMIOS0[23] | — | SIUL LINFlex_2 FlexCAN_2 PWM/Timer | I/O | S | None, None | 115 | — | — |
| PM[12] | PCR[159] | Option 0 Option 1 Option 2 Option 3 | GPIO[159] DCULITE_B7 — I2S_SCK / PWMOA | — | SIUL DCULite — SGM | I/O | M | None, None | — | — | L24 |
| PM[13] | PCR[160] | Option 0 Option 1 Option 2 Option 3 | GPIO[160] DCULITE_PCLK — SGM_MCLK | — | SIUL DCULite — SGM | I/O | F | None, None | — | — | L23 |
| PM[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PM[15] | — | — | Reserved | — | — | — | — | — | — | — | — |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|---|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PORT N | | | | | | | | | | | |
| PN[0] | PCR[161] | Option 0 Option 1 Option 2 Option 3 | GPIO[161] DCULITE_HSYNC — TCON[4] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AC3 |
| PN[1] | PCR[162] | Option 0 Option 1 Option 2 Option 3 | GPIO[162] DCULITE_VSYNC — TCON[5] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AD3 |
| PN[2] | PCR[163] | Option 0 Option 1 Option 2 Option 3 | GPIO[163] DCULITE_R0 RXD_2 VIU0_PDI8 | — | SIUL DCULite LINFlex_2 VIU2/PDI | I/O | M | None, None | — | — | AC10 |
| PN[3] | PCR[164] | Option 0 Option 1 Option 2 Option 3 | GPIO[164] DCULITE_R1 TXD_2 VIU1_PDI9 | — | SIUL DCULite LINFlex_2 VIU2/PDI | I/O | M | None, None | — | — | AF10 |
| PN[4] | PCR[165] | Option 0 Option 1 Option 2 Option 3 | GPIO[165] DCULITE_R2 — TCON[6] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AC11 |
| PN[5] | PCR[166] | Option 0 Option 1 Option 2 Option 3 | GPIO[166] DCULITE_R3 — TCON[7] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AD11 |
| PN[6] | PCR[167] | Option 0 Option 1 Option 2 Option 3 | GPIO[167] DCULITE_R4 — TCON[8] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AE11 |
| PN[7] | PCR[168] | Option 0 Option 1 Option 2 Option 3 | GPIO[168] DCU_LITE_R5 — TCON[9] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AF11 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|--|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PN[8] | PCR[169] | Option 0 Option 1 Option 2 Option 3 | GPIO[169] DCULITE_R6 — TCON[10] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AC12 |
| PN[9] | PCR[170] | Option 0 Option 1 Option 2 Option 3 | GPIO[170] DCULITE_R7 — TCON[11] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AD12 |
| PN[10] | PCR[171] | Option 0 Option 1 Option 2 Option 3 | GPIO[171] DCULITE_G0 RXD_3 VIU2_PDI10 | — | SIUL DCULite LINFlex_3 VIU2/PDI | I/O | M | None, None | — | — | AE12 |
| PN[11] | PCR[172] | Option 0 Option 1 Option 2 Option 3 | GPIO[172] DCULITE_G1 TXD_3 VIU3_PDI11 | — | SIUL DCULite LINFlex_3 VIU2/PDI | I/O | M | None, None | — | — | AF12 |
| PN[12] | PCR[173] | Option 0 Option 1 Option 2 Option 3 | GPIO[173] DCULITE_G2 — eMIOS0[17] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | R26 |
| PN[13] | PCR[174] | Option 0 Option 1 Option 2 Option 3 | GPIO[174] DCULITE_G3 — eMIOS0[18] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | R25 |
| PN[14] | PCR[175] | Option 0 Option 1 Option 2 Option 3 | GPIO[175] DCULITE_G4 — eMIOS0[19] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | P26 |
| PN[15] | PCR[176] | Option 0 Option 1 Option 2 Option 3 | GPIO[176] DCULITE_G5 — eMIOS0[20] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | P24 |
| PORT P | | | | | | | | | | | |
| PP[0] | PCR[177] | Option 0 Option 1 Option 2 Option 3 | GPIO[177] DCULITE_G6 — eMIOS0[21] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | P23 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|----------|--|--|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PP[1] | PCR[178] | Option 0 Option 1 Option 2 Option 3 | GPIO[178] DCULITE_G7 — eMIOS0[22] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | N26 |
| PP[2] | PCR[179] | Option 0 Option 1 Option 2 Option 3 | GPIO[179] DCULITE_B0 CANRX_2 VIU4_PDI12 | — | SIUL DCULite FlexCAN_2 VIU2/PDI | I/O | M | None, None | — | — | N25 |
| PP[3] | PCR[180] | Option 0 Option 1 Option 2 Option 3 | GPIO[180] DCULITE_B1 CANTX_2 PDI_DE | — | SIUL DCULite FlexCAN_2 PDI | I/O | M | None, None | — | — | N23 |
| PP[4] | PCR[181] | Option 0 Option 1 Option 2 Option 3 | GPIO[181] DCULITE_B2 — eMIOS0[11] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | M26 |
| PP[5] | PCR[182] | Option 0 Option 1 Option 2 Option 3 | GPIO[182] DCULITE_B3 — eMIOS0[13] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | M25 |
| PP[6] | PCR[183] | Option 0 Option 1 Option 2 Option 3 | GPIO[183] DCULITE_B4 — eMIOS0[15] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | M24 |
| PP[7] | PCR[184] | Option 0 Option 1 Option 2 Option 3 | GPIO[184] DCULITE_B5 — I2S_FS | — | SIUL DCULite — SGM | I/O | M | None, None | — | — | M23 |
| PP[8] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[9] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[10] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[11] | — | — | Reserved | — | — | — | — | — | — | — | — |

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PXD20 Microcontroller Data Sheet, Rev. 2

Freescal Semiconductor

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|-----|---------------------------------|----------|-------------------------------|-------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PP[12] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[13] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[15] | — | — | Reserved | — | — | — | — | — | — | — | — |

¹ Alternate functions are chosen by setting the values of the PCR[PA] bitfields inside the SIUL module.

PCR[PA] = 00 selects Option 0

PCR[PA] = 01 selects Option 1

PCR[PA] = 10 selects Option 2

PCR[PA] = 11 selects Option 3

This is intended to select the output functions. To use one of the input functions, the PCR[IBE] bit must be written to '1', regardless of the values selected in the PCR[PA] bitfields. For this reason, the value corresponding to an input only function is reported as "—".

² Special functions are enabled independently from the standard digital pin functions. Enabling standard I/O functions in the PCR registers may interfere with their functionality. ADC functions are enabled using the PCR[APC] bit; other functions are enabled by enabling the respective module.

³ Using the PSMI registers in the System Integration Unit Lite (SIUL), different pads can be multiplexed to the same peripheral input. Please see the SIUL chapter of the *PXD20 Microcontroller Reference Manual* for details.

⁴ See the "Pad types" section for an explanation of the letters in this column.

⁵ Reset configuration is given as I/O direction and pull, e.g., "Input, pullup".

⁶ Out of reset pins PH[0:3] are available as JTAG pins (TCK, TDI, TDO and TMS respectively). It is up to the user to configure pins PH[0:3] when needed.

3 System design information

3.1 Power-up sequencing

The preferred power-up sequence for PXD20 is as follows:

1. Generic IO supplies or noise-free supplies, consisting of:
 - VDDA
 - VDDE_A
 - VDDE_B
 - VDDM
 - VDD_DR
 - VDD33_DR
 - VDDPLL

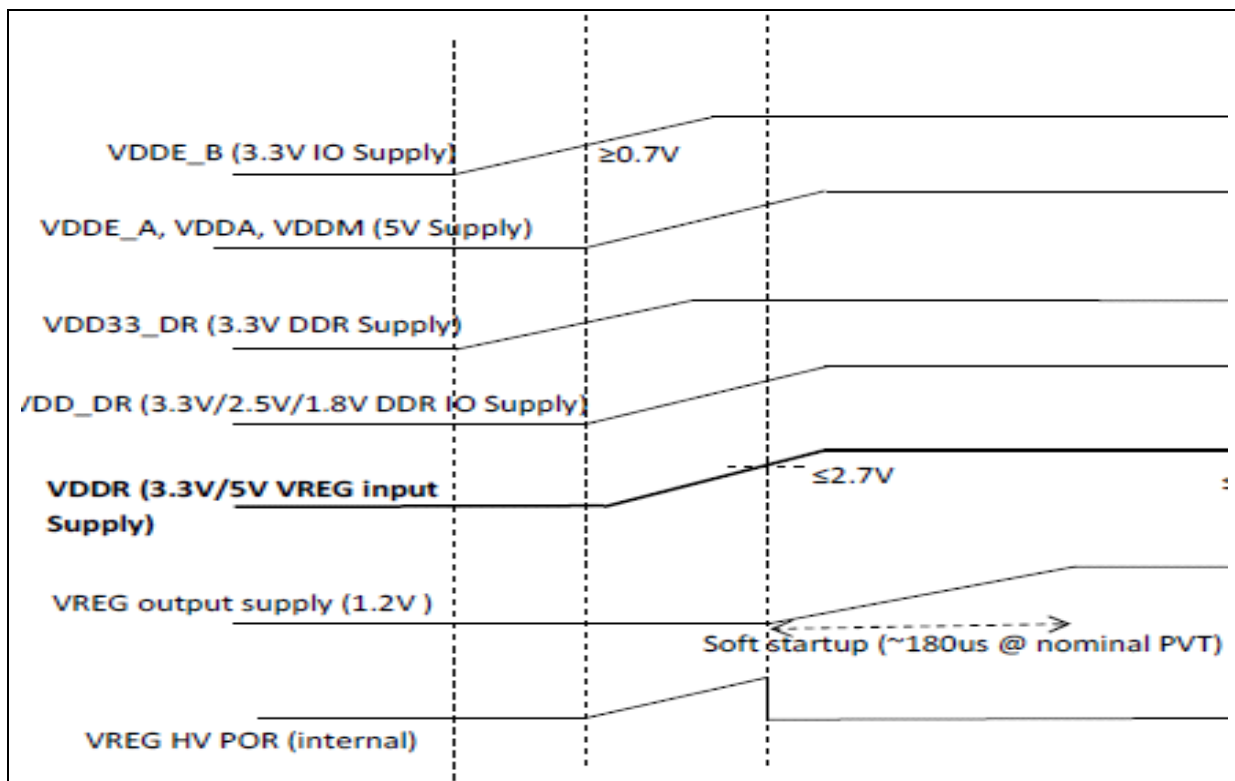


Figure 6. Power-up sequencing

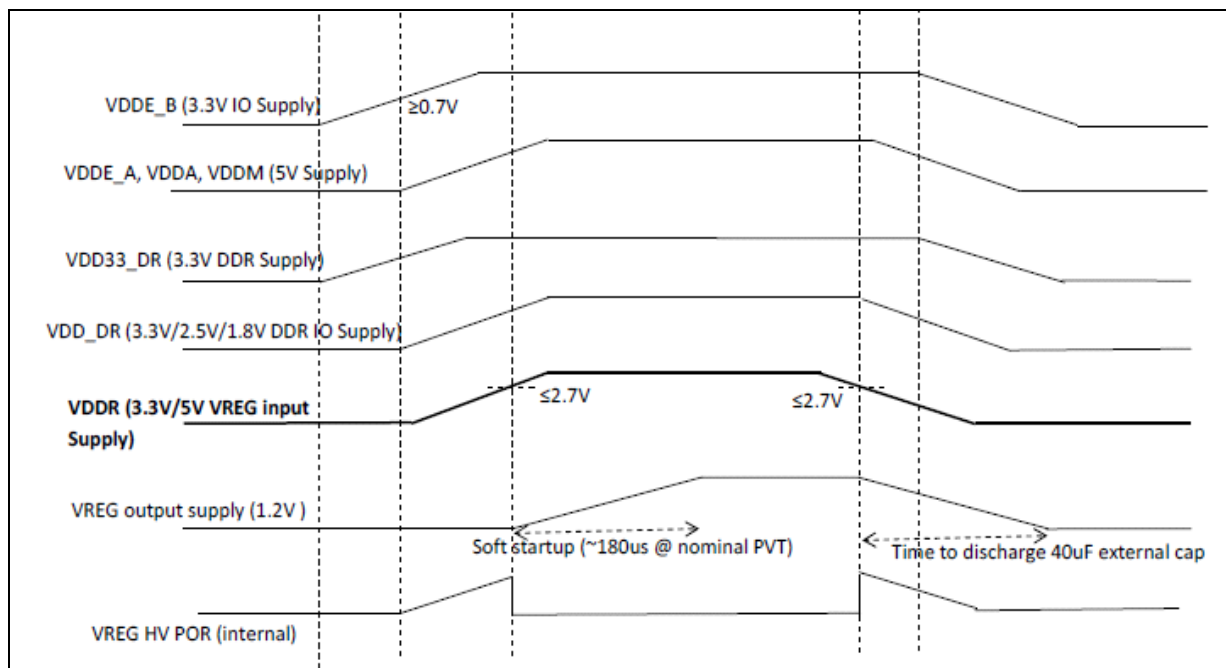


Figure 7. Power-down sequencing

2. All 3.3V supplies (VDDE_B and VDD33_DR) should be ramped up first, and then the rest of the I/O supplies should be ramped up (VDDA, VDDE_A, VDDM, and VDD_DR).
3. VDDR, the regulator input supply, should be the last supply to ramp up; all supplies can be ramped up together as long as VDDR is included. So all 5V supplies should be ramped up after the 3.3 V supplies, and if all the supplies are of the same level, they can be ramped up together as well.
4. LV supply (VDD12). If Vreg is in bypass mode and the core supply (1.2 V) is supplied externally, then this should be the last supply given.

NOTE

For DDR, the 3.3 V supply (VDD33_DR) should come before VDD_DR.

This sequence ensures that when VREG releases its LVDs, the IO and other HV segments are powered properly. This is important because PXD20 doesn't monitor LVDs on IO HV supplies.

4 Electrical characteristics

4.1 Introduction

This section contains electrical characteristics of the device as well as temperature and power considerations.

This product contains devices to protect the inputs against damage due to high static voltages. However, it is advisable to take precautions to avoid application of any voltage higher than the specified maximum rated voltages.

To enhance reliability, unused inputs can be driven to an appropriate logic voltage level (V_{DD} or V_{SS}). This could be done by internal pull up and pull down, which is provided by the product for most general purpose pins.

The parameters listed in the following tables represent the characteristics of the device and its demands on the system.

In the tables where the device logic provides signals with their respective timing characteristics, the symbol “CC” for Controller Characteristics is included in the Symbol column.

In the tables where the external system must provide signals with their respective timing characteristics to the device, the symbol “SR” for System Requirement is included in the Symbol column.

4.2 Parameter classification

The electrical parameters shown in this supplement are guaranteed by various methods. To give the customer a better understanding, the classifications listed in [Table 8](#) are used and the parameters are tagged accordingly in the tables where appropriate.

Table 8. Parameter classifications

| Classification tag | Tag description |
|--------------------|--|
| P | Those parameters are guaranteed during production testing on each individual device. |
| C | Those parameters are achieved by the design characterization by measuring a statistically relevant sample size across process variations. |
| T | Those parameters are achieved by design characterization on a small sample size from typical devices under typical conditions unless otherwise noted. All values shown in the typical column are within this category. |
| D | Those parameters are derived mainly from simulations. |

NOTE

The classification is shown in the column labeled “C” in the parameter tables where appropriate.

4.3 Absolute maximum ratings

Table 9. Absolute maximum ratings

| Symbol | C | Parameter | Conditions | Value | | Unit | SpecID |
|---------------------------------|----|---|-----------------------------|-----------------------|--|------|--------|
| | | | | Min | Max | | |
| V _{DDA} | SR | Voltage on VDDA pin (ADC reference) with respect to ground (V _{SSA}) | | -0.3 | +5.5 | V | D1.1 |
| | | | Relative to V _{DD} | V _{DD} - 0.3 | V _{DD} + 0.3 | | |
| V _{SSA} | SR | Voltage on VSSA (ADC reference) pin with respect V _{SS} | | V _{SS} - 0.1 | V _{SS} +0.1 | V | D1.2 |
| V _{DDPLL} | CC | Voltage on VDDPLL (1.2 V PLL supply) pin with respect to ground (V _{SSPLL}) | | 1.08 | 1.32 | V | D1.3 |
| | | | Relative to V _{DD} | V _{DD} - 0.3 | V _{DD} + 0.3 | | |
| V _{DDR} | SR | Voltage on VDDR pin (regulator supply) with respect to ground (V _{SSR}) | | -0.3 | +5.5 | V | D1.4 |
| | | | Relative to V _{DD} | V _{DD} - 0.3 | V _{DD} + 0.3 | | |
| V _{SSR} | SR | Voltage on VSSR (regulator ground) pin with respect to V _{SS} | | V _{SS} - 0.1 | V _{SS} + 0.1 | V | D1.5 |
| V _{DD12} | CC | Voltage on VDD12 pin with respect to ground (V _{SS12}) | | 1.08 | 1.4 | V | D1.6 |
| V _{SS12} | CC | Voltage on VSS12 pin with respect to V _{SS} | | V _{SS} - 0.1 | V _{SS} + 0.1 | V | D1.7 |
| V _{DDE_A} ¹ | SR | Voltage on VDDE_A (I/O supply) pin with respect to ground (V _{SSE_A}) | | -0.3 | +5.5 | V | D1.8 |
| V _{DDE_B} ¹ | SR | Voltage on VDDE_B (I/O supply) pin with respect to ground (V _{SS}) | | -0.3 | +3.6 | V | D1.9 |
| V _{DDM} ¹ | SR | Voltage on VDDM (stepper motor supply) pin with respect to ground (V _{SSM}) | | -0.3 | +5.5 | V | D1.10 |
| V _{SS} ² | SR | I/O supply ground | | 0 | 0 | V | D1.11 |
| V _{DD_DR} | | Voltage on V _{DDDDR} with respect to V _{SS} | | -0.3 | 3.6 | V | D1.12 |
| V _{RSDS} | | Voltage on V _{DDRSDS} with respect to V _{SS} | | -0.3 | 3.6 | V | D1.13 |
| V _{IN} | SR | Voltage on any GPIO pin with respect to ground (V _{SS}) | | -0.3 | V _{DDmax} (V _{DDE} max of that segment) | V | |
| I _{INJPAD} | SR | Injected input current on any pin during overload condition | | -10 | 10 | mA | D1.15 |
| I _{INJSUM} | SR | Absolute sum of all injected input currents during overload condition | | -50 | 50 | | D1.16 |
| T _{STORAGE} | SR | T Storage temperature | | -55 | 150 | °C | D1.17 |
| ESD _{HBM} | SR | ESD Susceptibility (Human Body Model) | | | 2000 | V | D1.18 |

¹ Throughout the remainder of this document V_{DD} refers collectively to I/O voltage supplies, i.e., V_{DDE_A}, V_{DDE_B}, and V_{DDM}, unless otherwise noted.

² Throughout the remainder of this document V_{SS} refers collectively to I/O voltage supply grounds, i.e., V_{SSE_A}, V_{SSPLL}, and V_{SSM}, unless otherwise noted.

NOTE

Stresses exceeding the recommended absolute maximum ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. During overload conditions ($V_{IN} > V_{DD}$ or $V_{IN} < V_{SS}$), the voltage on pins with respect to ground (V_{SS}) must not exceed the recommended values.

4.4 Recommended operating conditions

Table 10. Recommended operating conditions (3.3 V)

| Symbol | C | Parameter | Conditions | Value | | Unit | SpecID | |
|------------------|----|-----------|---|----------------------|----------------|----------------|--------|-------|
| | | | | Min | Max | | | |
| V_{DDA}^1 | SR | P | Voltage on VDDA pin (ADC reference) with respect to ground (V_{SS}) | | +3.0 | +3.6 | V | D2.1 |
| | | | | Relative to V_{DD} | $V_{DD} - 0.1$ | $V_{DD} + 0.1$ | | |
| V_{SSA} | SR | P | Voltage on VSSA (ADC reference) pin with respect V_{SS} | | $V_{SS} - 0.1$ | $V_{SS} + 0.1$ | V | D2.2 |
| V_{DDPLL} | CC | P | Voltage on VDDPLL (1.2 V PLL supply) pin with respect to ground (V_{SSPLL}) | | 1.08 | 1.32 | V | D2.3 |
| V_{DDR}^2 | SR | P | Voltage on VDDR pin (regulator supply) with respect to ground (V_{SSR}) | | +3.0 | +3.6 | V | D2.4 |
| | | | | Relative to V_{DD} | $V_{DD} - 0.1$ | $V_{DD} + 0.1$ | | |
| V_{SSR} | SR | D | Voltage on VSSR (regulator ground) pin with respect to V_{SS} | | $V_{SS} - 0.1$ | $V_{SS} + 0.1$ | V | D2.5 |
| $V_{DD12}^{3,4}$ | CC | P | Voltage on VDD12 pin with respect to ground (V_{SS12}) | | 1.08 | 1.4 | V | D2.6 |
| V_{SS12} | CC | D | Voltage on VSS12 pin with respect to V_{SS} | | $V_{SS} - 0.1$ | $V_{SS} + 0.1$ | V | D2.7 |
| $V_{DD}^{5,6,7}$ | SR | P | Voltage on V_{DD} pins (V_{DDE_A} , V_{DDE_B} , V_{DD_DR} , V_{DDM}) with respect to ground (V_{SS}) | | V_{DDmin}^5 | V_{DDmax}^5 | V | D2.8 |
| V_{SS}^8 | SR | D | I/O supply ground | | 0 | 0 | V | D2.9 |
| $V_{DDE_A}^9$ | SR | P | Voltage on VDDE_A (I/O supply) pin with respect to ground (V_{SSE_A}) | | +3.0 | +3.6 | V | D2.10 |
| V_{DDE_B} | SR | P | Voltage on VDDE_B (I/O supply) pin with respect to ground (V_{SSE_B}) | | +3.0 | +3.6 | V | D2.11 |
| V_{DDM} | SR | P | Voltage on VDDM (stepper motor supply) pin with respect to ground (V_{SSM}) | | +3.0 | +3.6 | V | D2.12 |
| V_{DD_DR} | | P | Voltage on V_{DDDDR} with respect to V_{SS} | | +1.62 | +3.6 | V | D2.13 |
| V_{SS_DR} | | D | Voltage on V_{SSRSDS} with respect to V_{SS} | | +1.62 | +3.6 | V | D2.14 |
| V_{RSDS} | | P | Voltage on V_{DDDDR} with respect to V_{SS} | | +3.0 | +3.6 | V | D2.15 |
| TV_{DD} | SR | D | V_{DD} slope to ensure correct power up ¹⁰ | | | 12 | V/ms | D2.16 |
| T_A | SR | P | Ambient temperature under bias | | -40 | 105 | °C | D2.17 |
| T_J | SR | D | Junction temperature under bias | | -40 | 140 | | D2.18 |

- ¹ 100 nF capacitance needs to be provided between V_{DDA}/V_{SSA} pair.
- ² 10 μ F capacitance must be connected between V_{DDR} and V_{SS12} because of a sharp surge due to external ballast.
- ³ V_{DD12} cannot be used to drive any external component.
- ⁴ Each V_{DD12}/V_{SS12} supply pair should have a 10 μ F capacitor. Absolute combined maximum capacitance is 40 μ F. Preferably, all the V_{DD12} supply pads should be shorted and then connected to a $4 \times 10 \mu$ F capacitance. This is to ensure the ESR of external capacitance does not exceed 0.2 Ω . A 100 nF capacitor must be placed close to the pin.
- ⁵ V_{DD} refers collectively to I/O voltage supplies, i.e., V_{DDE_A} , V_{DDE_B} , V_{DD_DR} , and V_{DDM} .
- ⁶ 100 nF capacitance needs to be provided between each V_{DD}/V_{SS} pair. V_{DDmin} value for is 3 V for V_{DDE_A} & V_{DDM} as well as for V_{DDE_B} , while it is 1.62 V for V_{DD_DR} . V_{DD} max value is 3.6 V for V_{DDE_A} & V_{DDM} as well as for V_{DDE_B} & V_{DD_DR} .
- ⁷ Full electrical specification cannot be guaranteed when voltage drops below 3.0V. In particular, ADC electrical characteristics and I/O's DC electrical specification may not be guaranteed.
When voltage drops below V_{LVDHVL} device is reset.
- ⁸ V_{SS} refers collectively to I/O voltage supply grounds, i.e., V_{SSE_A} , V_{SS} , and V_{SSM} unless otherwise noted.
- ⁹ V_{DDE_A} should not be less than V_{DDA} .
- ¹⁰ Guaranteed by device validation.

Table 11. Recommended operating conditions (5.0 V)

| Symbol | C | Parameter | Conditions | Value | | Unit | SpecID |
|----------------------------|----|---|---------------------------|--------------------------|--------------------------|------|--------|
| | | | | Min | Max | | |
| V_{DDA} ¹ | SR | P Voltage on V_{DDA} pin (ADC reference) with respect to ground (V_{SS}) | | +4.5 | +5.5 | V | D2.19 |
| | | | Voltage drop ² | +3.0 | +5.5 | | |
| | | | Relative to V_{DD} | $V_{DD} - 0.1$ | $V_{DD} + 0.1$ | | |
| V_{SSA} | SR | D Voltage on V_{SSA} (ADC reference) pin with respect V_{SS} | | $V_{SS} - 0.1$ | $V_{SS} + 0.1$ | V | D2.20 |
| V_{DDPLL} | CC | P Voltage on V_{DDPLL} (1.2 V PLL supply) pin with respect to ground (V_{SSPLL}) | | 1.08 | 1.32 | V | D2.21 |
| V_{DDR} ³ | SR | P Voltage on V_{DDR} pin (regulator supply) with respect to ground (V_{SSR}) | | +3.0 | +3.6 | V | D2.22 |
| | | | Voltage drop ² | +3.0 | +3.6 | | |
| | | | Relative to V_{DD} | $V_{DD} - 0.1$ | $V_{DD} + 0.1$ | | |
| V_{SSR} | SR | D Voltage on V_{SSR} (regulator ground) pin with respect to V_{SS} | | $V_{SS} - 0.1$ | $V_{SS} + 0.1$ | V | D2.23 |
| V_{DD12} ^{4,5} | CC | P Voltage on V_{DD12} pin with respect to ground (V_{SS12}) | | 1.08 | 1.4 | V | D2.24 |
| V_{SS12} | CC | D Voltage on V_{SS12} pin with respect to V_{SS} | | $V_{SS} - 0.1$ | $V_{SS} + 0.1$ | V | D2.25 |
| V_{DD} ^{6,7} | SR | P Voltage on V_{DD} pins (V_{DDE_A} , V_{DDE_B} , V_{DD_DR} , V_{DDMA} , V_{DDMB} , V_{DDMC}) with respect to ground (V_{SS}) | Voltage drop ² | V_{DDmin} ⁶ | V_{DDmax} ⁶ | V | D2.26 |
| V_{SS} ⁸ | SR | D I/O supply ground | | 0 | 0 | V | D2.27 |
| V_{DDE_A} ⁹ | SR | P Voltage on V_{DDE_A} (I/O supply) pin with respect to ground (V_{SSE_A}) | | +4.5 | +5.5 | V | D2.28 |
| V_{DDE_B} ¹⁰ | SR | P Voltage on V_{DDE_B} (I/O supply) pin with respect to ground (V_{SSE_B}) | | +3.0 | +3.6 | V | D2.29 |

Table 11. Recommended operating conditions (5.0 V) (continued)

| Symbol | C | Parameter | Conditions | Value | | Unit | SpecID |
|----------------------------------|----|-----------|---|-------|------|------|--------|
| | | | | Min | Max | | |
| V _{DDM} | SR | P | Voltage on VDDMA (stepper motor supply) pin with respect to ground (V _{SSMA}) | +4.5 | +5.5 | V | D2.30 |
| V _{DD_DR} ¹¹ | | P | Voltage on V _{DD_DR} with respect to V _{SS} | +1.62 | +3.6 | V | D2.31 |
| V _{SS_DR} | | D | Voltage on V _{SSRSDS} with respect to V _{SS} | +1.62 | +3.6 | V | D2.32 |
| V _{RSDS} | | P | Voltage on V _{DD_DR} with respect to V _{SS} | +3.0 | +3.6 | V | D2.33 |
| TV _{DD} | SR | D | V _{DD} slope to ensure correct power up ¹² | | 12 | V/ms | D2.34 |
| T _A | SR | P | Ambient temperature under bias | -40 | 105 | °C | D2.35 |
| | | | | -40 | 105 | | |
| T _J | SR | D | Junction temperature under bias | -40 | 140 | | D2.36 |

¹ 100 nF capacitance needs to be provided between V_{DDA}/V_{SSA} pair.

² Full functionality cannot be guaranteed when voltage drops below 4.5 V. In particular, I/O DC and ADC electrical characteristics may not be guaranteed below 4.5 V during the voltage drop sequence.

³ 10 μF capacitance must be connected between V_{DDR} and V_{SS12}. It is recommended that this cap should be placed, as close as possible to the DUT pin on board.

⁴ V_{DD12} cannot be used to drive any external component.

⁵ Each V_{DD12}/V_{SS12} supply pair should have a 10 μF capacitor. Absolute combined maximum capacitance is 40 μF. Preferably, all the VDD12 supply pads should be shorted and then connected to a 4×10 μF capacitance. This is to ensure the ESR of external capacitance does not exceed 0.2 Ω. A 100 nF capacitor must be placed close to the pin.

⁶ V_{DD} refers collectively to I/O voltage supplies, i.e., V_{DDE_A}, V_{DDE_B}, V_{DDE_DR}, V_{DDMA}, V_{DDMB} and V_{DDMC}. VDDmin value for is 4.5 V for VDDE_A & VDDM, 3 V VDDE_B, while it is 1.62 V for VDD_DR. VDD max value is 5.5 V for VDDE_A & VDDM and 3.6 V for VDDE_B & VDD_DR.

⁷ 100 nF capacitance needs to be provided between each V_{DD}/V_{SS} pair.

⁸ V_{SS} refers collectively to I/O voltage supply grounds, i.e., V_{SSE_A}, V_{SSE_B}, V_{SSE_A}, V_{SSE_E}, V_{SSMA}, V_{SSMB} and V_{SSMC}) unless otherwise noted.

⁹ V_{DDE_A} should not be less than V_{DDA}.

¹⁰ VDDE_B cannot go beyond 3.6V under any operating condition.

¹¹ VDD_DR can be 1.8, 2.5 and 3.3V (typical) based on type of SDR memory.

¹² Guaranteed by device validation

4.5 Thermal characteristics

Table 12. Thermal characteristics for 176-pin LQFP¹

| Symbol | C | Parameter | Conditions | Value | Unit | SpecID | |
|---------------------|----|-----------|---|---------------------------------------|------|--------|------|
| R _{θJA} | CC | D | Junction to Ambient Natural Convection ² | Single layer board -1s | 36 | °C/W | D3.1 |
| R _{θJA} | CC | D | Junction to Ambient Natural Convection ² | Four layer board -2s2p | 29 | °C/W | D3.2 |
| R _{θJMA} | CC | D | Junction to Ambient ² | @200 ft./min., single layer board -1s | 28 | °C/W | D3.3 |
| R _{θJMA} | CC | D | Junction to Ambient ² | @200 ft./min., Four layer board -2s2p | 23 | °C/W | D3.4 |
| R _{θJB} | CC | D | Junction to Board ³ | | 18 | °C/W | D3.5 |
| R _{θJctop} | CC | D | Junction to Case (Top) ⁴ | | 5 | °C/W | D3.6 |

Table 12. Thermal characteristics for 176-pin LQFP¹ (continued)

| Symbol | C | D | Parameter | Conditions | Value | Unit | SpecID |
|-------------|----|---|---|------------|-------|------|--------|
| Ψ_{JT} | CC | D | Junction to Package Top Natural Convection ⁵ | | 2 | °C/W | D3.7 |

¹ Thermal characteristics are targets based on simulation that are subject to change per device characterization.

² Junction-to-Ambient Thermal Resistance determined per JEDEC JESD51-3 and JESD51-6. Thermal test board meets JEDEC specification for this package.

³ Junction-to-Board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.

⁴ Junction-to-Case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.

⁵ Thermal characterization parameter indicating the temperature difference between the package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

Table 13. Thermal characteristics for 208-pin LQFP¹

| Symbol | C | D | Parameter | Conditions | Value | Unit | SpecID |
|--------------------|----|---|---|---------------------------------------|-------|------|--------|
| $R_{\theta JA}$ | CC | D | Junction to Ambient Natural Convection ² | Single layer board –1s | 34 | °C/W | D3.8 |
| $R_{\theta JA}$ | CC | D | Junction to Ambient Natural Convection ² | Four layer board –2s2p | 27 | °C/W | D3.9 |
| $R_{\theta JMA}$ | CC | D | Junction to Ambient ² | @200 ft./min., single layer board –1s | 27 | °C/W | D3.10 |
| $R_{\theta JMA}$ | CC | D | Junction to Ambient ² | @200 ft./min., Four layer board –2s2p | 22 | °C/W | D3.11 |
| $R_{\theta JB}$ | CC | D | Junction to Board ³ | — | 18 | °C/W | D3.12 |
| $R_{\theta Jctop}$ | CC | D | Junction to Case (Top) ⁴ | — | 5 | °C/W | D3.13 |
| Ψ_{JT} | CC | D | Junction to Package Top Natural Convection ⁵ | — | 2 | °C/W | D3.14 |

¹ Thermal characteristics are targets based on simulation that are subject to change per device characterization.

² Junction-to-Ambient Thermal Resistance determined per JEDEC JESD51-3 and JESD51-6. Thermal test board meets JEDEC specification for this package.

³ Junction-to-Board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.

⁴ Junction-to-Case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.

⁵ Thermal characterization parameter indicating the temperature difference between the package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

Table 14. Thermal characteristics for 416-pin TEPBGA¹

| Symbol | C | D | Parameter | Conditions | Value | Unit | SpecID |
|--------------------|----|---|---|---------------------------------------|-------|------|--------|
| $R_{\theta JA}$ | CC | D | Junction to Ambient Natural Convection ² | Single layer board –1s | 26 | °C/W | D3.15 |
| $R_{\theta JA}$ | CC | D | Junction to Ambient Natural Convection ² | Four layer board –2s2p | 18 | °C/W | D3.16 |
| $R_{\theta JMA}$ | CC | D | Junction to Ambient ² | @200 ft./min., single layer board –1s | 20 | °C/W | D3.17 |
| $R_{\theta JMA}$ | CC | D | Junction to Ambient ² | @200 ft./min., Four layer board –2s2p | 15 | °C/W | D3.18 |
| $R_{\theta JB}$ | CC | D | Junction to Board ³ | — | 10 | °C/W | D3.19 |
| $R_{\theta Jctop}$ | CC | D | Junction to Case (Top) ⁴ | — | 6 | °C/W | D3.20 |

Table 14. Thermal characteristics for 416-pin TEPBGA¹ (continued)

| Symbol | C | Parameter | Conditions | Value | Unit | SpecID |
|-------------|----|---|------------|-------|------|--------|
| Ψ_{JT} | CC | D Junction to Package Top Natural Convection ⁵ | — | 2 | °C/W | D3.21 |

¹ Thermal characteristics are targets based on simulation that are subject to change per device characterization.

² Junction-to-Ambient Thermal Resistance determined per JEDEC JESD51-3 and JESD51-6. Thermal test board meets JEDEC specification for this package.

³ Junction-to-Board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.

⁴ Junction-to-Case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.

⁵ Thermal characterization parameter indicating the temperature difference between the package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

4.5.1 General notes for specifications at maximum junction temperature

An estimate of the chip junction temperature, T_J , can be obtained from the equation:

$$T_J = T_A + (R_{\theta JA} * P_D) \quad \text{Eqn. 1}$$

where:

T_A = ambient temperature for the package (°C)

$R_{\theta JA}$ = junction to ambient thermal resistance (°C/W)

P_D = power dissipation in the package (W)

The thermal resistance values used are based on the JEDEC JESD51 series of standards to provide consistent values for estimations and comparisons. The difference between the values determined for the single-layer (1s) board compared to a four-layer board that has two signal layers, a power and a ground plane (2s2p), demonstrate that the effective thermal resistance is not a constant. The thermal resistance depends on the:

- Construction of the application board (number of planes)
- Effective size of the board which cools the component
- Quality of the thermal and electrical connections to the planes
- Power dissipated by adjacent components

Connect all the ground and power balls to the respective planes with one via per ball. Using fewer vias to connect the package to the planes reduces the thermal performance. Thinner planes also reduce the thermal performance. When the clearance between the vias leave the planes virtually disconnected, the thermal performance is also greatly reduced.

As a general rule, the value obtained on a single-layer board is within the normal range for the tightly packed printed circuit board. The value obtained on a board with the internal planes is usually within the normal range if the application board has:

- One oz. (35 micron nominal thickness) internal planes
- Components are well separated
- Overall power dissipation on the board is less than 0.02 W/cm²

The thermal performance of any component depends on the power dissipation of the surrounding components. In addition, the ambient temperature varies widely within the application. For many natural convection and especially closed box applications, the board temperature at the perimeter (edge) of the package is approximately the same as the local air temperature near the device. Specifying the local ambient conditions explicitly as the board temperature provides a more precise description of the local ambient conditions that determine the temperature of the device.

At a known board temperature, the junction temperature is estimated using the following equation:

$$T_J = T_B + (R_{\theta JB} * P_D) \quad \text{Eqn. 2}$$

where:

T_B = board temperature for the package perimeter ($^{\circ}\text{C}$)

$R_{\theta JB}$ = junction-to-board thermal resistance ($^{\circ}\text{C}/\text{W}$) per JESD51-8S

P_D = power dissipation in the package (W)

When the heat loss from the package case to the air does not factor into the calculation, an acceptable value for the junction temperature is predictable. Ensure the application board is similar to the thermal test condition, with the component soldered to a board with internal planes.

The thermal resistance is expressed as the sum of a junction-to-case thermal resistance plus a case-to-ambient thermal resistance:

$$R_{\theta JA} = R_{\theta JC} + R_{\theta CA} \quad \text{Eqn. 3}$$

where:

$R_{\theta JA}$ = junction to ambient thermal resistance ($^{\circ}\text{C}/\text{W}$)

$R_{\theta JC}$ = junction to case thermal resistance ($^{\circ}\text{C}/\text{W}$)

$R_{\theta CA}$ = case to ambient thermal resistance ($^{\circ}\text{C}/\text{W}$)

$R_{\theta JC}$ is device related and is not affected by other factors. The thermal environment can be controlled to change the case-to-ambient thermal resistance, $R_{\theta CA}$. For example, change the air flow around the device, add a heat sink, change the mounting arrangement on the printed circuit board, or change the thermal dissipation on the printed circuit board surrounding the device. This description is most useful for packages with heat sinks where 90% of the heat flow is through the case to heat sink to ambient. For most packages, a better model is required.

A more accurate two-resistor thermal model can be constructed from the junction-to-board thermal resistance and the junction-to-case thermal resistance. The junction-to-case thermal resistance describes when using a heat sink or where a substantial amount of heat is dissipated from the top of the package. The junction-to-board thermal resistance describes the thermal performance when most of the heat is conducted to the printed circuit board. This model can be used to generate simple estimations and for computational fluid dynamics (CFD) thermal models.

To determine the junction temperature of the device in the application on a prototype board, use the thermal characterization parameter (Ψ_{JT}) to determine the junction temperature by measuring the temperature at the top center of the package case using the following equation:

$$T_J = T_T + (\Psi_{JT} * P_D) \quad \text{Eqn. 4}$$

where:

T_T = thermocouple temperature on top of the package ($^{\circ}\text{C}$)

Ψ_{JT} = thermal characterization parameter ($^{\circ}\text{C}/\text{W}$)

P_D = power dissipation in the package (W)

The thermal characterization parameter is measured in compliance with the JESD51-2 specification using a 40-gauge type T thermocouple epoxied to the top center of the package case. Position the thermocouple so that the thermocouple junction rests on the package. Place a small amount of epoxy on the thermocouple junction and approximately 1 mm of wire extending from the junction. Place the thermocouple wire flat against the package case to avoid measurement errors caused by the cooling effects of the thermocouple wire.

References:

Electrical characteristics

Semiconductor Equipment and Materials International
 805 East Middlefield Rd.
 Mountain View, CA 94043
 (415) 964-5111

MIL-SPEC and EIA/JESD (JEDEC) specifications are available from Global Engineering Documents at 800-854-7179 or 303-397-7956.

JEDEC specifications are available on the WEB at <http://www.jedec.org>.

4.6 EMI (electromagnetic interference) characteristics

Table 15. EMI testing specifications^{1 2}

| Symbol | Parameter | Conditions | Clocks | Frequency Range | Level (Typ) | Unit |
|--------------------|------------------|--|---|--------------------|-------------|------------|
| Radiated Emissions | V _{EME} | Device Configuration, test conditions and EM testing per standard IEC61967-2 | FOSC — 8 MHz, External Crystal FCPU —124 MHz FBUS —124 MHz No PLL Frequency Modulation | 150 kHz – 50 MHz | 19 | dB μ V |
| | | | | 50 MHz – 150 MHz | 30 | |
| | | | | 150 MHz – 500 MHz | 25 | |
| | | | | 500 MHz – 1000 MHz | 19 | |
| | | | | IEC Level | K | |
| | | | FOSC — 8 MHz, External Crystal FCPU —124 MHz FBUS —124 MHz 2% PLL Frequency Modulation | 150 kHz – 50 MHz | 15 | dB μ V |
| | | | | 50 MHz – 150 MHz | 24 | |
| | | | | 150 MHz – 500 MHz | 17 | |
| | | | | 500 MHz – 1000 MHz | 14 | |
| | | | | IEC Level | L | |

¹ The reported emission level is the value of the maximum emission, rounded up to the next whole number.

² IEC Level Maximum: L is less than or equal to 24 dB μ V, K is less than or equal to 30 dB μ V.

4.7 Power management

4.7.1 Voltage regulator electrical characteristics

The internal voltage regulator requires an external NPN (BCP68 or NJD2873) ballast to be connected as shown in Figure 8 s well as an external capacitance (C_{REG}) to be connected to the device in order to provide a stable low voltage digital supply to the device. Capacitances should be placed on the board as near as possible to the associated pins. Care should also be taken to limit the serial inductance of the board to less than 15 nH.

For the PxD20 microcontroller, 100 nF should be placed between each V_{DD12}/V_{SS12} supply pair and also between the V_{DDPLL}/V_{SSPLL} pair. Additionally, 10 μ F should be placed between the V_{DDR} pin and the adjacent V_{SS} pin.

$V_{DDR} = 3.0 \text{ V to } 3.6 \text{ V} / 4.5 \text{ V to } 5.5 \text{ V}$, $T_A = -40 \text{ to } 105 \text{ }^\circ\text{C}$, unless otherwise specified.

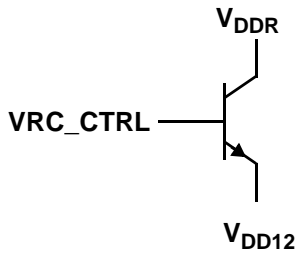


Figure 8. External NPN ballast connections

Table 16. Voltage regulator electrical characteristics

| Symbol | C | Parameter | Conditions | Min | Max | Unit | SpecID | | |
|------------|----|-----------|---|---|-----------------------|---|------------------|-------|------|
| V_{DDR} | SR | P | Power supply | — | 3.0 | 5.5 | V | D5.1 | |
| T_J | SR | D | Junction temperature | — | -40 | 140 | $^\circ\text{C}$ | D5.2 | |
| I_{REG} | CC | T | Current consumption | Reference included, @ 55 $^\circ\text{C}$ No load @ Full load | — | 2 11 | mA | D5.3 | |
| I_L | CC | T | Output current capacity | DC load current | — | 450 | mA | D5.4 | |
| V_{DD12} | CC | D | Output voltage (value @ $I_L = 0$ @ 27 $^\circ\text{C}$) | Pre-trimming sigma < 7 mV | — | 1.330 | V | D5.5 | |
| | | P | | Post-trimming | 1.26 | 1.29 | | | |
| | | T | Output voltage (value @ $I_L = I_{max}$) | Post-trimming | 1.145 | — | | | |
| | SR | D | External decoupling/stability capacitor | 4 capacitances of 10 μ F each | 10 x 4 | — | μ F | D5.6 | |
| | | | | ESR of external cap | 0.05 | 0.2 | ohm | | |
| | | | | 1 bond wire R + 1 pad R | 0.2 | 1 | ohm | | |
| L_{BOND} | CC | D | Bonding Inductance for Bipolar Base Control pad | | 0 | 15 | nH | D5.7 | |
| | CC | D | Power supply rejection | @ DC @ no load | Load = 10 μ F x 4 | — | -30 | dB | D5.8 |
| | | | | @ 200 kHz @ no load | | -100 | | | |
| | | | | @ DC @ 400 mA | | -30 | | | |
| | | | | @ 200 kHz @ 400 mA | | -30 | | | |
| | CC | D | Load current transient | Load = 10 μ F x 4 | — | 10% to 90% of I_L (max) in 100 ns | | D5.9 | |
| t_{SU} | CC | T | Start-up time after input supply stabilizes ¹ | Load = 10 μ F x 4 | — | 500 | μ s | D5.10 | |

Electrical characteristics

¹ Time after the input supply to the voltage regulator has ramped up (VDDR) and the voltage regulator has asserted the Power OK signal.

Table 17. Low-power voltage regulator electrical characteristics

| Symbol | | C | Parameter | Conditions | Min | Max | Unit | SpecID |
|------------|----|---|-------------------------|---|------|----------|------|--------|
| T_J | SR | D | Junction temperature | — | -40 | 140 | °C | D5.2 |
| I_{REG} | CC | T | Current consumption | Reference included, @ 55 °C No load @ Full load | — | 5 600 | µA | D5.3 |
| I_L | CC | T | Output current capacity | DC load current | — | 15 | mA | D5.4 |
| V_{DD12} | CC | D | Output voltage | Pre-trimming sigma < 7 mV | — | 1.33 | V | D5.5 |
| | | P | | Post-trimming | 1.14 | 1.32 | | |

Table 18. Ultra low-power voltage regulator electrical characteristics

| Symbol | | C | Parameter | Conditions | Min | Max | Unit | SpecID |
|------------|----|---|---|---|------|----------|------|--------|
| T_J | SR | D | Junction temperature | — | -40 | 140 | °C | D5.2 |
| I_{REG} | CC | T | Current consumption | Reference included, @ 55 °C No load @ Full load | — | 2 100 | µA | D5.3 |
| I_L | CC | T | Output current capacity | DC load current | — | 5 | mA | D5.4 |
| V_{DD12} | CC | D | Output voltage (value @ $I_L = 0$ @ 27°C) | Pre-trimming sigma < 7 mV | — | 1.33 | V | D5.5 |
| | | P | | Post-trimming | 1.14 | 1.32 | | |

4.7.2 Voltage monitor electrical characteristics

The device implements a Power On Reset module to ensure correct power-up initialization, as well as four low voltage detectors to monitor the V_{DD} and the V_{DD12} voltage while device is supplied:

- POR monitors V_{DD} during the power-up phase to ensure device is maintained in a safe reset state
- LVDHV3 monitors V_{DD} to ensure device reset below minimum functional supply
- LVDHV5 monitors V_{DD} when application uses device in the 5.0V ±10% range
- LVDLVCOR monitors power domain No. 1
- LVDLVBKP monitors power domain No. 0

Table 19. Low voltage monitor electrical characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID | |
|------------------------|----|-----------|--|--|-------|-----|-------|--------|-------|
| | | | | Min | Typ | Max | | | |
| V _{PORH} | CC | C | Power-on reset threshold | T _A = 25°C, after trimming | 1.5 | — | 2.7 | V | D5.11 |
| V _{LVDHV3H} | CC | C | LVDHV3 low voltage detector high threshold | | — | — | 2.8 | | D5.12 |
| V _{LVDHV3L} | CC | C | LVDHV3 low voltage detector low threshold | | 2.7 | — | — | | D5.13 |
| V _{LVDHV5H} | CC | C | LVDHV5 low voltage detector high threshold | | — | — | 4.37 | | D5.14 |
| V _{LVDHV5L} | CC | C | LVDHV5 low voltage detector low threshold | | 4.2 | — | — | | D5.15 |
| V _{LVDLVCORH} | CC | C | LVDLVCOR low voltage detector high threshold | | — | — | 1.185 | | D5.16 |
| V _{LVDLVCORL} | CC | C | LVDLVCOR low voltage detector low threshold | | 1.095 | — | — | | D5.17 |

¹ V_{DD} = 3.3V ±10% / 5.0V ± 10%, T_A = -40 to 105°C, unless otherwise specified.

² All values need to be confirmed during device validation.

4.7.3 Low voltage domain power consumption

Table 20 provides DC electrical characteristics for significant application modes. These values are indicative values; actual consumption depends on the application.

Table 20. DC electrical characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | |
|---------------------------------|----|-----------|--|-------------------------|-----|-------|---------------------|----|
| | | | | Min | Typ | Max | | |
| I _{DDMAX} ² | CC | D | RUN mode maximum average current | — | — | 250 | 276.63 ³ | mA |
| I _{DDRUN} ⁴ | CC | P | RUN mode typical average current ⁵ f _{CPU} = 125 MHz, Dual Display Drive with external DRAM, 416 TEPBGA package option only | — | — | 275 | — | mA |
| | | | | — | — | 240 | — | |
| I _{DDHALT} | CC | C | HALT mode current ⁶ Slow internal RC oscillator (128 kHz) running | T _A = 25 °C | — | 17.5 | 21.5 | mA |
| | | | | T _B = 105 °C | — | 35 | 43.5 | |
| I _{DDSTOP} | CC | D | STOP mode current ⁷ Slow internal RC oscillator (128 kHz) running | T _A = -40°C | — | 645 | — | μA |
| | | | | T _A = 0°C | — | 1100 | — | |
| | | | | T _A = 25°C | — | 1531 | 1615 | |
| | | | | T _A = 55°C | — | 3.8 | — | mA |
| | | | | T _A = 85°C | — | 9.7 | — | |
| | | | | T _A = 105°C | — | 17.67 | 18.46 | |

Table 20. DC electrical characteristics (continued)

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | | |
|-----------------------|----|-----------|--|---|------------------------|-----|------|-----|----|
| | | | | Min | Typ | Max | | | |
| I _{DDSTDBY2} | CC | D | STANDBY2 mode current ⁸ (64K SRAM on) | SXOSC (32 KHz ⁹) ON and RTC running | T _A = -40°C | — | 470 | — | μA |
| | | | | | T _A = 0°C | — | 480 | — | |
| | | | | | T _A = 25°C | — | 481 | 490 | |
| | | | | | T _A = 55°C | — | 525 | — | |
| | | | | | T _A = 85°C | — | 650 | — | |
| | | | | | T _A = 105°C | — | 870 | 910 | |
| | CC | D | SXOSC (32 KHz) and RTC OFF | T _A = -40°C | | 63 | — | μA | |
| | | | | T _A = 0°C | | 85 | — | | |
| | | | | T _A = 25°C | | 93 | 100 | | |
| | | | | T _A = 55°C | | 95 | — | | |
| | | | | T _A = 85°C | | 190 | — | | |
| | | | | T _A = 105°C | | 390 | 430 | | |
| I _{DDSTDBY1} | CC | D | STANDBY1 mode current (8K SRAM on) ¹⁰ | SXOSC (32KHz) ON and RTC running | T _A = -40°C | — | 415 | — | μA |
| | | | | | T _A = 0°C | — | 422 | — | |
| | | | | | T _A = 25°C | — | 426 | 430 | |
| | | | | | T _A = 55°C | — | 575 | — | |
| | | | | | T _A = 85°C | — | 680 | — | |
| | | | | | T _A = 105°C | — | 810 | 915 | |
| | CC | D | SXOSC (32 KHz) and RTC OFF | T _A = -40°C | | 20 | — | μA | |
| | | | | T _A = 0°C | | 22 | — | | |
| | | | | T _A = 25°C | | 29 | 45 | | |
| | | | | T _A = 55°C | | 47 | — | | |
| | | | | T _A = 85°C | | 118 | — | | |
| | | | | T _A = 105°C | | 236 | 310 | | |

¹ V_{DD} = 3.0 V to 5.5 V, T_A = -40 to 105 °C, unless otherwise specified.

² I_{DDMAX} is composed of the current consumption on all supplies (V_{DD12}, V_{DDE_A}, V_{DDE_B}, V_{DDA}, V_{DDR}, V_{DDM}, V_{DDPLL}, and V_{DD_DR}). It does not include current consumption linked to I/Os toggling which is highly dependent on the application. The given value is thought to be a worst case value with all peripherals running, and code fetched from code flash while modify operation on-going on data flash. It is to be noticed that this value can be significantly reduced by application; switch-off not used peripherals (default), reduce peripheral frequency through internal prescaler, fetch from RAM most used functions, use low power mode when possible.

³ Higher current may be sinked by device during power-up and standby exit. Please refer to inrush current in Table 21.

⁴ RUN current measured with typical application and accesses on both flash and RAM.

⁵ Data and Code Flash in Normal Power. Code fetched from RAM: DCUs running with 20MHz pixel clock, QuadSPI fetching data at 80MHz, GPU accessing internal SRAM and external DRAM, DMA, RLE, and VIU active, Serial IPs CAN and LIN in loop back mode, DSPI as Master, PLL as system Clock (4 x Multiplier) peripherals on (eMIOS/ADC/SMD/SSD/SGM) and running at max frequency, periodic SW/WDG timer reset enabled.

- ⁶ Flash in Low Power. RCOSC 128 kHz and RCOSC 16 MHz ON. 10 MHz XTAL clock. FlexCAN: instances: 0, 1 ON (clocked but no reception or transmission), LINFLEX: instances 0, 1, 2 ON (clocked but no reception or transmission). eMIOS: instance: 0, 1 ON - 16 channels on with PWM20K Hz. DSPI: instance: 0 (clocked but no communication). DCUs, TCON, VIU, GPU clock gated, RTC/API ON. PIT ON. STM ON. ADC ON but not converting.
- ⁷ No clock, RC 16MHz off, RCI 128 kHz on, PLL off, HPvreg off, ULPVreg/LPVreg on. All possible peripherals off and clock gated. Flash in power down mode.
- ⁸ ULPreg ON, HP/LPVreg off, 64 KB RAM on, device configured for minimum consumption, all possible modules switched off.
- ⁹ 32 KHz oscillator operates at 32,768 Hz.
- ¹⁰ ULPreg ON, HP/LPVreg off, 8 KB RAM on, device configured for minimum consumption, all possible modules switched off.

4.8 DC electrical specifications

4.8.1 DC specification for CMOS090LP2 library @ VDDE = 3.3 V

NOTE

These pad specifications are applicable for pads in the Digital segment Only. See the “GPIO power bank supplies and functionality” table in the “Voltage Regulators and Power Supplies” chapter of the reference manual for details.

Table 21. DC electrical specifications

| Symbol | C | Parameter | Condition | Value | | Unit | SpecID | |
|-----------|----|-----------|---|--------------------------|------------------------|------------------------|---------------|-------|
| | | | | Min | Max | | | |
| Vdd | SR | P | Core supply voltage | — | 1.08 | 1.47 | V | D9.1 |
| Vdde | SR | P | I/O supply voltage | — | 3.0 | 3.6 | V | D9.2 |
| Vdd33 | SR | P | I/O pre-driver supply voltage | — | 3.0 | 3.6 | V | D9.3 |
| Vih_c | SR | P | CMOS input buffer high voltage | With hysteresis enabled | $0.65 \times V_{dde}$ | $V_{dde} + 0.3$ | V | D9.4 |
| | | | | With hysteresis disabled | $0.55 \times V_{dde}$ | $V_{dde} + 0.3$ | | |
| Vil_c | SR | P | CMOS input buffer low voltage | With hysteresis enabled | $V_{ss} - 0.3$ | $0.35 \times V_{dde}$ | V | D9.5 |
| | | | | With hysteresis disabled | $V_{ss} - 0.3$ | $0.40 \times V_{dde}$ | | |
| Vhys_c | SR | T | CMOS input buffer hysteresis | — | $0.1 \times V_{dde}$ | — | V | D9.6 |
| Vih_fod_h | SR | P | 5 V tolerant CMOS input buffer high voltage | With hysteresis enabled | $0.65 \times V_{dd33}$ | $V_{dd33} + 0.3$ | V | D9.7 |
| Vil_fod_h | SR | P | 5 V tolerant CMOS input buffer low voltage | With hysteresis enabled | $V_{ss} - 0.3$ | $0.35 \times V_{dd33}$ | V | D9.8 |
| lact_s | SR | T | Selectable weak pullup/pulldown current | — | 25 | 150 | μA | D9.9 |
| linact_d | SR | P | Digital pad input leakage current | Weak pull inactive | -2.5 | 2.5 | μA | D9.10 |
| linact_a | SR | P | Analog pad input leakage current | Weak pull inactive | -150 | 150 | μA | D9.11 |
| Voh | SR | P | Output high voltage | — | $0.8 \times V_{dde}$ | — | V | D9.12 |

Table 21. DC electrical specifications (continued)

| Symbol | C | Parameter | Condition | Value | | Unit | SpecID |
|-----------|----|-----------|------------------------------------|-------------------|-------------|------|--------|
| | | | | Min | Max | | |
| Vol | SR | P | Output low voltage | — | 0.2 × Vdde | V | D9.13 |
| Voh_pci | SR | P | PCI output high voltage | — | 0.9 × Vdde | V | D9.14 |
| Vol_pci | SR | P | PCI output low voltage | — | 0.1 × Vdde | V | D9.15 |
| Vol_fod_h | SR | P | Fast open-drain output low voltage | Iol_fod_h = 10 mA | 0.2 × Vdd33 | | D9.16 |

Table 22. Drive current, VDDE=3.3 V (±10%)

| Pad | C | Drive mode | Minimum Ioh (mA) ¹ | Minimum Iol (mA) ² |
|---------|---|------------|-------------------------------|-------------------------------|
| pad_fc | C | 00 | 16.1 | 24 |
| | | 01 | 31.8 | 47.9 |
| | | 10 | 47.2 | 70.6 |
| | | 11 | 77 | 114.5 |
| pad_msr | P | All | 61.9 | 83.6 |
| pad_ssr | P | All | 61.9 | 83.6 |

¹ Ioh is defined as the current sourced by the pad to drive the output to Voh.

² Iol is defined as the current sunk by the pad to drive the output to Vol.

Table 23. Supply leakage

| Pad | C | VDD | VDDE (Typ/Max) | VDD33 (Typ/Max) |
|---------|---|-------|----------------|-----------------|
| pad_fc | D | 90 μA | 3 nA / 4 μA | 1 nA / 30 μA |
| pad_msr | | — | — | — |
| pad_ssr | | — | — | — |

4.8.2 DC specification for CMOS090LP2fg library @ VDDE = 5.0 V

NOTE

These pad specifications are applicable for pads in the Analog segment Only. See the “GPIO power bank supplies and functionality” table in the “Voltage Regulators and Power Supplies” chapter of the reference manual for details.

Table 24. DC electrical specifications

| Symbol | C | Parameter | Condition | Value | | Unit | SpecID | |
|--------------|----|-----------|--|--------------------------|-----------------------|-----------------------|---------------|-------|
| | | | | Min | Max | | | |
| Vdd | SR | P | Core supply voltage | — | 1.08 | 1.32 | V | D9.17 |
| Vdde | SR | P | I/O supply voltage | — | 4.5 | 5.5 | V | D9.18 |
| Vdd33 | SR | P | I/O pre-driver supply voltage | — | 3.0 | 3.6 | V | D9.19 |
| Vih_hys | SR | P | CMOS input buffer high voltage | With hysteresis enabled | $0.65 \times V_{dde}$ | $V_{dde} + 0.3$ | V | D9.20 |
| Vil_hys | SR | P | CMOS input buffer low voltage | With hysteresis enabled | $V_{ss} - 0.3$ | $0.35 \times V_{dde}$ | V | D9.21 |
| Vih | SR | P | CMOS input buffer high voltage | With hysteresis disabled | $0.55 \times V_{dde}$ | $V_{dde} + 0.3$ | V | D9.22 |
| Vil | SR | P | CMOS input buffer low voltage | With hysteresis disabled | $V_{ss} - 0.3$ | $0.40 \times V_{dde}$ | V | D9.23 |
| Vhys | SR | T | CMOS input buffer hysteresis | — | $0.1 \times V_{dde}$ | — | V | D9.24 |
| Pull_loh | SR | P | Weak pullup current | — | 35 | 135 | μA | D9.25 |
| Pull_lol | SR | P | Weak pulldown current | — | 35 | 200 | μA | D9.26 |
| linact_d | SR | P | Digital pad input leakage current | Weak pull inactive | -2.5 | 2.5 | μA | D9.27 |
| linact_a | SR | P | Analog pad input leakage current | Weak pull inactive | -150 | 150 | μA | D9.28 |
| Voh | SR | P | Slew rate controlled output high voltage | — | $0.8 \times V_{dde}$ | — | V | D9.29 |
| Vol | SR | P | Slew rate controlled output low voltage | — | — | $0.2 \times V_{dde}$ | V | D9.30 |
| Voh_ls | SR | P | Low swing output pad output high voltage | — | 2.64 | — | V | D9.31 |
| loh_msr | SR | C | pad_msr_hv loh | — | 11.6 | 40.7 | mA | D9.32 |
| lol_msr | SR | C | pad_msr_hv lol | — | 17.7 | 68.2 | mA | D9.33 |
| loh_ssr | SR | C | pad_ssr_hv loh | — | 6.0 | 21.3 | mA | D9.34 |
| lol_ssr | SR | C | pad_ssr_hv lol | — | 9.2 | 36.3 | mA | D9.35 |
| loh_multv_hs | SR | C | pad_multv_hv loh | High swing mode | 10 | 40 | mA | D9.36 |
| loh_multv_ls | SR | C | pad_multv_hv loh | Low swing mode | TBD | TBD | mA | D9.37 |
| lol_multv | SR | C | pad_multv_hv lol | High/low swing mode | 12 | 56 | mA | D9.38 |

Electrical characteristics
Table 24. DC electrical specifications (continued)

| Symbol | | C | Parameter | Condition | Value | | Unit | SpecID |
|-----------|----|---|---------------------------------|-----------|-------|-------|------|--------|
| | | | | | Min | Max | | |
| Rtgate | SR | D | Pad_tgate_hv input resistance | — | 250 | 800 | Ω | D9.39 |
| pupd_rm | SR | D | pad_pupd_hv resistance mismatch | — | — | 5 | % | D9.40 |
| pupd_leak | SR | D | pad_pupd_hv leakage current | — | 0.1 | 75000 | pA | D9.41 |
| pupd200k | SR | D | pad_pupd_hv 200 kΩ resistance | — | 130 | 280 | kΩ | D9.42 |
| pupd100k | SR | D | pad_pupd_hv 100 kΩ resistance | — | 65 | 140 | kΩ | D9.43 |
| pupd5k | SR | D | pad_pupd_hv 5 kΩ resistance | — | 1.4 | 5.2 | kΩ | D9.44 |

Table 25. DC electrical specifications

| Symbol | | Parameter | Condition | Value | | Unit | SpecID |
|----------|----|--|--------------------------|-----------------------|-----------------------|------|--------|
| | | | | Min | Max | | |
| Vdd | SR | Core supply voltage | — | 1.08 | 1.32 | V | D9.45 |
| Vdde | SR | I/O supply voltage | — | 3.0 | 3.6 | V | D9.46 |
| Vdd33 | SR | I/O pre-driver supply voltage | — | 3.0 | 3.6 | V | D9.47 |
| Vih_hys | SR | CMOS input buffer high voltage | With hysteresis enabled | $0.65 \times V_{dde}$ | $V_{dde} + 0.3$ | V | D9.48 |
| Vil_hys | SR | CMOS input buffer low voltage | With hysteresis enabled | $V_{ss} - 0.3$ | $0.35 \times V_{dde}$ | V | D9.49 |
| Vih | SR | CMOS input buffer high voltage | With hysteresis disabled | $0.55 \times V_{dde}$ | $V_{dde} + 0.3$ | V | D9.50 |
| Vil | SR | CMOS input buffer low voltage | With hysteresis disabled | $V_{ss} - 0.3$ | $0.40 \times V_{dde}$ | V | D9.51 |
| Vhys | SR | CMOS input buffer hysteresis | — | $0.1 \times V_{dde}$ | — | V | D9.52 |
| Pull_loh | SR | Weak pullup current | — | 15 | 70 | μA | D9.53 |
| Pull_lol | SR | Weak pulldown current | — | 15 | 95 | μA | D9.54 |
| Iinact_d | SR | Digital pad input leakage current | Weak pull inactive | -2.5 | 2.5 | μA | D9.55 |
| Iinact_a | SR | Analog pad input leakage current | Weak pull inactive | -150 | 150 | μA | D9.56 |
| Voh | SR | Slew rate controlled output high voltage | — | $0.8 \times V_{dde}$ | — | V | D9.57 |
| Vol | SR | Slew rate controlled output low voltage | — | — | $0.2 \times V_{dde}$ | V | D9.58 |

Table 25. DC electrical specifications (continued)

| Symbol | | Parameter | Condition | Value | | Unit | SpecID |
|------------------|----|---------------------------------------|---------------------|-------|-------|------------|--------|
| | | | | Min | Max | | |
| loh_msr | SR | pad_msr_hv loh | — | 5.4 | 21 | mA | D9.59 |
| lol_msr | SR | pad_msr_hv lol | — | 8.1 | 38.6 | mA | D9.60 |
| loh_ssr | SR | pad_ssr_hv loh | — | 2.8 | 11.2 | mA | D9.61 |
| lol_ssr | SR | pad_ssr_hv lol | — | 4.2 | 20.6 | mA | D9.62 |
| loh_multv_h s | SR | pad_multv_hv loh | High swing mode | — | TBD | mA | D9.63 |
| lol_multv | SR | pad_multv_hv lol | High/low swing mode | — | TBD | mA | D9.64 |
| Rtgate | SR | Pad_tgate_hv input resistance | — | 325 | 1250 | Ω | D9.65 |
| pupd_rm | SR | pad_pupd_hv resistance mismatch | — | — | 5 | % | D9.66 |
| pupd_leak | SR | pad_pupd_hv leakage current | — | 0.1 | 75000 | pA | D9.67 |
| pupd200k | SR | pad_pupd_hv 200 k Ω resistance | — | 130 | 280 | k Ω | D9.68 |
| pupd100k | SR | pad_pupd_hv 100 k Ω resistance | — | 65 | 140 | k Ω | D9.69 |
| pupd5k | SR | pad_pupd_hv 5 k Ω resistance | — | 1.7 | 7.7 | k Ω | D9.70 |

Table 26. Supply leakage

| Pad | VDD | | VDDE | | VDD33 | |
|---------------------------|----------|---------|----------|---------|-------|-----|
| | Typ | Max | Typ | Max | Typ | Max |
| pad_msr_hv | 0.818 nA | 83.7 nA | 0.81 nA | 118 nA | — | — |
| pad_ssr_hv | 0.818 nA | 83.7 nA | 0.858 nA | 88.7 nA | — | — |
| pad_i_hv | 0.307 nA | 48.4 nA | 88.2 pA | 30 nA | — | — |
| biasref_hv | — | — | — | — | — | — |
| core_v_det_hv | 0 | 0 | — | — | 0 | 0 |
| core_v_det_lp_hv | 0 | 0 | — | — | — | — |
| corner_esdpadcell_hv | — | — | — | — | — | — |
| corner_esdpadcell_id00_hv | — | — | — | — | — | — |
| corner_esdpadcell_id11_hv | — | — | — | — | — | — |
| corner_esdpadcell_lp_hv | — | — | — | — | — | — |
| esd_term_35_84_hv | — | — | — | — | — | — |
| pad_9v_hv | 0 | 0 | — | — | — | — |
| pad_ae_hv | — | — | — | — | — | — |

Table 26. Supply leakage (continued)

| Pad | VDD | | VDDE | | VDD33 | |
|------------------|-----|-----|------|-----|-------|-----|
| | Typ | Max | Typ | Max | Typ | Max |
| pad_esdspacer_hv | — | — | — | — | — | — |
| pad_tgate_hv | — | — | — | — | — | — |
| pad_vdd33_hv | — | — | — | — | — | — |
| pad_vdde_hv | 0 | 0 | — | — | 0 | 0 |
| pad_vddint3v_hv | 0 | 0 | — | — | 0 | 0 |
| pad_vddint_hv | 0 | 0 | — | — | — | — |
| pad_vss_hv | 0 | 0 | — | — | — | — |
| pad_vsse_hv | 0 | 0 | — | — | — | — |
| pad_vssint3v_hv | 0 | 0 | — | — | — | — |
| pad_vssint_hv | 0 | 0 | — | — | — | — |
| spr_17_82_hv | — | — | — | — | — | — |
| spr_35_84_hv | — | — | — | — | — | — |
| spr_71_88_hv | — | — | — | — | — | — |
| spr_143_38_hv | — | — | — | — | — | — |
| spr_vdde_lvl_hv | — | — | — | — | — | — |

Table 27. AVG IDDE specifications

| Cell | Period (ns) | Load (pF) ¹ | VDDE (V) | Drive/slew select | IDDE (mA) |
|-------------------------|-------------|------------------------|----------|-------------------|-----------|
| pad_msr_hv ² | 24 | 50 | 5.5 | 11 | 14 |
| | 62 | 50 | 5.5 | 01 | 5.3 |
| | 317 | 50 | 5.5 | 00 | 1.1 |
| | 425 | 200 | 5.5 | 00 | 3 |
| pad_ssr_hv ² | 37 | 50 | 5.5 | 11 | 9 |
| | 130 | 50 | 5.5 | 01 | 2.5 |
| | 650 | 50 | 5.5 | 00 | 0.5 |
| | 840 | 200 | 5.5 | 00 | 1.5 |

¹ All loads are lumped loads.

² Average current is for pad configured as output only. Use pad_i current for input.

4.8.3 DC specification for CMOS090_ddd library @ VDDE = 3.3 V

Table 28. DC electrical specifications at 3.3 V VDDE

| Symbol | | Parameter | Value | | Unit | SpecID |
|--------|----|-------------------------------|------------------|------------------|------|--------|
| | | | Min | Max | | |
| Vdd | SR | Core supply voltage | 1.08 | 1.32 | V | D9.71 |
| | | | 1.08 | 1.47 | | |
| Vdde | SR | I/O supply voltage | 3.0 | 3.6 | V | D9.72 |
| Vdd33 | SR | I/O pre-driver supply voltage | 3.0 | 3.6 | V | D9.73 |
| Vref | SR | Input reference voltage | 1.3 | 1.7 | V | D9.74 |
| Vtt | SR | Termination voltage | $V_{ref} - 0.05$ | $V_{ref} + 0.05$ | V | D9.75 |
| Vih | SR | Input high voltage | $V_{ref} + 0.20$ | — | V | D9.76 |
| Vil | SR | Input low voltage | — | $V_{ref} - 0.2$ | V | D9.77 |
| Voh | SR | Output high voltage | $V_{tt} + 0.8$ | — | V | D9.78 |
| Vol | SR | Output low voltage | — | $V_{tt} - 0.8$ | V | D9.79 |

Table 29. Output drive current @ VDDE = 3.3 V ($\pm 10\%$)

| Pad | C | Drive mode | Minimum loh (mA) | Minimum lol (mA) |
|------------|---|------------|------------------|------------------|
| pad_st_acc | P | 111 | -16 | 16 |
| pad_st_dq | P | 111 | -16 | 16 |
| pad_st_clk | P | 111 | -16 | 16 |
| pad_st | P | 111 | -16 | 16 |
| pad_st_odt | P | 111 | -16 | 16 |
| pad_st_ck | P | 111 | -16 | 16 |

4.8.4 DC specification for CMOS090_ddd library @ VDDE = 2.5 V

Table 30. DC electrical specifications at 2.5 V VDDE

| Symbol | | C | Parameter | Value | | Unit | SpecID |
|--------|----|---|-------------------------------|-----------------------|-----------------------|------|--------|
| | | | | Min | Max | | |
| Vdd | SR | P | Core supply voltage | 1.08 | 1.32 | V | D9.80 |
| | | | | 1.08 | 1.47 | | |
| Vdde | SR | P | I/O supply voltage | 2.3 | 2.7 | V | D9.81 |
| Vdd33 | SR | P | I/O pre-driver supply voltage | 3.0 | 3.6 | V | D9.82 |
| Vref | SR | P | Input reference voltage | $0.49 \times V_{dde}$ | $0.51 \times V_{dde}$ | V | D9.83 |
| Vtt | SR | P | Termination voltage | $V_{ref} - 0.04$ | $V_{ref} + 0.04$ | V | D9.84 |

Table 30. DC electrical specifications at 2.5 V VDDE (continued)

| Symbol | C | Parameter | Value | | Unit | SpecID | |
|--------|----|-----------|---------------------|-------------|-------------|--------|-------|
| | | | Min | Max | | | |
| Vih | SR | P | Input high voltage | Vref + 0.15 | — | V | D9.85 |
| Vil | SR | P | Input low voltage | — | Vref – 0.15 | V | D9.86 |
| Voh | SR | P | Output high voltage | Vtt + 0.81 | — | V | D9.87 |
| Vol | SR | P | Output low voltage | — | Vtt – 0.81 | V | D9.88 |

Table 31. Output drive current @ VDDE = 2.5 V (±200mV)

| Pad | C | Drive mode | Minimum Ioh (mA) | Minimum Iol (mA) | Libraries |
|------------|---|------------|------------------|------------------|-----------|
| pad_st_acc | P | 011 | –16.2 | 16.2 | 6MDDR |
| pad_st_dq | P | 011 | –16.2 | 16.2 | 6MDDR |
| pad_st_ck | P | 011 | –16.2 | 16.2 | 6MDDR |

4.8.5 DC specification for CMOS090_ ddr library @ VDDE = 1.8 V

Table 32. DC electrical specifications for 1.8 V VDDE

| Symbol | C | Parameter | Value | | Unit | SpecID | |
|--------|----|-----------|-------------------------------|--------------|--------------|--------|-------|
| | | | Min | Max | | | |
| Vdd | SR | P | Core supply voltage | 1.08 | 1.32 | V | D9.89 |
| | | | | 1.08 | 1.47 | | |
| Vdde | SR | P | I/O supply voltage | 1.7 | 1.9 | V | D9.90 |
| Vdd33 | SR | P | I/O pre-driver supply voltage | 3.0 | 3.6 | V | D9.91 |
| Vref | SR | P | Input reference voltage | 0.49 × Vdde | 0.51 × Vdde | V | D9.92 |
| Vtt | SR | P | Termination voltage | Vref – 0.04 | Vref + 0.04 | V | D9.93 |
| Vih | SR | P | Input high voltage | Vref + 0.125 | — | V | D9.94 |
| Vil | SR | P | Input low voltage | — | Vref – 0.125 | V | D9.95 |
| Voh | SR | P | Output high voltage | Vtt + 0.81 | — | V | D9.96 |
| Vol | SR | P | Output low voltage | — | Vtt – 0.81 | V | D9.97 |

Table 33. Output drive current @ VDDE = 1.8 V (±100mV)

| Pad | C | Drive mode | Minimum Ioh (mA) | Minimum Iol (mA) | Libraries |
|------------|---|------------|------------------|------------------|-----------|
| pad_st_acc | P | 000 | –3.57 | 3.57 | 6MDDR |
| | | 001 | –7.84 | 7.84 | |
| | | 010 | –5.36 | 5.36 | |
| | | 110 | –13.4 | 13.4 | |

Table 33. Output drive current @ VDDE = 1.8 V (± 100 mV) (continued)

| Pad | | Drive mode | Minimum Ioh (mA) | Minimum Iol (mA) | Libraries |
|------------|---|------------|------------------|------------------|-----------|
| pad_st_dq | P | 000 | -3.57 | 3.57 | 6MDDR |
| | | 001 | -7.84 | 7.84 | |
| | | 010 | -5.36 | 5.36 | |
| | | 110 | -13.4 | 13.4 | |
| pad_st_clk | P | 000 | -3.57 | 3.57 | 6MDDR |
| | | 001 | -7.84 | 7.84 | |
| | | 010 | -5.36 | 5.36 | |
| | | 110 | -13.4 | 13.4 | |

Table 34. ODT DC electrical characteristics

| Symbol | C | Parameter | Condition | Value | | | Unit | SpecID | |
|--------|----|-----------|---------------------------|--|-----|-----|------|----------|-------|
| | | | | Min | Typ | Max | | | |
| Rtt | SR | C | Effective impedance value | PXD20 supports only 150 ohm termination and that can be enabled by enabling any bit of the termination control register (all of them are OR'ed). | 120 | 150 | 180 | Ω | D9.98 |

Table 35. core_v_det_odt and core_v_det33_odt specifications

| VDDE | C | VDD | Vtrip max (V) | Vtrip min | Hysteresis min (V) |
|--------|---|---------|---------------|-----------|--------------------|
| 3.5 | C | Rising | 0.79 | 0.44 | 0.07 |
| | C | Falling | 0.56 | 0 | |
| 1.62 | C | Rising | 0.65 | 0.3 | 0.16 |
| | C | Falling | 0.33 | 0 | |
| Rising | C | 0.0 | 1.40 | 0.3 | — |

4.9 $\overline{\text{RESET}}$ electrical characteristics

The device implements a dedicated bidirectional RESET pin.

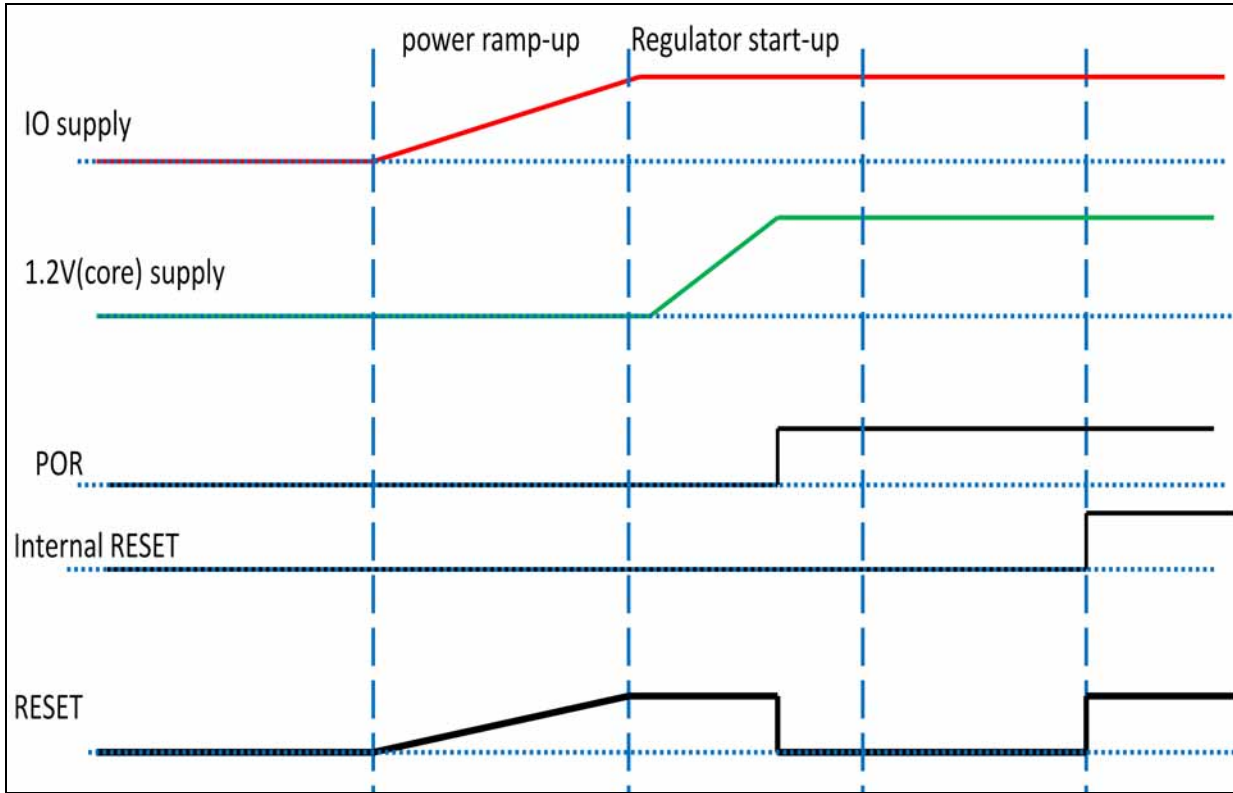


Figure 9. Start-up reset requirements

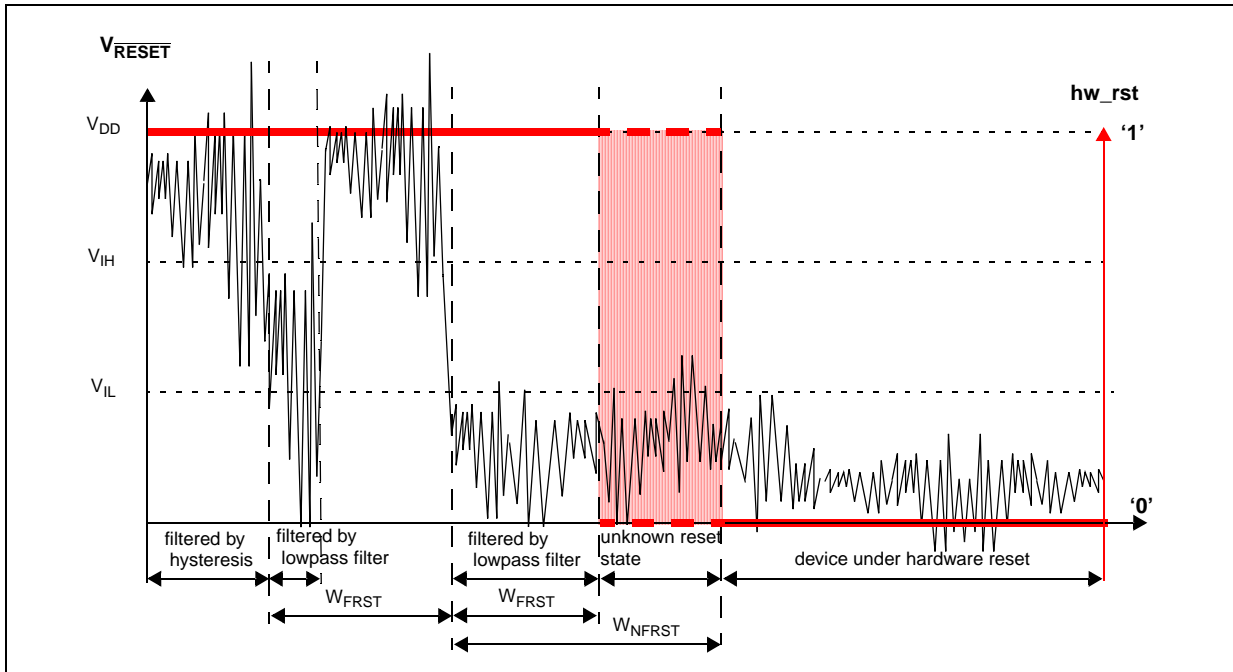


Figure 10. Noise filtering on reset signal

Table 36. Reset electrical characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID | |
|--------------------|-----------------|-----------|---|---|-----|---------------------|---------------------|--------|------|
| | | | | Min | Typ | Max | | | |
| V _{IH} | SR | P | Input High Level CMOS Schmitt Trigger | — | — | — | V | D8.1 | |
| V _{IL} | SR | P | Input low Level CMOS Schmitt Trigger | — | — | — | V | D8.2 | |
| V _{HYS} | CC ³ | D | Input hysteresis CMOS Schmitt Trigger | — | — | — | V | D8.3 | |
| V _{OL} | CC ⁴ | P | Output low level | Push Pull, I _{OL} = 2mA, V _{DD} = 5.0V ± 10%, ipp_hve = 0 (recommended) | — | — | 0.1 V _{DD} | V | D8.4 |
| | | D | Push Pull, I _{OL} = 1mA, V _{DD} = 5.0V ± 10%, ipp_hve = 1 ⁵ | — | — | 0.1 V _{DD} | | | |
| | | C | Push Pull, I _{OL} = 1mA, V _{DD} = 3.3V ± 10%, ipp_hve = 1 (recommended) | — | — | 0.5 | | | |
| T _{tr} | CC ⁴ | T | Output transition time output pin ⁶ MEDIUM configuration | C _L = 25pF, V _{DD} = 5.0V ± 10%, ipp_hve = 0 | — | — | 10 | ns | D8.5 |
| | | | | C _L = 50pF, V _{DD} = 5.0V ± 10%, ipp_hve = 0 | — | — | 20 | | |
| | | | | C _L = 100pF, V _{DD} = 5.0V ± 10%, ipp_hve = 0 | — | — | 40 | | |
| | | | | C _L = 25pF, V _{DD} = 3.3V ± 10%, ipp_hve = 1 | — | — | 12 | | |
| | | | | C _L = 50pF, V _{DD} = 3.3V ± 10%, ipp_hve = 1 | — | — | 25 | | |
| | | | | C _L = 100pF, V _{DD} = 3.3V ± 10%, ipp_hve = 1 | — | — | 40 | | |
| W _{FRST} | SR | P | RESET Input Filtered Pulse | — | — | 70 | ns | D8.6 | |
| W _{NFRST} | SR | P | RESET Input Not Filtered Pulse | — | — | 400 | ns | D8.7 | |
| I _{WPUL} | CC ⁴ | P | Weak pullup current absolute value | — | — | 10 | μA | D8.8 | |

¹ V_{DD} = 3.3V ± 10% / 5.0V ± 10%, T_A = -40 to +105°C, unless otherwise specified

² All values need to be confirmed during device validation.

³ Data based on characterization results, not tested in production

⁴ Guaranteed by design simulation.

⁵ This is a transient configuration during power-up, up to the end of reset PHASE2 (refer to RGM module section of the reference manual).

⁶ C_L calculation should include device and package capacitance (C_{PKG} < 5pF).

4.10 Fast external crystal oscillator (4–16 MHz) electrical characteristics

This device implements the fast external oscillator (FXOSC) using a low power Loop Controlled Pierce Oscillator (LCP) configuration.

Table 37. Fast external crystal oscillator electrical characteristics

| Symbol | | Parameter | Conditions | Value | | | Unit | SpecID |
|-----------------|---|---|------------------------|-------------------------|----------------|-------------------------|---------|--------|
| | | | | Min | Typ | Max | | |
| f_{OSC} | C | Crystal oscillator range | Loop controlled Pierce | 4.0 | — | 16 | MHz | O9.1 |
| i_{OSC} | P | Startup current | — | 100 | — | — | μ A | O9.2 |
| t_{UPOSC} | C | Oscillator start-up time | Loop controlled Pierce | — | 4 ¹ | 50 ² | ms | O9.3 |
| t_{CQOUT} | D | Clock quality check time-out | — | 0.45 | — | 2.5 | s | O9.4 |
| f_{CMFA} | D | Clock monitor failure assert frequency | — | 200 | 400 | 800 | kHz | O9.5 |
| f_{EXT} | D | External square wave input frequency ² | — | 2.0 | — | 50 | MHz | O9.6 |
| t_{EXTL} | D | External square wave pulse width low | — | 9.5 | — | — | ns | O9.7 |
| t_{EXTH} | D | External square wave pulse width high | — | 9.5 | — | — | ns | O9.8 |
| t_{EXTR} | D | External square wave rise time | — | — | — | 1 | ns | O9.9 |
| t_{EXTF} | D | External square wave fall time | — | — | — | 1 | ns | O9.10 |
| C_{IN} | D | Input capacitance | EXTAL and XTAL pins | — | 7 | — | pF | O9.11 |
| $V_{IH,EXTAL}$ | P | EXTAL pin input high voltage ² | — | $0.75 \times V_{DDPLL}$ | — | — | V | O9.12 |
| | T | | | — | — | $V_{DDPLL} + 0.3$ | | |
| $V_{IL,EXTAL}$ | P | EXTAL pin input low voltage ² | — | — | — | $0.25 \times V_{DDPLL}$ | V | O9.13 |
| | T | | | $V_{SSPLL} - 0.3$ | — | — | | |
| $V_{HYS,EXTAL}$ | C | EXTAL pin input hysteresis ² | — | — | 180 | — | mV | O9.14 |
| $V_{PP,EXTAL}$ | C | EXTAL pin oscillation amplitude | Loop controlled Pierce | — | 1.0 | — | V | O9.15 |

¹ $f_{OSC} = 4$ MHz, $C = 22$ pF

² Maximum value is for extreme cases using high Q, low frequency crystals

4.11 Slow external crystal oscillator (32 KHz) electrical characteristics

The device provides a slow external oscillator/resonator driver (SXOSC). The 32 KHz oscillator operates at 32,768 Hz.

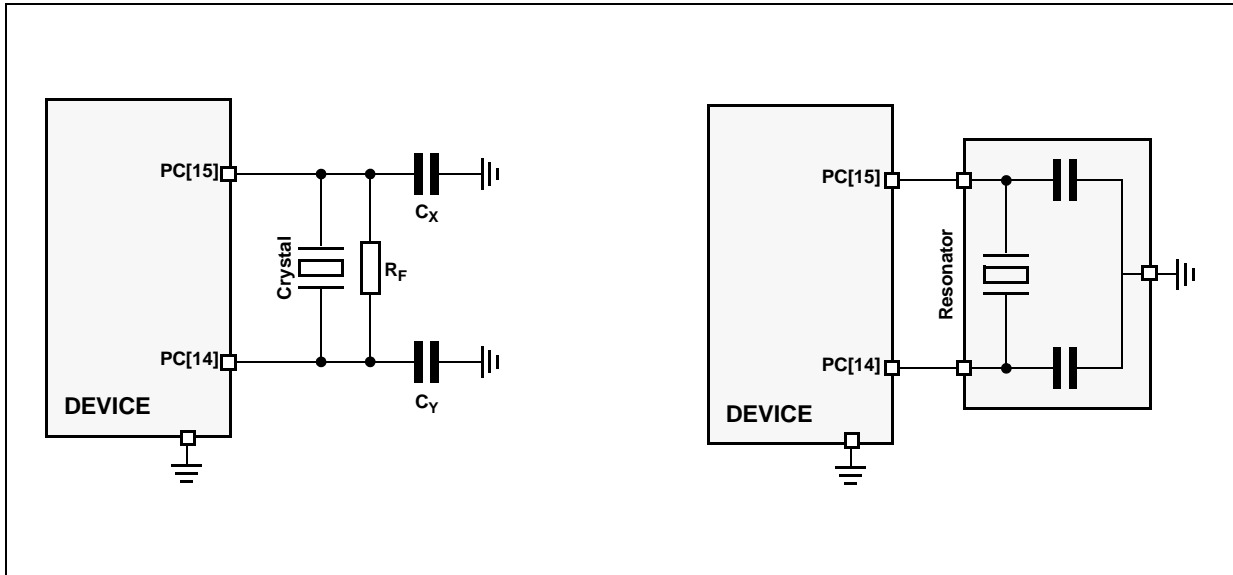


Figure 11. Crystal oscillator and resonator connection scheme

NOTE

PC[14]/PC[15] must not be directly used to drive external circuits.

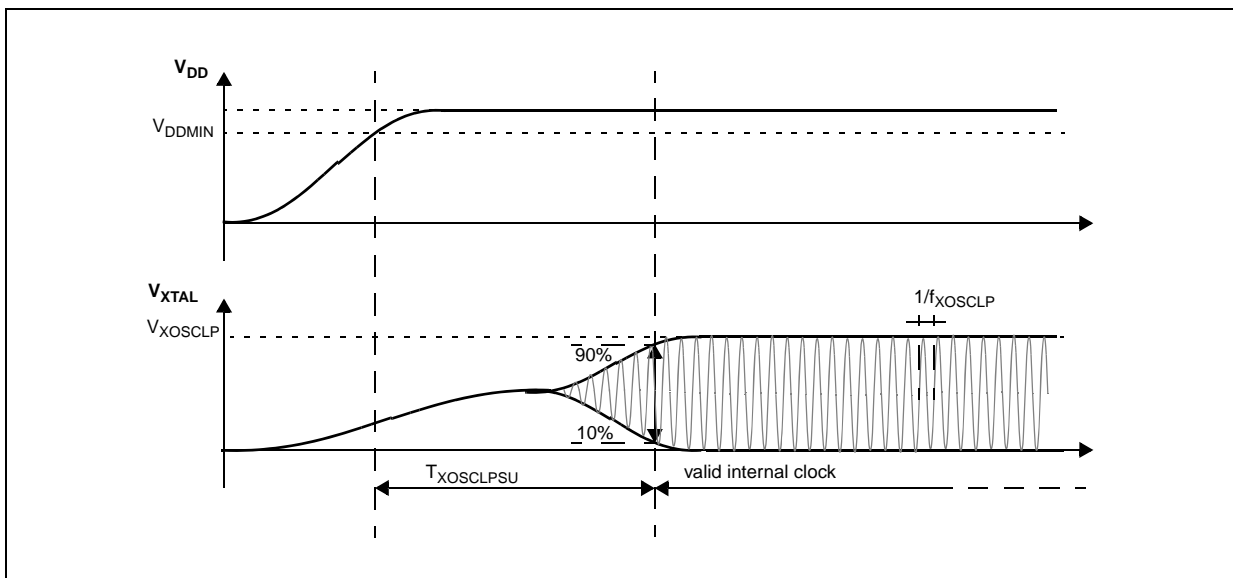


Figure 12. Slow external crystal oscillator electrical characteristics

Table 38. Slow external crystal oscillator electrical characteristics

| Symbol | | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|----------------------------|-----------------|---|---------------------------------------|---|--|------|--|------|--------|
| | | | | | Min | Typ | Max | | |
| f _{XOSCLP} | SR | C | Oscillator frequency | | 32 | — | 40 | kHz | O10.1 |
| V _{XOSCLP} | CC ³ | C | Oscillation amplitude | V _{DDA} =3.3V±10%, V _{DDE_A} =3.3V±10% | 1.12 | 1.33 | 1.74 | V | O10.2 |
| | | | | V _{DDA} =5.0V±10%, V _{DDE_A} =5.0V±10% | 1.12 | 1.37 | 1.74 | | |
| I _{XOSCLP} | CC ³ | D | Oscillator consumption | — | — | — | 5 | µA | O10.3 |
| T _{XOSCLPS U} | CC ³ | D | Oscillator start-up time | — | — | — | 2 | s | O10.4 |
| V _{IH} | SR | C | Input high level CMOS Schmitt Trigger | Oscillator bypass mode | 0.65V _{DDA} 0.65V _{DDE_A} | — | V _{DDA} +0.4 V _{DDE_A} +0.4 | V | O10.5 |
| V _{IL} | SR | C | Input low level CMOS Schmitt Trigger | Oscillator bypass mode | V _{SS} -0.4 | — | 0.35V _{DDA} 0.35V _{DDE_A} | V | O10.6 |

¹ V_{DD} = 3.3 V ±10% / 5.0 V ±10%, T_A = -40 to +105 °C, unless otherwise specified

² All values need to be confirmed during device validation.

³ Granted by device validation

4.12 FMPLL electrical characteristics

The device provides a frequency-modulated phase-locked loop (FMPLL) module to generate a fast system clock from the fast external oscillator driver.

Table 39. FMPLL electrical characteristics

| Symbol | | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|---------------------|-----------------|---|---|--|--------------------|-----|------------------|------|--------|
| | | | | | Min | Typ | Max | | |
| f _{PLLIN} | SR | T | PLL reference clock ³ | — | 4 | — | 120 | MHz | O11.1 |
| Δ _{PLLIN} | SR | T | PLL reference clock duty cycle ³ | — | 47.5 | — | 52.5 | % | O11.2 |
| f _{PLLOUT} | CC ⁴ | T | PLL output clock frequency | — | 15 | — | 250 ⁵ | MHz | O11.3 |
| f _{CPU} | CC ⁴ | T | System clock frequency | — | — | — | 125 ⁶ | MHz | O11.4 |
| T _{LOCK} | CC ⁴ | T | PLL lock time | Stable oscillator (f _{PLLIN} = 10 MHz) | — | — | 100 | µs | O11.5 |
| ΔT _{PKJIT} | CC ⁴ | T | PLL jitter | f _{PLLOUT} (PHI i.e. FMPLL O/P) = 15.625 MHz @ 10 MHz resonator | -509 | — | 509 | ps | O11.6 |
| ΔT _{LTJIT} | CC ⁴ | T | PLL long term jitter | f _{PLLIN} = 10 MHz (resonator) | -2.4 | — | 2.4 | ns | O11.7 |
| I _{PLL} | CC ⁷ | D | Current Consumption (Normal Mode for Analog Supply) | T _A = 25°C | — | — | 500 | µA | O11.8 |

¹ V_{DDPLL} = 1.2 V ±10%, T_A = -40 to 105 °C, unless otherwise specified.

² All values need to be confirmed during device validation.

³ PLLIN clock retrieved directly from XOSCHS clock. Input characteristics are granted when oscillator is used in functional mode. When bypass mode is used, oscillator input clock should verify f_{PLLIN} and Δ_{PLLIN}.

- ⁴ Data based on device simulation.
⁵ 2x sys clock required for generation of DDR timing.
⁶ f_{CPU} of 125 MHz can be achieved only at temperatures up to 105 °C with a maximum FM depth of 2%.
⁷ Data based on characterization results, not tested in production

4.13 Fast internal RC oscillator (16 MHz) electrical characteristics

The device provides a fast internal RC oscillator (FIRC). This is used as the default clock at the power-up of the device.

Table 40. Fast internal oscillator electrical characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|-----------------|-----------------|--|--------------------------------|--------------------|-----|-----|------|--------|
| | | | | Min | Typ | Max | | |
| f_{RCM} | CC ³ | P RC oscillator high frequency | $T_A = 25\text{ °C}$, trimmed | — | 16 | — | MHz | O12.1 |
| I_{RCMRUN} | CC ³ | D RC oscillator high frequency current in running mode | $T_A = 25\text{ °C}$, trimmed | — | — | 200 | μA | O12.2 |
| I_{RCMPWD} | CC ³ | D RC oscillator high frequency current in power down mode | $T_A = 25\text{ °C}$ | — | — | 10 | μA | O12.3 |
| $\Delta RCMVAR$ | CC ⁴ | C RC oscillator variation in temperature and supply with respect to f_{RC} at $T_A = 55\text{ °C}$ in high-frequency configuration | — | -5 | — | +5 | % | O12.5 |

¹ $V_{DD} = 3.3\text{ V} \pm 10\% / 5.0\text{ V} \pm 10\%$, $T_A = -40$ to 105 °C, unless otherwise specified.

² All values need to be confirmed during device validation.

³ Guaranteed by device simulation, not tested in production

⁴ Guaranteed by device characterization, not tested in production

4.14 Slow internal RC oscillator (128 kHz) electrical characteristics

The device provides a slow internal RC oscillator (SIRC). This can be used as the reference clock for the RTC module.

Table 41. Slow internal RC oscillator electrical characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|----------------------|-----------------|--|--------------------------------|--------------------|-----|-----|------|--------|
| | | | | Min | Typ | Max | | |
| f_{RCL} | CC ³ | P RC oscillator low frequency | $T_A = 25\text{ °C}$, trimmed | — | 128 | — | kHz | O13.1 |
| I_{RCL} | CC ³ | D RC oscillator low frequency current | $T_A = 25\text{ °C}$, trimmed | — | — | 5 | μA | O13.2 |
| $\Delta RCLTRI$ M | CC ³ | C RC oscillator precision after trimming of f_{RCL} | $T_A = 25\text{ °C}$ | -2 | — | +2 | % | O13.3 |
| $\Delta RCLVAR$ 3 | CC ³ | C RC oscillator variation in temperature and supply with respect to f_{RC} at $T_A = 55\text{ °C}$ in high frequency configuration | High frequency configuration | -10 | — | +10 | % | O13.4 |

¹ $V_{DD} = 3.3\text{ V} \pm 10\% / 5.0\text{ V} \pm 10\%$, $T_A = -40$ to +105 °C, unless otherwise specified.

² All values need to be confirmed during device validation.

³ Guaranteed by device simulation, not tested in production

4.15 Flash memory electrical characteristics

Table 42. Program and erase specifications

| Symbol | C | Parameter | Min Value | Typical Value ¹ | Initial Max ² | Max ³ | Unit | SpecID |
|--------------------------|---|---|-----------|----------------------------|--------------------------|------------------|------|--------|
| T _{dwprogram} | C | Double Word (64 bits) Program Time ⁴ | | — | 22 | 500 | μs | D14.1 |
| T _{16kpperase} | C | 16 KB Block Pre-program and Erase Time | | — | 500 | 5000 | ms | D14.2 |
| T _{32kpperase} | C | 32 KB Block Pre-program and Erase Time | | — | 600 | 5000 | ms | D14.3 |
| T _{128kpperase} | C | 128 KB Block Pre-program and Erase Time | | — | 1300 | 7500 | ms | D14.4 |

¹ Typical program and erase times assume nominal supply values and operation at 25 °C. All times are subject to change pending device characterization.

² Initial factory condition: < 100 program/erase cycles, 25 °C, typical supply voltage.

³ The maximum program & erase times occur after the specified number of program/erase cycles. These maximum values are characterized but not guaranteed.

⁴ Actual hardware programming times. This does not include software overhead.

Table 43. Flash module life

| Symbol | C | Parameter | Conditions | Value | | Unit | SpecID |
|----------------|---|--|---|---------|---------|------------|--------|
| | | | | Min | Typ | | |
| P/E | C | Number of program/erase cycles per block for 16 KB, 48KB and 64KB blocks, across full operating temperature range (Tj) | — | 100,000 | — | P/E cycles | D14.5 |
| P/E | C | Number of program/erase cycles per block for 128KB and 256KB blocks, across full operating temperature range (Tj) | — | 1,000 | 100,000 | P/E cycles | D14.6 |
| Data retention | C | Minimum data retention at 85 °C average ambient temperature ¹ | Blocks with 0 – 1,000 P/E cycles | 20 | — | Years | D14.8 |
| | | | Blocks with 1,001 – 10,000 P/E cycles | 10 | — | Years | |
| | | | Blocks with 10,001 – 100,000 P/E cycles | 5 | — | Years | |

¹ Ambient temperature averaged over duration of application, not to exceed recommended product operating temperature range.

4.16 ADC parameters

The device provides a 10-bit Successive Approximation Register (SAR) Analog to Digital Converter.

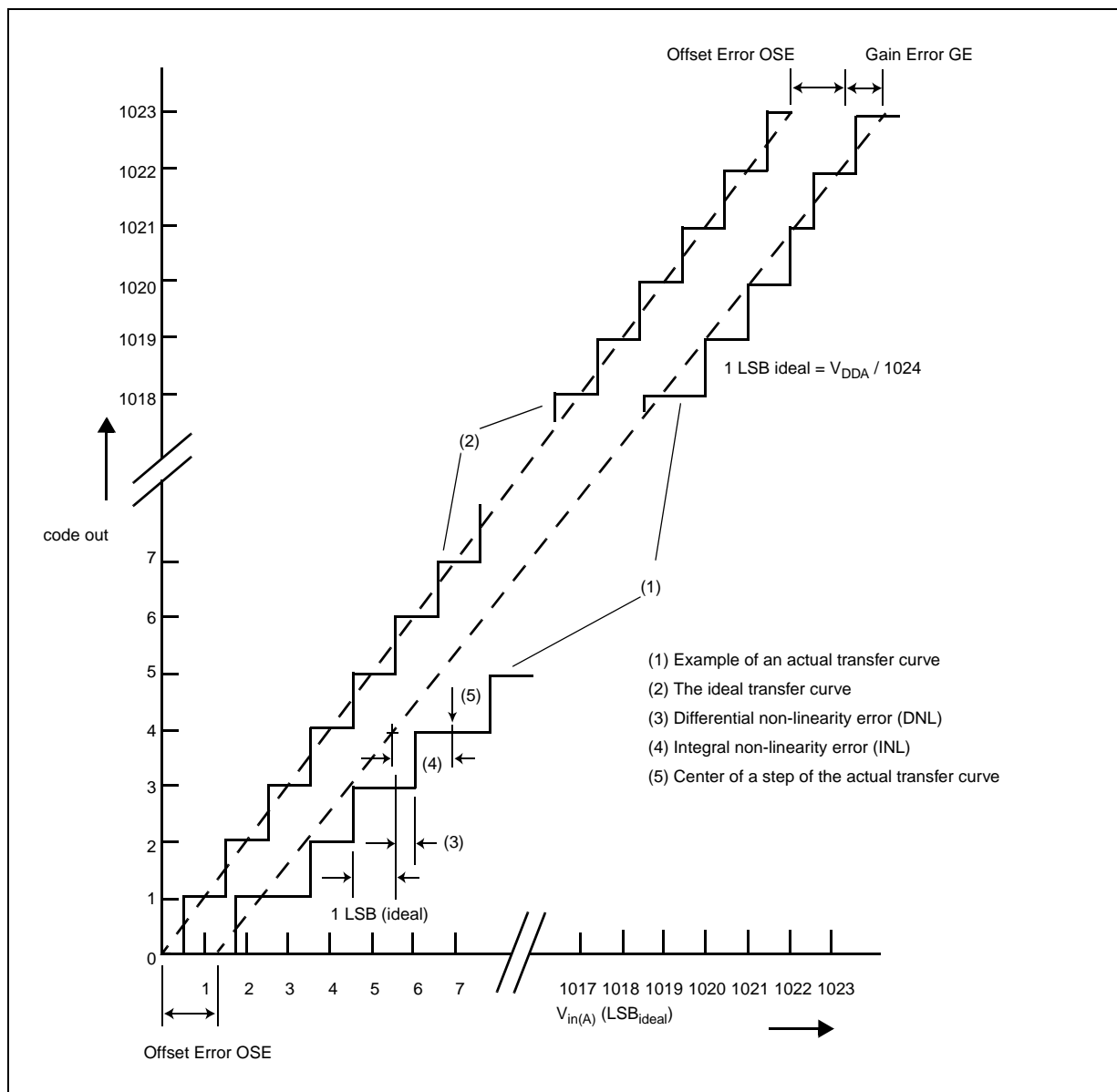


Figure 13. ADC characteristics and error definitions

4.16.1 Input impedance and ADC accuracy

In the following analysis, the input circuit corresponding to the precise channels is considered.

To preserve the accuracy of the A/D converter, it is necessary that analog input pins have low AC impedance. Placing a capacitor with good high frequency characteristics at the input pin of the device can be effective: the capacitor should be as large as possible, ideally infinite. This capacitor contributes to attenuating the noise present on the input pin; furthermore, it sources charge during the sampling phase, when the analog signal source is a high-impedance source.

Electrical characteristics

A real filter can typically be obtained by using a series resistance with a capacitor on the input pin (simple RC filter). The RC filtering may be limited according to the value of source impedance of the transducer or circuit supplying the analog signal to be measured. The filter at the input pins must be designed taking into account the dynamic characteristics of the input signal (bandwidth) and the equivalent input impedance of the ADC itself.

In fact a current sink contributor is represented by the charge sharing effects with the sampling capacitance: C_S being substantially a switched capacitance, with a frequency equal to the conversion rate of the ADC, it can be seen as a resistive path to ground. For instance, assuming a conversion rate of 1 MHz, with C_S equal to 3 pF, a resistance of 330 kΩ is obtained ($R_{EQ} = 1 / (fc \times C_S)$, where fc represents the conversion rate at the considered channel). To minimize the error induced by the voltage partitioning between this resistance (sampled voltage on C_S) and the sum of $R_S + R_F + R_L + R_{SW} + R_{AD}$, the external circuit must be designed to respect the [Equation 5](#):

Eqn. 5

$$V_A \cdot \frac{R_S + R_F + R_L + R_{SW} + R_{AD}}{R_{EQ}} < \frac{1}{2} \text{LSB}$$

[Equation 5](#) generates a constraint for external network design, in particular on resistive path. Internal switch resistances (R_{SW} and R_{AD}) can be neglected with respect to external resistances.

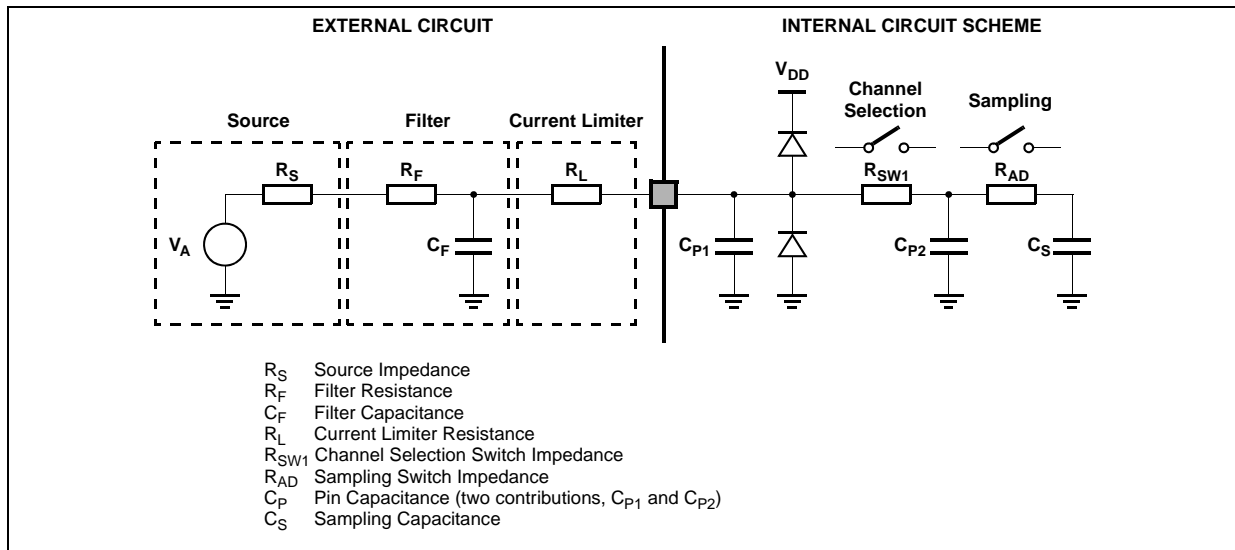


Figure 14. Input equivalent circuit (precise channels)

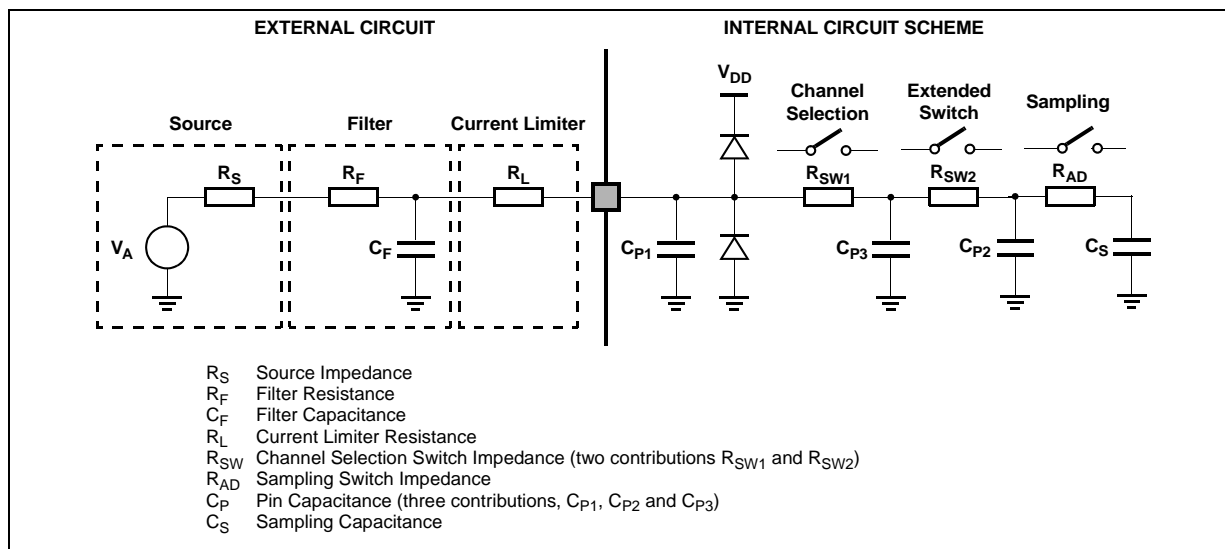


Figure 15. Input equivalent circuit (extended channels)

A second aspect involving the capacitance network shall be considered. Assuming the three capacitances C_F , C_{P1} and C_{P2} are initially charged at the source voltage V_A (refer to the equivalent circuit reported in Figure 14): A charge sharing phenomenon is installed when the sampling phase is started (A/D switch close).

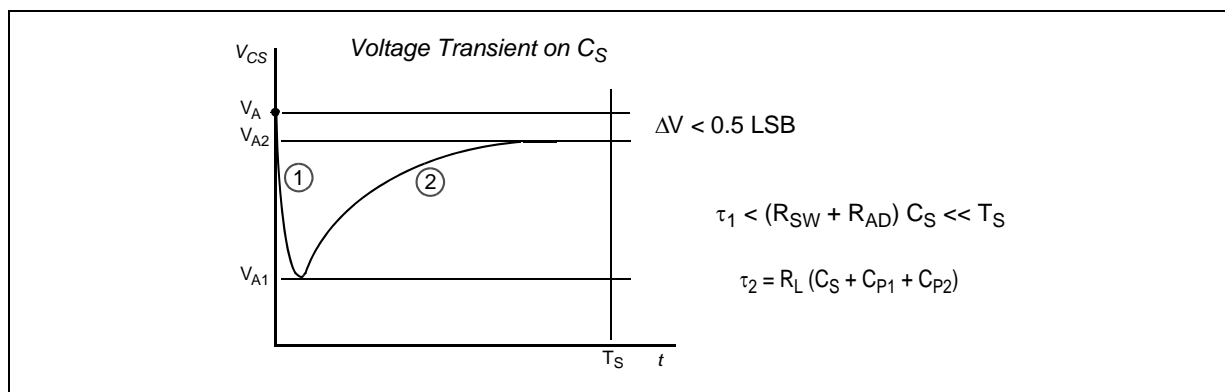


Figure 16. Transient behavior during sampling phase

In particular two different transient periods can be distinguished:

- A first and quick charge transfer from the internal capacitance C_{P1} and C_{P2} to the sampling capacitance C_S occurs (C_S is supposed initially completely discharged): considering a worst case (since the time constant in reality would be faster) in which C_{P2} is reported in parallel to C_{P1} (call $C_P = C_{P1} + C_{P2}$), the two capacitances C_P and C_S are in series, and the time constant is

Eqn. 6

$$\tau_1 = (R_{SW} + R_{AD}) \cdot \frac{C_P \cdot C_S}{C_P + C_S}$$

Equation 6 can again be simplified considering only C_S as an additional worst condition. In reality, the transient is faster, but the A/D converter circuitry has been designed to be robust also in the very worst case: the sampling time T_S is always much longer than the internal time constant:

Eqn. 7

$$\tau_1 < (R_{SW} + R_{AD}) \cdot C_S \ll T_S$$

The charge of C_{P1} and C_{P2} is redistributed also on C_S , determining a new value of the voltage V_{A1} on the capacitance according to Equation 8:

Eqn. 8

$$V_{A1} \cdot (C_S + C_{P1} + C_{P2}) = V_A \cdot (C_{P1} + C_{P2})$$

- A second charge transfer involves also C_F (that is typically bigger than the on-chip capacitance) through the resistance R_L : again considering the worst case in which C_{P2} and C_S were in parallel to C_{P1} (since the time constant in reality would be faster), the time constant is:

Eqn. 9

$$\tau_2 < R_L \cdot (C_S + C_{P1} + C_{P2})$$

In this case, the time constant depends on the external circuit: in particular imposing that the transient is completed well before the end of sampling time T_S , a constraints on R_L sizing is obtained:

Eqn. 10

$$10 \cdot \tau_2 = 10 \cdot R_L \cdot (C_S + C_{P1} + C_{P2}) < T_S$$

Of course, R_L shall be sized also according to the current limitation constraints, in combination with R_S (source impedance) and R_F (filter resistance). Being C_F definitively bigger than C_{P1} , C_{P2} and C_S , then the final voltage V_{A2} (at the end of the charge transfer transient) will be much higher than V_{A1} . Equation 11 must be respected (charge balance assuming now C_S already charged at V_{A1}):

Eqn. 11

$$V_{A2} \cdot (C_S + C_{P1} + C_{P2} + C_F) = V_A \cdot C_F + V_{A1} \cdot (C_{P1} + C_{P2} + C_S)$$

The two transients above are not influenced by the voltage source that, due to the presence of the $R_F C_F$ filter, is not able to provide the extra charge to compensate the voltage drop on C_S with respect to the ideal source V_A ; the time constant $R_F C_F$ of the filter is very high with respect to the sampling time (T_S). The filter is typically designed to act as anti-aliasing.

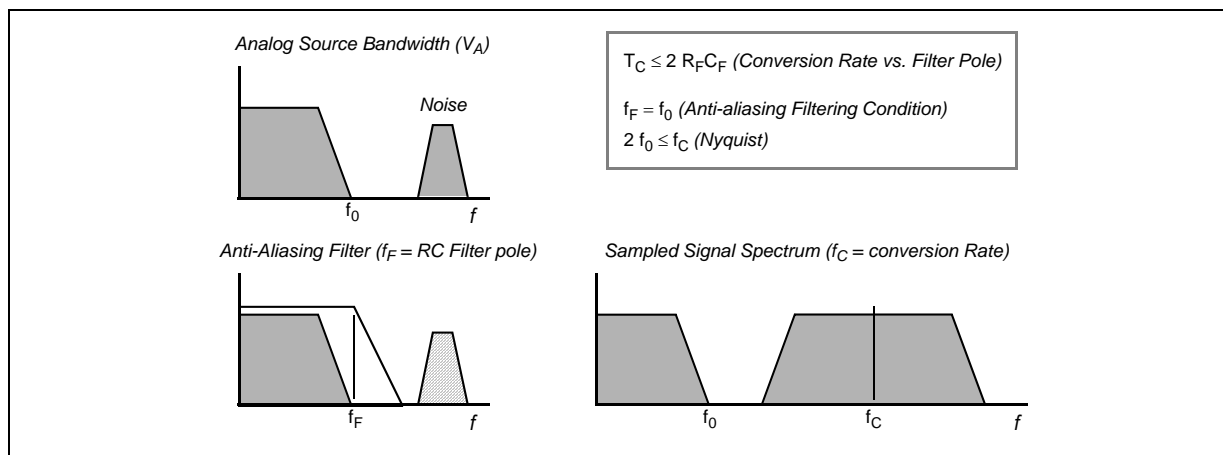


Figure 17. Spectral representation of input signal

Calling f_0 the bandwidth of the source signal (and as a consequence the cut-off frequency of the anti-aliasing filter, f_F), according to the Nyquist theorem the conversion rate f_C must be at least $2f_0$; it means that the constant time of the filter is greater than or at least equal to twice the conversion period (T_C). Again the conversion period T_C is longer than the sampling time T_S , which is just a portion of it, even when fixed channel continuous conversion mode is selected (fastest conversion rate at a specific channel): in conclusion it is evident that the time constant of the filter $R_F C_F$ is definitively much higher than the sampling time T_S , so the charge level on C_S cannot be modified by the analog signal source during the time in which the sampling switch is closed.

The considerations above lead to impose new constraints on the external circuit, to reduce the accuracy error due to the voltage drop on C_S ; from the two charge balance equations above, it is simple to derive [Equation 12](#) between the ideal and real sampled voltage on C_S :

Eqn. 12

$$\frac{V_A}{V_{A2}} = \frac{C_{P1} + C_{P2} + C_F}{C_{P1} + C_{P2} + C_F + C_S}$$

From this formula, in the worst case (when V_A is maximum, that is for instance 5V), assuming to accept a maximum error of half a count, a constraint is evident on C_F value:

Eqn. 13

$$C_F > 2048 \cdot C_S$$

4.16.2 ADC electrical characteristics

Table 44. ADC electrical characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|---------------|-----------------|-----------|--|---|--------------------|--------------------|------|--------|
| | | | | Min | Typ | Max | | |
| V_{SSA} | SR | D | Voltage on VSSA (ADC reference) pin with respect to ground (V_{SS}) ³ | — | — | 0.1 | V | D15.1 |
| V_{DDA} | SR | D | Voltage on VDDA pin (ADC reference) with respect to ground (V_{SS}) | — | $V_{DDE_A} - 0.1$ | $V_{DDE_A} + 0.1$ | V | D15.2 |
| V_{AINx} | SR | D | Analog input voltage ⁴ | — | $V_{SSA} - 0.1$ | $V_{DDA} + 0.1$ | V | D15.3 |
| f_{ADC} | SR | D | ADC analog frequency | — | 6 | 32 | MHz | D15.4 |
| t_{ADC_PU} | SR | D | ADC power up delay | — | — | 1.5 | µs | D15.5 |
| t_{ADC_S} | CC ⁵ | T | Sample time ⁶ | $f_{ADC} = 32$ MHz, ADC_conf_sample_input = 17 | 0.5 | — | µs | D15.6 |
| | | | | $f_{ADC} = 6$ MHz, ADC_conf_sample_input = 127 | — | 21 | | |
| t_{ADC_C} | CC ⁵ | T | Conversion time ⁷ | $f_{ADC} = 32$ MHz, ADC_conf_comp = 2 | 0.625 | — | µs | D15.7 |

Table 44. ADC electrical characteristics (continued)

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID | |
|------------------|-----------------|-----------|--|--|------|-----|------|--------|--------|
| | | | | Min | Typ | Max | | | |
| C _S | CC ⁵ | D | ADC input sampling capacitance | — | — | 3 | pF | D15.8 | |
| C _{P1} | CC ⁵ | D | ADC input pin capacitance 1 | — | — | 3 | pF | D15.9 | |
| C _{P2} | CC ⁵ | D | ADC input pin capacitance 2 | — | — | 1 | pF | D15.10 | |
| C _{P3} | CC ⁵ | D | ADC input pin capacitance 3 | — | — | 1 | pF | D15.11 | |
| R _{SW1} | CC ⁵ | D | Internal resistance of analog source | — | — | 3 | kΩ | D15.12 | |
| R _{SW2} | CC ⁵ | D | Internal resistance of analog source | — | — | 2 | kΩ | D15.13 | |
| R _{AD} | CC ⁵ | D | Internal resistance of analog source | — | — | 0.1 | kΩ | D15.14 | |
| I _{INJ} | SR | T | Input current Injection | Current injection on one ADC input, different from the converted one | -10 | — | 10 | mA | D15.15 |
| INL | CC ⁵ | P | Integral Non Linearity | No overload | -1.5 | — | 1.5 | LSB | D15.16 |
| DNL | CC ⁵ | P | Differential Non Linearity | No overload | -1.0 | — | 1.0 | LSB | D15.17 |
| OFS | CC ⁵ | T | Offset error | After offset cancellation | — | 0.5 | — | LSB | D15.18 |
| GNE | CC ⁵ | T | Gain error | — | — | 0.6 | — | LSB | D15.19 |
| TUEX | CC | T | Total Unadjusted Error for extended channel | No overload | -3 | — | 3 | LSB | D15.21 |
| TUEP | CC ⁵ | T | Total Unadjusted Error for precise channels, input only pins | No overload | -2 | — | 2 | LSB | D15.22 |
| | | | | overload conditions on adjacent channel | — | — | — | LSB | |
| TUEX | CC ⁵ | T | Total Unadjusted Error for extended channel, | No overload | -3 | — | 3 | LSB | D15.23 |
| | | | | overload conditions on adjacent channel | — | — | — | LSB | |

¹ V_{DDA} = 3.3 V ± 10% / 5.0 V ± 10%, T_A = -40 to +105 °C, unless otherwise specified.

² All values need to be confirmed during device validation.

³ Analog and digital V_{SS} **must** be common (to be tied together externally).

⁴ V_{AINx} may exceed V_{SSA} and V_{DDA} limits, remaining on absolute maximum ratings, but the results of the conversion will be clamped respectively to 0x000 or 0x3FF

⁵ Guaranteed by design

⁶ During the sample time the input capacitance C_S can be charged/discharged by the external source. The internal resistance of the analog source must allow the capacitance to reach its final voltage level within t_{ADC_S}. After the end of the sample time t_{ADC_S}, changes of the analog input voltage have no effect on the conversion result. Values for the sample clock t_{ADC_S} depend on programming.

⁷ This parameter does not include the sample time t_{ADC_S}, but only the time for determining the digital result and the time to load the result's register with the conversion result.

4.17 AC specifications

4.17.1 AC specification for CMOS090LP2 library @ VDDE = 3.3 V

Table 45. Functional pad type AC specifications

| Name | C | Prop. delay (ns) L>H / H>L ¹ | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select |
|---------|-----------|--|-----------|---------------------|------------|--------------------|---------------------------|
| | | Min | Max | Min | Max | | MSB, LSB |
| pad_ssr | C | — | 4.5 / 4.5 | — | 2.2 / 2.2 | 50 | 11 ² |
| | | — | 8 / 8 | — | 6 / 6 | 200 | |
| | | — | 45 / 45 | — | 22 / 22 | 50 | 10 |
| | | — | 60 / 60 | — | 28 / 28 | 200 | |
| | | — | 90 / 90 | — | 42 / 42 | 50 | 01 |
| | | — | 110 / 110 | — | 50 / 50 | 200 | |
| | | — | 430 / 430 | — | 210 / 210 | 50 | 00 |
| — | 480 / 480 | — | 220 / 220 | 200 | | | |
| pad_fc | C | — | 2.5 / 2.5 | — | 1.2 / 1.2 | 10 | 00 |
| | | — | 2.5 / 2.5 | — | 1.2 / 1.2 | 20 | 01 |
| | | — | 2.5 / 2.5 | — | 1.2 / 1.2 | 30 | 10 |
| | | — | 2.5 / 2.5 | — | 1.2 / 1.2 | 50 | 11 ² |
| pad_msr | C | — | 4.0 / 4.5 | — | 1.02 / 1.4 | 50 | 11 ² |
| | | — | 7.3 / 8.3 | — | 3.5 / 4.2 | 200 | |
| | | — | 24 / 22 | — | 9.1 / 10.3 | 50 | 10 |
| | | — | 33 / 31 | — | 14 / 15 | 200 | |
| | | — | 49 / 44 | — | 18 / 21 | 50 | 01 |
| | | — | 60 / 53 | — | 24 / 25 | 200 | |
| | | — | 332 / 302 | — | 126 / 151 | 50 | 00 |
| — | 362 / 325 | — | 136 / 158 | 200 | | | |

¹ L>H signifies low-to-high propagation delay and H>L signifies high-to-low propagation delay.

² Can be used on the tester.

4.17.2 AC specification for CMOS090LP2fg library @ VDDE = 5.0 V

Table 46. Functional pad type AC specifications

| Name | C | Prop. delay (ns) L>H / H>L ¹ | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select | |
|-------------------------|---|--|-----------|---------------------|-----------|--------------------|---------------------------|-----------------|
| | | Min | Max | Min | Max | | MSB, LSB | |
| pad_msr_hv ² | C | 4.6 / 3.7 | 12 / 12 | 2.2 / 2.2 | 5.3 / 5.9 | 50 | 11 ³ | |
| | | 13 / 10 | 32 / 32 | 9 / 9 | 22 / 22 | 200 | | |
| | | N/A | | | | | | 10 ⁴ |
| | | 12 / 13 | 28 / 34 | 5.6 / 6 | 12 / 15 | 50 | 01 | |
| | | 23 / 23 | 52 / 59 | 11 / 14 | 28 / 31 | 200 | | |
| | | 69 / 71 | 152 / 165 | 34 / 35 | 70 / 74 | 50 | 00 | |
| | | 95 / 90 | 205 / 220 | 44 / 51 | 96 / 96 | 200 | | |
| pad_ssr_hv ² | C | 7.3 / 5.7 | 19 / 18 | 4.4 / 4.3 | 10 / 11 | 50 | 11 ³ | |
| | | 24 / 19 | 58 / 58 | 17 / 15 | 40 / 42 | 200 | | |
| | | N/A | | | | | | 10 ⁴ |
| | | 26 / 27 | 61 / 69 | 13 / 13 | 30 / 34 | 50 | 01 | |
| | | 49 / 45 | 115 / 115 | 27 / 23 | 61 / 61 | 200 | | |
| | | 137 / 142 | 320 / 330 | 72 / 74 | 156 / 164 | 50 | 00 | |
| | | 182 / 172 | 420 / 420 | 90 / 85 | 200 / 200 | 200 | | |
| pad_i_hv | C | 0.5 / 0.5 | 1.9 / 1.9 | 0.3 / 0.3 | 1.5 / 1.5 | 0.5 | N/A | |

¹ L>H signifies low-to-high propagation delay and H>L signifies high-to-low propagation delay.

² For input buffer timing, look at pad_i_hv.

³ Can be used on the tester.

⁴ This drive select value is not supported. If selected, it will be approximately equal to 11.

4.17.3 AC specification for CMOS090LP2fg library @ VDDE = 3.3 V

Table 47. Functional pad AC type specifications

| Name | Prop. delay (ns) L>H / H>L | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select | |
|------------|-------------------------------|-----------|---------------------|-----------|--------------------|---------------------------|----|
| | Min | Max | Min | Max | | MSB, LSB | |
| pad_msr_hv | 5.8 / 4.4 | 18 / 17 | 2.7 / 2.1 | 7.6 / 8.5 | 50 | 11 | |
| | 16 / 13 | 46 / 49 | 11.2 / 8.6 | 30 / 34 | 200 | | |
| | N/A | | | | | | 10 |
| | 14 / 16 | 37 / 45 | 6.5 / 6.7 | 15.5 / 19 | 50 | 01 | |
| | 27 / 27 | 69 / 82 | 15 / 13 | 38 / 43 | 200 | | |
| | 83 / 86 | 200 / 210 | 38 / 38 | 86 / 86 | 50 | 00 | |
| | 113 / 109 | 270 / 285 | 53 / 46 | 120 / 120 | 200 | | |

Table 47. Functional pad AC type specifications (continued)

| Name | Prop. delay (ns) L>H / H>L | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select |
|------------|-------------------------------|-----------|---------------------|-----------|--------------------|---------------------------|
| | Min | Max | Min | Max | | MSB, LSB |
| pad_ssr_hv | 9.2 / 6.9 | 27 / 28 | 5.5 / 4.1 | 15 / 17 | 50 | 11 |
| | 30 / 23 | 81 / 87 | 21 / 16 | 57 / 63 | 200 | |
| | N/A | | | | | 10 |
| | 31 / 31 | 80 / 90 | 15.4 / 15.4 | 38 / 42 | 50 | 01 |
| | 58 / 52 | 144 / 155 | 32 / 26 | 82 / 85 | 200 | |
| | 162 / 168 | 415 / 415 | 80 / 82 | 190 / 190 | 50 | 00 |
| | 216 / 205 | 533 / 540 | 106 / 95 | 250 / 250 | 200 | |
| pad_i_hv | 0.5 / 0.5 | 3 / 3 | 0.4 / 0.4 | 1.5 / 1.5 | 0.5 | N/A |

4.17.4 Pad AC specifications (3.3 V, PAD3V5V = 1)

 Table 48. Pad AC specifications (3.3 V, PAD3V5V = 1)¹

| No. | Pad | Tswitchon ¹ (ns) | | | Rise/Fall ² (ns) | | | Frequency (MHz) | | | Current slew (mA/ns) | | | Load drive (pF) |
|-----------------------------|-----------------------------|--------------------------------|-----|-----|--------------------------------|-----|------|--------------------|-----|-----|-------------------------|-----|-----|--------------------|
| | | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max | |
| 1 | Slow | 3 | — | 40 | 4 | — | 40 | — | — | 4 | 0.01 | — | 2 | 25 |
| | | 3 | — | 40 | 6 | — | 50 | — | — | 2 | 0.01 | — | 2 | 50 |
| | | 3 | — | 40 | 10 | — | 75 | — | — | 2 | 0.01 | — | 2 | 100 |
| | | 3 | — | 40 | 14 | — | 100 | — | — | 2 | 0.01 | — | 2 | 200 |
| 2 | Medium | 1 | — | 15 | 2 | — | 12 | — | — | 40 | 2.5 | — | 7 | 25 |
| | | 1 | — | 15 | 4 | — | 25 | — | — | 20 | 2.5 | — | 7 | 50 |
| | | 1 | — | 15 | 8 | — | 40 | — | — | 13 | 2.5 | — | 7 | 100 |
| | | 1 | — | 15 | 14 | — | 70 | — | — | 7 | 2.5 | — | 7 | 200 |
| 3 | Fast | 1 | — | 6 | 1 | — | 4 | — | — | 72 | 3 | — | 40 | 25 |
| | | 1 | — | 6 | 1.5 | — | 7 | — | — | 55 | 3 | — | 40 | 50 |
| | | 1 | — | 6 | 3 | — | 12 | — | — | 40 | 3 | — | 40 | 100 |
| | | 1 | — | 6 | 5 | — | 18 | — | — | 25 | 3 | — | 40 | 200 |
| 4 | Pull Up/Down (3.6 V max) | — | — | — | — | — | 7500 | — | — | — | — | — | — | 50 |
| Parameter Classification | | D | | | C | | | C | | | C | | | n/a |

¹ Propagation delay from $V_{DD}/2$ of internal signal to Pchannel/Nchannel on condition

² Slope at rising/falling edge

4.17.5 AC specification for CMOS090_dds library @ VDDE = 3.3 V

Table 49. AC specifications at 3.3 V VDDE

| Name | C | Prop. delay (ns) L>H / H>L | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select | Libraries |
|------------|---|-------------------------------|---------|---------------------|---------|--------------------|---------------------------|-----------|
| | | Min | Max | Min | Max | | MSB, LSB | |
| pad_st_acc | C | 1.4/1.4 | 2.4/2.4 | 3.1/2.5 | 5.6/5.4 | 5 | 111 | 6MDDR |
| | | 1.7/1.7 | 2.7/2.7 | 0.9/1.1 | 1.7/2.0 | 20 | | |
| pad_st_dq | C | 1.4/1.4 | 2.4/2.4 | 3.1/2.5 | 5.6/5.4 | 5 | 111 | 6MDDR |
| | | 1.7/1.7 | 2.7/2.7 | 0.9/1.1 | 1.7/2.0 | 20 | | |
| pad_st_clk | C | 1.4/1.4 | 2.4/2.4 | 3.1/2.5 | 5.7/5.7 | 5 | 111 | 6MDDR |
| | | 1.6/1.6 | 2.6/2.6 | 1.1/1.3 | 2.3/2.3 | 20 | | |

4.17.6 AC specification for CMOS090_dds library @ VDDE = 2.5 V

Table 50. AC specifications at 2.5 V VDDE

| Name | C | Prop. delay (ns) L>H / H>L | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select | Libraries |
|------------|---|-------------------------------|---------|---------------------|---------|--------------------|---------------------------|-----------|
| | | Min | Max | Min | Max | | MSB, LSB | |
| pad_st_acc | C | 1.4/1.5 | 2.5/2.4 | 2.1/2.1 | 4.3/4.1 | 5 | 011 | 6MDDR |
| | | 1.7/1.7 | 2.8/2.7 | 0.6/0.7 | 1.1/1.3 | 20 | | |
| pad_st_dq | C | 1.4/1.5 | 2.5/2.4 | 2.1/2.1 | 4.3/4.1 | 5 | 011 | 6MDDR |
| | | 1.7/1.7 | 2.8/2.7 | 0.6/0.7 | 1.1/1.3 | 20 | | |
| pad_st_clk | C | 1.4/1.4 | 2.4/2.4 | 2.1/2.1 | 4.4/4.1 | 5 | 011 | 6MDDR |
| | | 1.1/1.6 | 2.7/2.7 | 0.6/0.7 | 1.6/1.8 | 20 | | |

4.17.7 AC specification for CMOS090_ ddr library @ VDDE = 1.8 V

Table 51. AC electrical specifications at 1.8 V VDD

| Name | C | Prop. delay (ns) L>H / H>L | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select | Libraries |
|------------|---|-------------------------------|---------|---------------------|---------|--------------------|---------------------------|-----------|
| | | Min | Max | Min | Max | | MSB, LSB | |
| pad_st_acc | C | 1.4/1.4 | 2.4/2.4 | 0.6/1.0 | 2.7/2.6 | 5 | 000 | 6MDDR |
| | | 1.7/1.7 | 2.8/2.7 | 0.2/0.4 | 0.5/0.6 | 20 | | |
| | | 1.4/1.5 | 2.4/2.5 | 1.1/1.1 | 3.0/2.7 | 5 | 001 | |
| | | 1.7/1.7 | 2.8/2.8 | 0.4/0.4 | 0.7/0.7 | 20 | | |
| | | 1.4/1.5 | 2.4/2.4 | 1.0/1.1 | 2.9/2.7 | 5 | 010 | |
| | | 1.7/1.7 | 2.8/2.7 | 0.3/0.4 | 0.6/0.7 | 20 | | |
| | | 1.4/1.5 | 2.5/2.5 | 1.5/1.1 | 3.1/2.6 | 5 | 110 | |
| | | 1.7/1.8 | 2.8/2.8 | 0.4/0.4 | 0.7/0.6 | 20 | | |
| pad_st_dq | C | 1.4/1.4 | 2.4/2.4 | 0.6/1.0 | 2.7/2.6 | 5 | 000 | 6MDDR |
| | | 1.7/1.7 | 2.8/2.7 | 0.2/0.4 | 0.5/0.6 | 20 | | |
| | | 1.4/1.5 | 2.4/2.5 | 1.1/1.1 | 3.0/2.7 | 5 | 001 | |
| | | 1.7/1.7 | 2.8/2.8 | 0.4/0.4 | 0.7/0.7 | 20 | | |
| | | 1.4/1.5 | 2.4/2.4 | 1.0/1.1 | 2.9/2.7 | 5 | 010 | |
| | | 1.7/1.7 | 2.8/2.7 | 0.3/0.4 | 0.6/0.7 | 20 | | |
| | | 1.4/1.5 | 2.5/2.5 | 1.5/1.1 | 3.1/2.6 | 5 | 110 | |
| | | 1.7/1.8 | 2.8/2.8 | 0.4/0.4 | 0.7/0.6 | 20 | | |
| pad_st_clk | C | 1.4/1.4 | 2.4/2.4 | 0.4/0.6 | 2.7/2.7 | 5 | 000 | 6MDDR |
| | | 1.6/1.6 | 2.7/2.7 | 0.7/0.9 | 1.8/3.4 | 20 | | |
| | | 1.4/1.4 | 2.4/2.4 | 1.1/1.1 | 3.0/2.8 | 5 | 001 | |
| | | 1.7/1.7 | 2.7/2.7 | 0.3/0.4 | 1.0/1.1 | 20 | | |
| | | 1.4/1.4 | 2.4/2.4 | 0.9/1.1 | 3.0/2.8 | 5 | 010 | |
| | | 1.6/1.6 | 2.7/2.7 | 0.3/0.4 | 0.9/1.0 | 20 | | |
| | | 1.4/1.5 | 2.5/2.5 | 1.5/1.2 | 3.2/2.6 | 5 | 110 | |
| | | 1.7/1.8 | 2.7/2.7 | 0.4/0.4 | 1.1/1.2 | 20 | | |

4.18 AC timing

4.18.1 IEEE 1149.1 interface timing

Table 52. JTAG interface timing¹

| Num | Symbol | CC ² | C | Characteristic | Min | Max | Unit | SpecID |
|-----|----------------------|-----------------|---|--|-----|-----|------|--------|
| 1 | t_{JCYC} | CC ² | D | TCK Cycle Time | 100 | — | ns | A1.1 |
| 2 | t_{JDC} | CC ² | D | TCK Clock Pulse Width (Measured at $V_{DD}/2$) | 40 | 60 | ns | A1.2 |
| 3 | $t_{TCKRISE}$ | CC ² | D | TCK Rise and Fall Times (40% – 70%) | — | 3 | ns | A1.3 |
| 4 | t_{TMSS}, t_{TDIS} | CC ² | D | TMS, TDI Data Setup Time | 5 | — | ns | A1.4 |
| 5 | t_{TMSH}, t_{TDIH} | CC ² | D | TMS, TDI Data Hold Time | 25 | — | ns | A1.5 |
| 6 | t_{TDOV} | CC ² | D | TCK Low to TDO Data Valid | — | 35 | ns | A1.6 |
| 7 | t_{TDOI} | CC ² | D | TCK Low to TDO Data Invalid | 0 | — | ns | A1.7 |
| 8 | t_{TDOHZ} | CC ² | D | TCK Low to TDO High Impedance | — | 30 | ns | A1.8 |
| 9 | t_{BSDV} | CC ² | D | TCK Falling Edge to Output Valid | — | 35 | ns | A1.9 |
| 10 | t_{BSDVZ} | CC ² | D | TCK Falling Edge to Output Valid out of High Impedance | — | 50 | ns | A1.10 |
| 11 | t_{BSDHZ} | CC ² | D | TCK Falling Edge to Output High Impedance | — | 50 | ns | A1.11 |
| 12 | t_{BSDST} | CC ² | D | Boundary Scan Input Valid to TCK Rising Edge | 50 | — | ns | A1.12 |
| 13 | t_{BSDHT} | CC ² | D | TCK Rising Edge to Boundary Scan Input Invalid | 50 | — | ns | A1.13 |

¹ These specifications apply to JTAG boundary scan only. JTAG timing specified at $V_{DD} = 3.0$ V to 3.6 V, $T_A = -40$ to 105 °C, and $CL = 50$ pF with SRC = 0b01.

² Parameter values guaranteed by design.

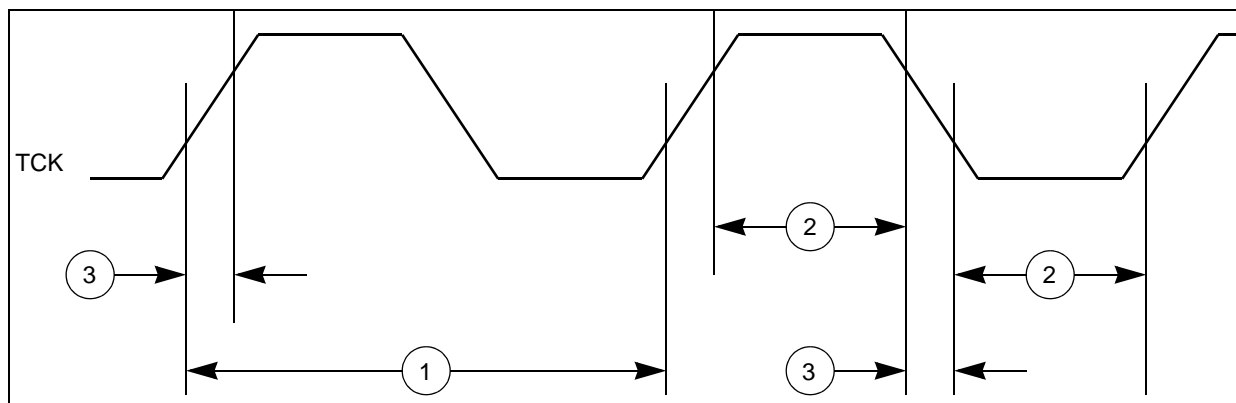


Figure 18. JTAG test clock input timing

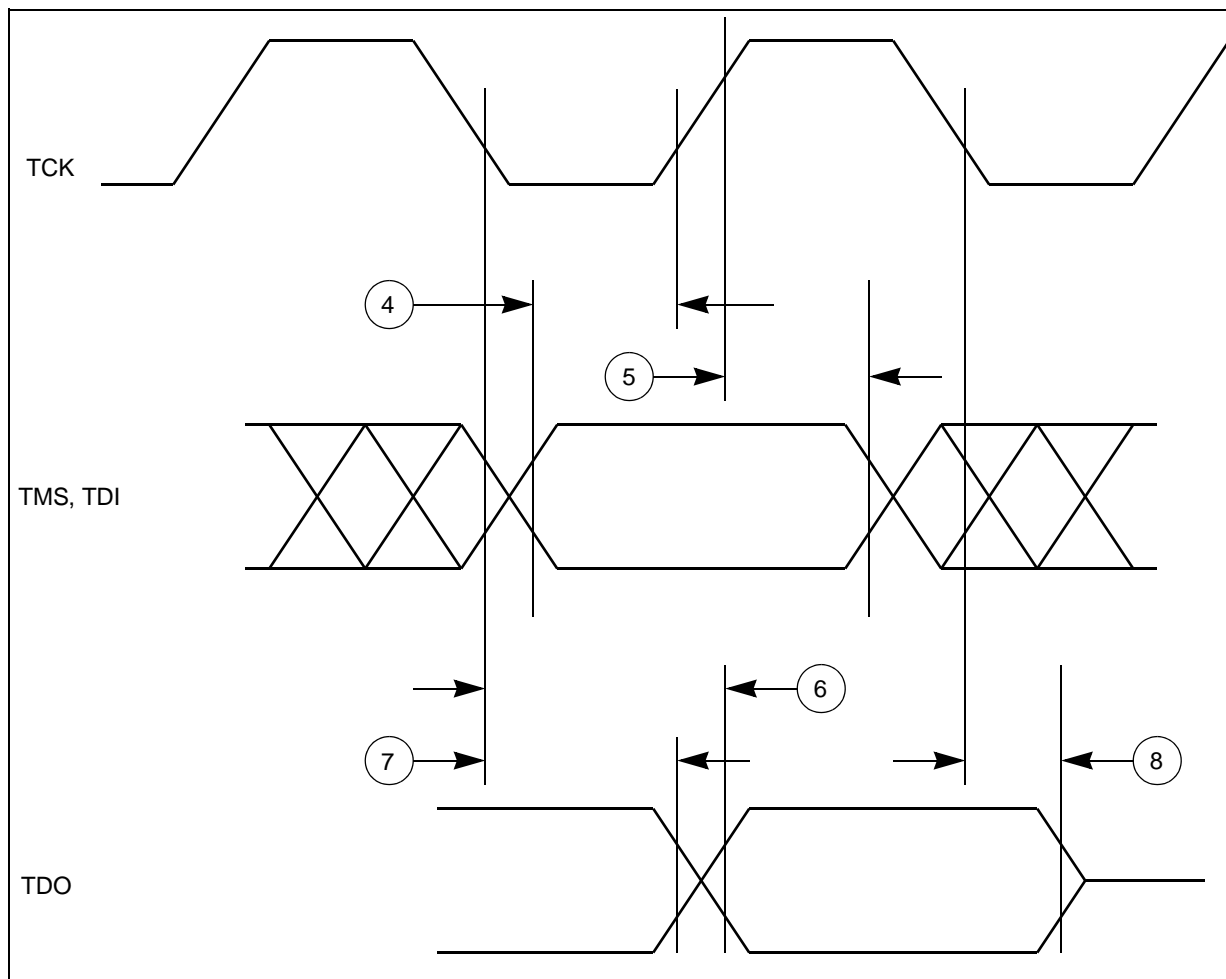


Figure 19. JTAG test access port timing

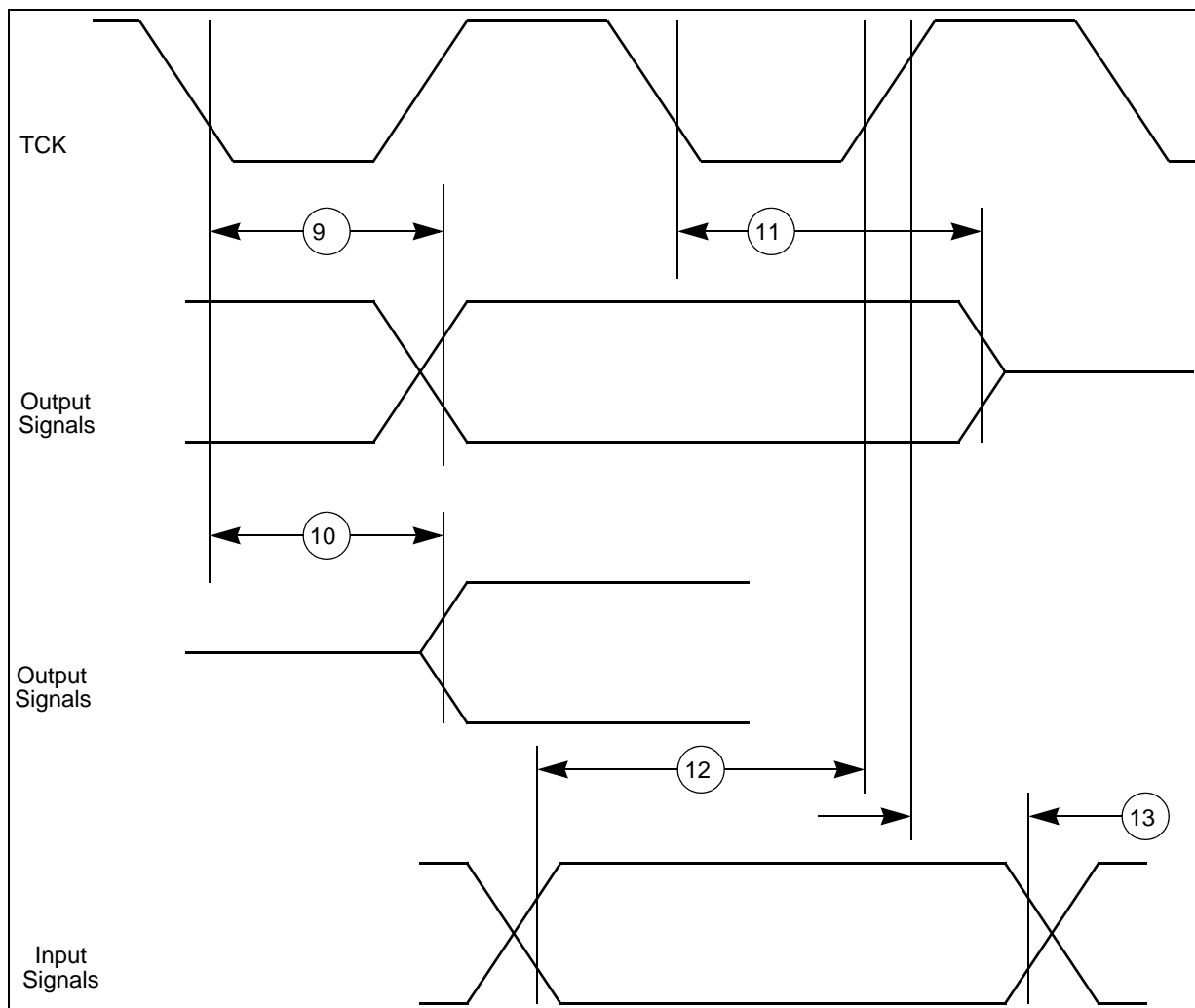


Figure 20. JTAG boundary scan timing

4.18.2 Nexus debug interface

Table 53. Nexus debug port timing¹

| Num | Symbol | CC ² | C | Characteristic | Min | Max | Unit | SpecID |
|-----|------------------------|-----------------|---|---|-----|-----|-------------|--------|
| 1 | t_{MCCYC} | CC ² | D | MCKO Cycle Time | 15 | — | ns | A2.1 |
| 2 | t_{MDC} | CC ² | D | MCKO Duty Cycle | 40 | 60 | % | A2.2 |
| 3 | t_{MDOV} | CC ² | D | MCKO Low to MDO Data Valid ³ | 0.1 | 0.2 | t_{MCCYC} | A2.3 |
| 4 | t_{MSEOV} | CC ² | D | MCKO Low to \overline{MSEO} Data Valid ³ | 0.1 | 0.2 | t_{MCCYC} | A2.4 |
| 5 | $t_{EVT OV}$ | CC ² | D | MCKO Low to \overline{EVTO} Data Valid ³ | 0.1 | 0.2 | t_{MCCYC} | A2.5 |
| 6 | t_{EVTIPW} | CC ² | D | \overline{EVTI} Pulse Width | 4 | — | t_{TCYC} | A2.6 |
| 7 | t_{EVTOPW} | CC ² | D | \overline{EVTO} Pulse Width | 1 | — | t_{MCCYC} | A2.7 |
| 8 | t_{TCYC} | CC ² | D | TCK Cycle Time ⁴ | 100 | — | ns | A2.8 |
| 9 | t_{TDC} | CC ² | D | TCK Duty Cycle | 40 | 60 | % | A2.9 |
| 10 | t_{NTDIS}, t_{NTMSS} | CC ² | D | TDI, TMS Data Setup Time | 25 | — | ns | A2.10 |
| 11 | t_{NTDIH}, t_{NTMSH} | CC ² | D | TDI, TMS Data Hold Time | 5 | — | ns | A2.11 |
| 12 | t_{JOV} | CC ² | D | TCK Low to TDO Data Valid | 0 | 35 | ns | A2.12 |

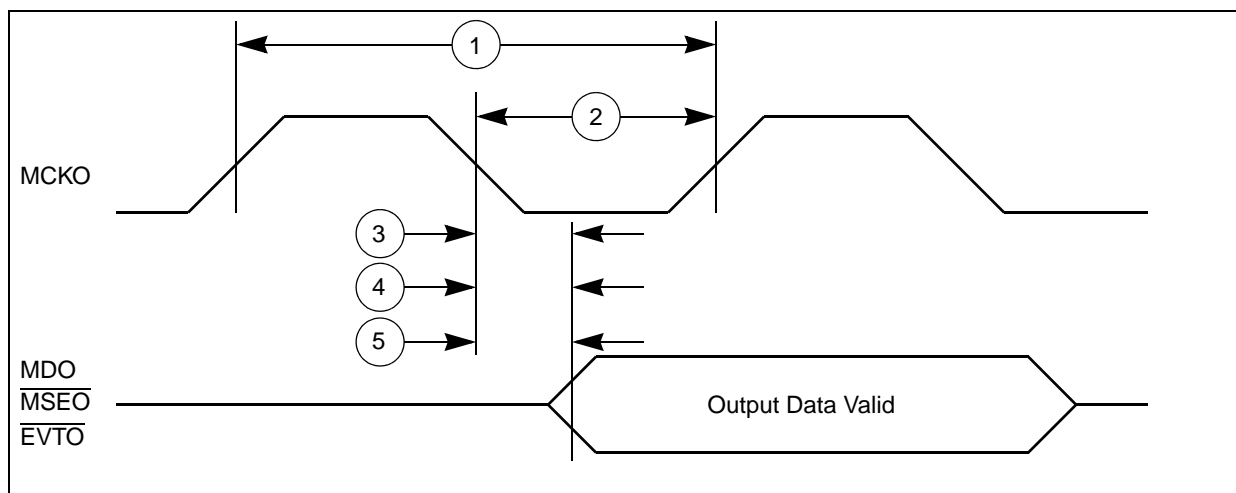
¹ JTAG specifications in this table apply when used for debug functionality. All Nexus timing relative to MCKO is measured from 50% of MCKO and 50% of the respective signal. Nexus timing specified at $V_{DD} = 3.0\text{ V to }3.6\text{ V}$, $T_A = -40\text{ to }105\text{ }^\circ\text{C}$, and $CL = 50\text{ pF}$ ($CI = 30\text{ pF}$ on MCKO), with $SRC = 0b10$ for MCKO and $0b11$ for others.

² Parameter values guaranteed by design.

³ MDO, \overline{MSEO} , and \overline{EVTO} data is held valid until next MCKO low cycle.

⁴ The system clock frequency needs to be three times faster than the TCK frequency.

Nexus Dual Data Rate is not supported. The timings are mentioned for dedicated pins on 416TEPBGA package. The max value for #2, 3, and 4 above, are 0.3 of t_{MCCYC} for shared Nexus ports.


Figure 21. Nexus output timing

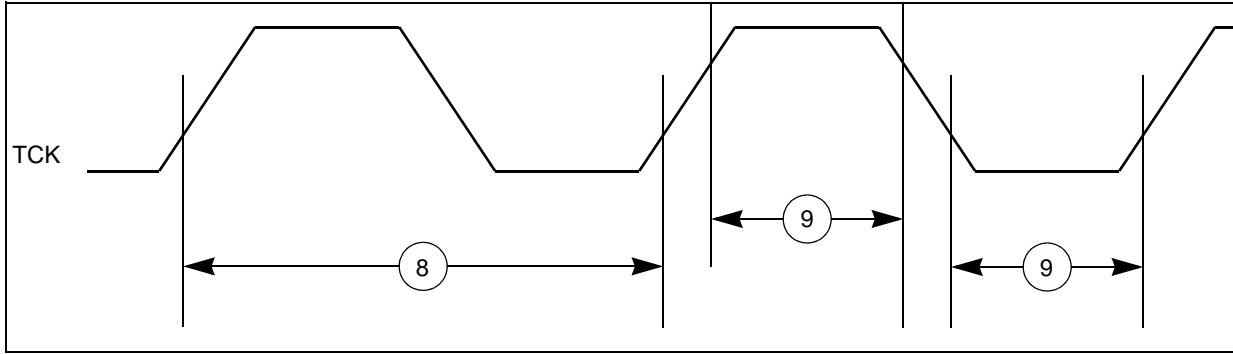


Figure 22. Nexus TCK timing

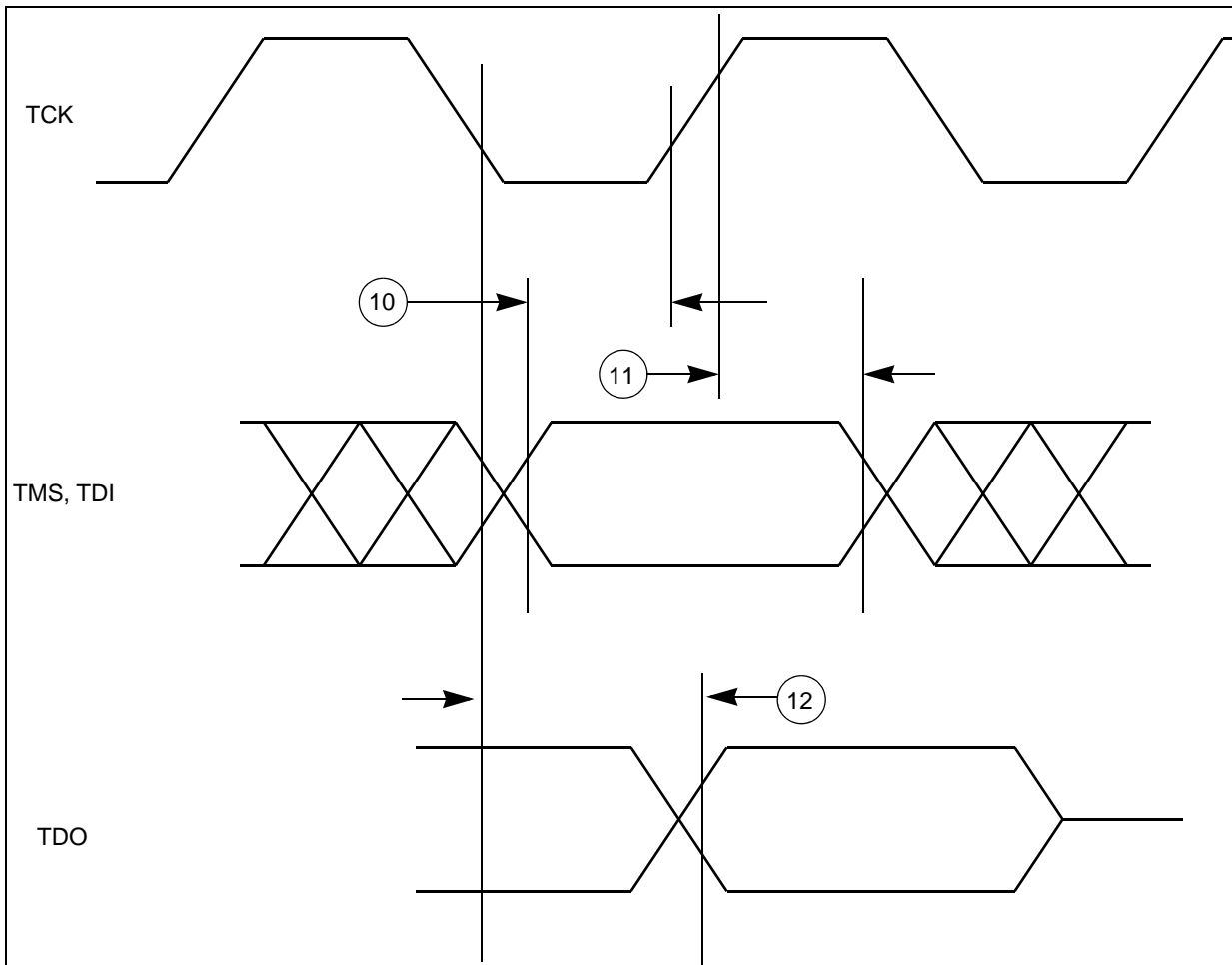


Figure 23. Nexus TDI, TMS, TDO timing

4.18.3 Interface to TFT LCD panels (DCU3 and DCULite)

Figure 24 depicts the LCD interface timing for a generic active matrix color TFT panel. In this figure signals are shown with positive polarity. The sequence of events for active matrix interface timing is:

- PCLK latches data into the panel on its positive edge (when positive polarity is selected). In active mode, PCLK runs continuously. This signal frequency could be from 5 to 66 MHz depending on the panel type.
- HSYNC causes the panel to start a new line. It always encompasses at least one PCLK pulse.
- VSYNC causes the panel to start a new frame. It always encompasses at least one HSYNC pulse.
- DE acts like an output enable signal to the LCD panel. This output enables the data to be shifted onto the display. When disabled, the data is invalid and the trace is off.

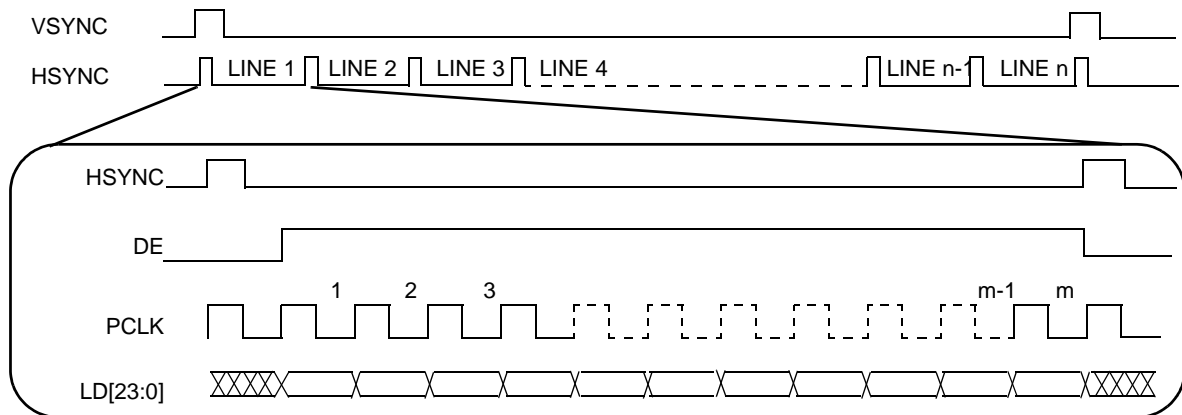


Figure 24. TFT LCD interface timing overview¹

4.18.3.1 Interface to TFT LCD panels—pixel level timings

Figure 25 depicts the horizontal timing (timing of one line), including both the horizontal sync pulse and data. All parameters shown in the diagram are programmable. This timing diagram corresponds to positive polarity of the PCLK signal (meaning the data and sync signals change on the rising edge) and active-high polarity of the HSYNC, VSYNC and DE signals. The user can select the polarity of the HSYNC and VSYNC signals via the SYN_POL register, whether active-high or active-low. The default is active-high. The DE signal is always active-high.

Pixel clock inversion and a flexible programmable pixel clock delay are also supported. They are programmed via the DCU Clock Confide Register (DCCR) in the system clock module.

The DELTA_X and DELTA_Y parameters are programmed via the DISP_SIZE register. The PW_H, BP_H and FP_H parameters are programmed via the HSYN PARA register. The PW_V, BP_V and FP_V parameters are programmed via the VSYN_PARA register.

1. In Figure 24, the “LD[23:0]” signal is “line data,” an aggregation of the DCU's RGB signals—R[0:7], G[0:7] and B[0:7].

Table 54. LCD interface timing parameters—horizontal and vertical

| Num | Symbol | C | Characteristic | Value | Unit | SpecID | |
|-----|-----------|-----------------|----------------|----------------------------|---|--------|-------|
| 1 | t_{PCP} | CC ¹ | D | Display pixel clock period | 31.25 | ns | A3.1 |
| 2 | t_{PWH} | CC ¹ | D | HSYNC pulse width | $PW_H \times t_{PCP}$ | ns | A3.2 |
| 3 | t_{BPH} | CC ¹ | D | HSYNC back porch width | $BP_H \times t_{PCP}$ | ns | A3.3 |
| 4 | t_{FPH} | CC ¹ | D | HSYNC front porch width | $FP_H \times t_{PCP}$ | ns | A3.4 |
| 5 | t_{SW} | CC ¹ | D | Screen width | $DELTA_X \times t_{PCP}$ | ns | A3.5 |
| 6 | t_{HSP} | CC ¹ | D | HSYNC (line) period | $(PW_H + BP_H + FP_H + DELTA_X) \times t_{PCP}$ | ns | A3.6 |
| 7 | t_{PWV} | CC ¹ | D | VSYNC pulse width | $PW_V \times t_{HSP}$ | ns | A3.7 |
| 8 | t_{BPV} | CC ¹ | D | VSYNC back porch width | $BP_V \times t_{HSP}$ | ns | A3.8 |
| — | t_{FPV} | CC ¹ | D | VSYNC front porch width | $FP_V \times t_{HSP}$ | ns | A3.9 |
| — | t_{SH} | CC ¹ | D | Screen height | $DELTA_Y \times t_{HSP}$ | ns | A3.10 |
| — | t_{VSP} | CC ¹ | D | VSYNC (frame) period | $(PW_V + BP_V + FP_V + DELTA_Y) \times t_{HSP}$ | ns | A3.11 |

¹ Parameter values guaranteed by design.

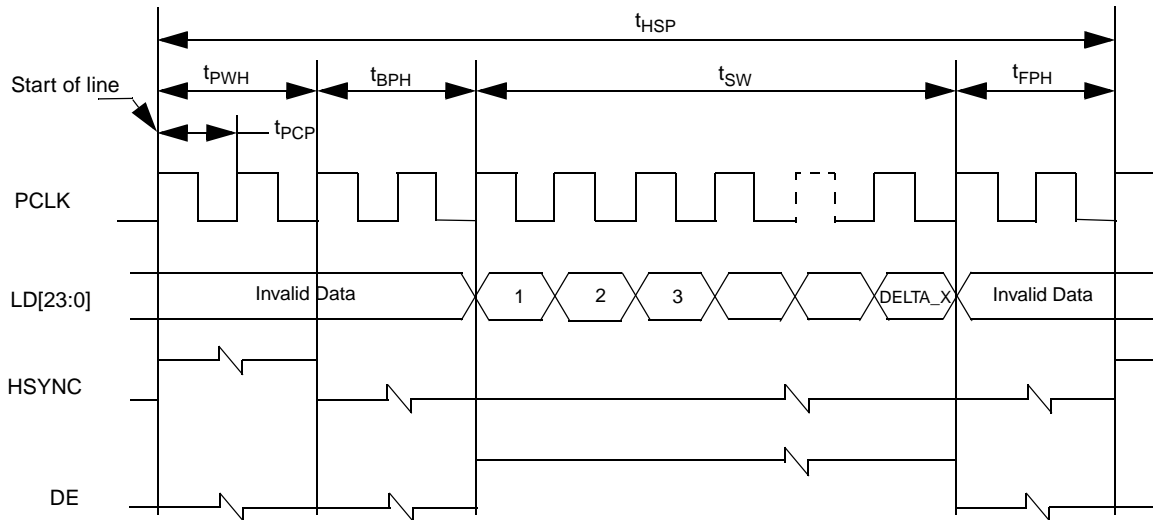


Figure 25. Horizontal sync timing

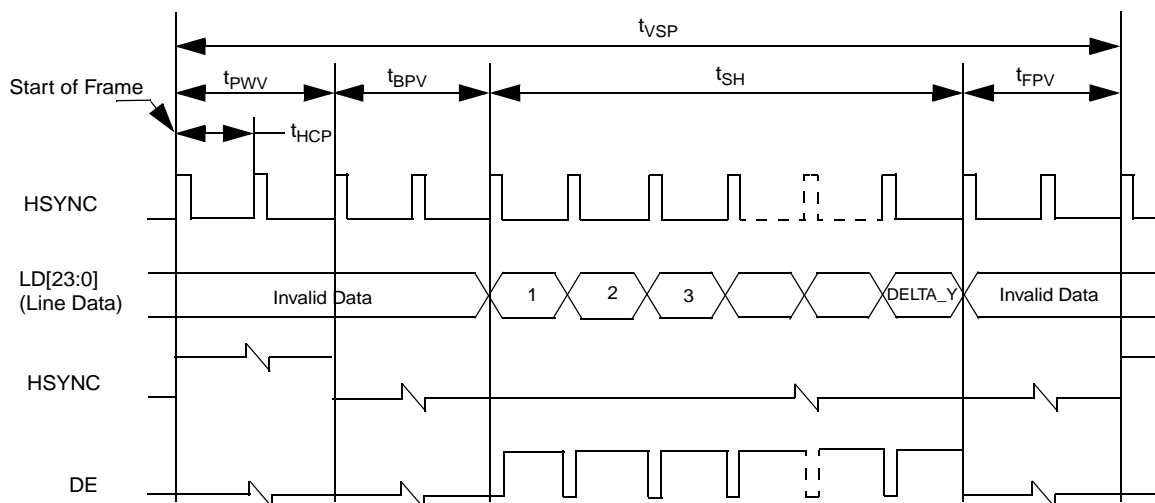


Figure 26. Vertical sync pulse

4.18.3.2 Interface to TFT LCD panels—access level

 Table 55. LCD interface timing parameters^{1,2,3,4}—Access Level

| Num | Symbol | C | Characteristic | Min. Value | Typical Value | Max. Value | Unit | SpecID |
|-----|-----------|-----------------|---|------------|---------------|------------|------|--------|
| 1 | t_{CKP} | CC ⁵ | D PDI Clock Period | 31.25 | — | — | ns | A3.12 |
| 2 | t_{CHD} | CC ⁵ | D Duty cycle | 40 | — | 60 | % | A3.13 |
| 3 | t_{DSU} | CC ⁵ | D interface data setup time | 6 | — | — | ns | A3.14 |
| 4 | t_{DHD} | CC ⁵ | D PDI interface data access hold time | 1 | — | — | ns | A3.15 |
| 5 | t_{CSU} | CC ⁵ | D PDI interface control signal setup time | 3 | — | — | ns | A3.16 |
| 6 | t_{CHD} | CC ⁵ | D PDI interface control signal hold time | 1 | — | — | ns | A3.17 |
| 7 | — | CC ⁵ | D TFT interface data valid after pixel clock | — | — | 6 | ns | A3.18 |
| 8 | — | CC ⁵ | D TFT interface HSYNC valid after pixel clock | — | — | 5 | ns | A3.19 |
| 9 | — | CC ⁵ | D TFT interface VSYNC valid after pixel clock | — | — | 5.5 | ns | A3.20 |
| 10 | — | CC ⁵ | D TFT interface DE valid after pixel clock | — | — | 5.6 | ns | A3.21 |
| 11 | — | CC ⁵ | D TFT interface hold time for data and control bits | 2 | — | — | ns | A3.22 |
| 12 | — | CC ⁵ | D Relative skew between the data bits | — | — | 3.7 | ns | A3.23 |

¹ The characteristics in this table are based on the assumption that data is output at +ve edge and displays latch data on -ve edge.

² Intra-bit skew is less than 2 ns.

³ Load CL = 50 pf for frequency up to 20 MHz.

⁴ Load CL = 25 pf for display freq from 20 to 32 MHz.

⁵ Parameter values guaranteed by design.

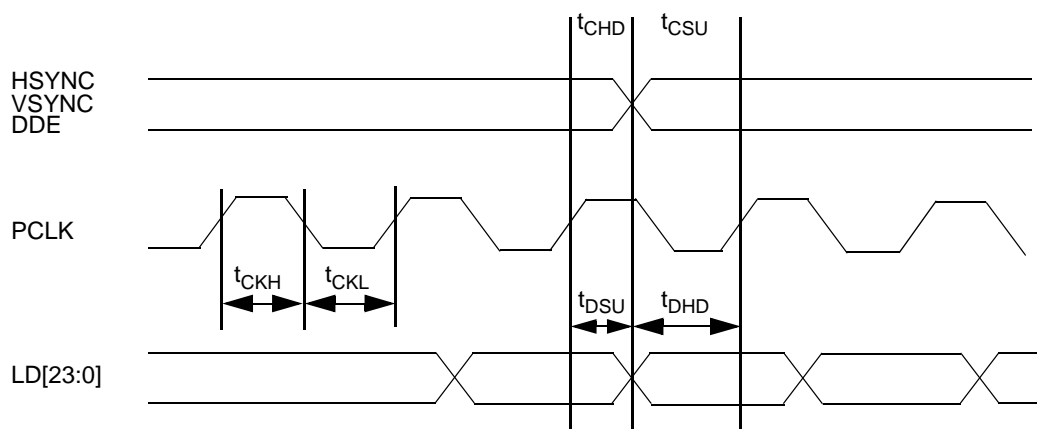


Figure 27. LCD Interface timing parameters—access level

4.18.4 RSDS interface to TFT LCD panels

Table 56. RSDS electrical characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|--------------|----|-----------|---|---|-----|-----|---------|--------|
| | | | | Min | Typ | Max | | |
| AVDD | SR | P | Voltage on VSSE_A pin with respect to ground (V_{SS}) | — | — | — | V | A4.1 |
| I_{DDTX} | SR | P | Current Consumption: RSDS Transmitter — Single Cell | — | 2.7 | — | mA | A4.2 |
| I_{DDPD} | SR | P | Power Down Current | — | 10 | — | μ A | A4.3 |
| I_{DDBG} | SR | P | Current Consumption of Bandgap and buffer | — | 100 | — | μ A | A4.4 |
| Fmax | SR | P | Data Frequency | — | 60 | 85 | MHz | A4.5 |
| V_{OD} | SR | P | Differential Output Voltage | $R_L = 100$ Ohms | 200 | 400 | mV | A4.6 |
| V_{OFF} | SR | P | Offset Voltage | $V_{CM} \pm 5\%$ | 1.2 | 1.5 | V | A4.7 |
| t_R / t_F | SR | P | Output Rise / Fall times | 20% to 80%, $V_{OD}=200$ mV, $C_L = 5$ pF | 500 | — | ps | A4.8 |
| t_{Xdelay} | SR | P | Tx Delay | — | 3 | — | ns | A4.9 |
| | SR | P | Termination Resistance (external) | 5% variation | 100 | — | Ohms | A4.10 |
| | SR | P | Transmitter Settling time | After power down, high to low | 10 | — | μ s | A4.11 |
| | SR | D | Transmitter Delay | Data in to Tx out | 8 | — | ns | A4.12 |

¹ $V_{DDA} = 3.3$ V \pm 10% $T_A = -40$ to 105 °C, unless otherwise specified.

² All values need to be confirmed during device validation.

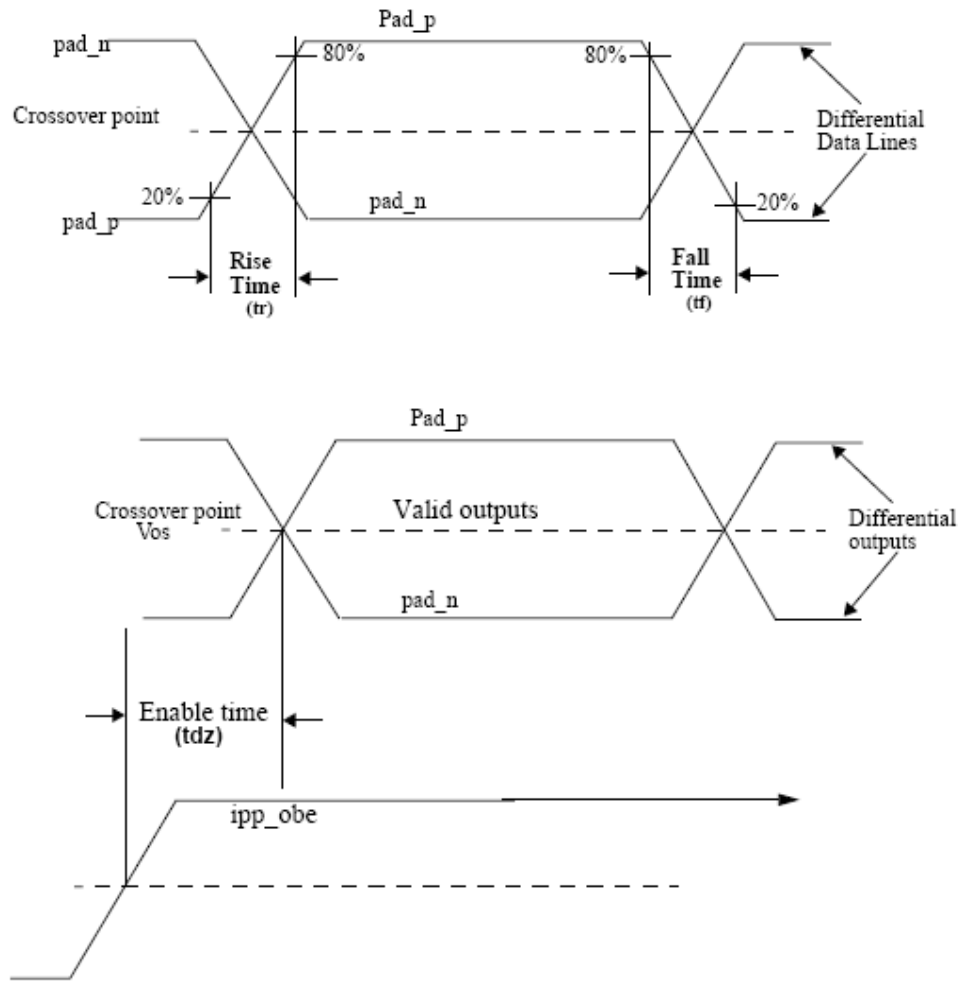


Figure 28. TCON/RSDS timing diagram

4.18.5 DRAM interface

DDR Interface specification from ‘MCD — 32 Bit Automotive MCU — CMOS090LP2’ I/O Pad Specification Revision 1.5 — May14th 2008.

This device supports SDR, DDR1, DDR2 half and full strengths, as well as LPDDR half and full speeds. Table 57 shows the SRE settings for the different modes.

Table 57. Pad mode configurations

| ipp_sre[2:0] | Mode |
|--------------|-------------------------|
| 000 | 1.8V LPDDR Half Speed |
| 001 | 1.8V LPDDR Full Speed |
| 010 | 1.8V DDR2 Half Strength |
| 011 | 2.5V DDR1 |
| 100 | Not supported |
| 101 | Not supported |
| 110 | 1.8V DDR2 Full Strength |
| 111 | SDR |

NOTE:

The specifications given in Table 58 are preliminary.

Table 58. LPDDR, DDR, and DDR2 (DDR2-250) SDRAM timing specifications^{1 2 3}

| No. | Symbol | Parameter | Min | Max | Unit |
|-----|------------------------|--|---------------------------------|---------------------------------|------|
| 1 | F | CC Frequency of Operation (Clock Period) | N/A | 125 | MHz |
| 1.1 | t _{CK} | CC Clock period | N/A | 8 | ns |
| 2 | V _{IX-AC} | CC MCK AC differential crosspoint voltage ⁴ | V _{DDE_DR} × 0.5 – 0.1 | V _{DDE_DR} × 0.5 + 0.1 | V |
| 3 | t _{CH} | CC CK HIGH pulse width ^{4, 5} | 0.47 | 0.53 | TCK |
| 4 | t _{CL} | CC CK LOW pulse width ^{4, 5} | 0.47 | 0.53 | tCK |
| 5 | t _{DQSS} | CC Skew between MCK and DQS transitions ^{5, 6} | 150 | 150 | ps |
| 6 | t _{OS(base)} | CC Address and control output setup time relative to MCK rising edge ^{5, 6} | (tCK/2) – 1000 | N/A | ps |
| 7 | t _{OH(base)} | CC Address and control output hold time relative to MCK rising edge ^{5, 6} | (tCK/2) + 1000 | N/A | ps |
| 8 | t _{DS1(base)} | CC DQ and DM output setup time relative to DQS ^{5, 6} | (tCK/4) – 750 | N/A | ps |
| 9 | t _{DH1(base)} | CC DQ and DM output hold time relative to DQS ^{5, 6} | (tCK/4) + 750 | N/A | ps |
| 10 | t _{DQSQ} | CC DQS-DQ skew for DQS and associated DQ inputs ⁵ | –(tCK/4) – 600 | (tCK/4) – 600 | ps |
| 11 | t _{DQSEN} | CC DQS window start position related to CAS read command ^{4, 5, 6, 7, 8} | TBD | TBD | ps |

¹ At recommended operating conditions with V_{DDE_DR} of ±5%.

² V_{DDE_DR} value is 1.8 for DDR2 mode, 2.5 V for DDR1 mode, and 1.8 V for LPDDR mode.

³ C_Z at –40, 140, 25 °C.

- ⁴ Measured with clock pin loaded with differential 100 ohm termination resistor.
- ⁵ All transitions measured at mid-supply ($V_{DDE_DR}/2$).
- ⁶ Measured with all outputs except the clock loaded with 50 ohm termination resistor to $V_{DDE_DR}/2$.
- ⁷ In this window, the first rising edge of DQS should occur. From the start of the window to DQS rising edge, DQS should be low.
- ⁸ Window position is given for $t_{DQSEN} = 2.0 t_{CK}$. For other values of t_{DQSEN} , window position is shifted accordingly.

4.18.5.1 2.5V DDR1

Table 59. SSTL_2 Class II 2.5V DDR DC specifications

| Symbol | C | Parameter | Condition | Min | Nom | Max | Units | Notes | SpecID |
|--------------|---|------------------------------|--------------------|-------------------|------|------------------|---------|---|--------|
| Vddet | P | I/O Supply Voltage | — | 2.30 | 2.50 | 2.70 | V | JESD8-9B | A5.1 |
| Vdd | P | Core Supply Voltage | — | 1.08 | 1.20 | 1.32 | V | — | A5.2 |
| Vref(dc) | P | Input Reference Voltage | — | 1.13 | 1.25 | 1.38 | V | JESD8-9B | A5.3 |
| Vtt | P | Termination Voltage | — | $V_{ref} - 0.04$ | vref | $V_{ref} + 0.04$ | V | JESD8-9B | A5.4 |
| $V_{ih(dc)}$ | C | DC Input Logic High | — | $V_{ref} + 0.15$ | — | $v_{ddet} + 0.3$ | V | JESD8-9B | A5.5 |
| $V_{il(dc)}$ | C | DC Input Logic Low | — | -0.3 | — | $V_{ref} - 0.15$ | V | JESD8-9B | A5.6 |
| $V_{ih(ac)}$ | C | AC Input Logic High | — | $V_{ref} + 0.31$ | — | — | V | JESD8-9B | A5.7 |
| $V_{il(ac)}$ | C | AC Input Logic Low | — | — | — | $V_{ref} - 0.31$ | V | JESD8-9B | A5.8 |
| I_{in} | P | Pad input Leakage Current | — | — | — | ± 10 | μA | — | A5.9 |
| V_{oh} | C | Output High Voltage Level | — | $v_{ddet} - 0.35$ | — | — | V | — | A5.10 |
| V_{ol} | C | Output Low Voltage Level | — | — | — | 0.35 | V | — | A5.11 |
| $I_{oh(dc)}$ | C | Output min source dc current | $V_{out} = V_{oh}$ | -16.2 | — | — | mA | $v_{ddet} = 2.3 V$ $V_{oh} = 1.95 V$ | A5.12 |
| $I_{ol(dc)}$ | C | Output min sink dc current | $V_{out} = V_{ol}$ | 16.2 | — | — | mA | $v_{ddet} = 2.3 V$ $V_{ol} = 0.35 V$ | A5.13 |

The SSTL_2 differential input switch point is at $V_{ref} = 0.50 \times V_{ddet}$.

Note that the JEDEC SSTL_2 specifications (JESD8-9B) for an SSTL interface for class II operation supersedes any specification in this document.

The SSTL_2 Class II output with `ipp_sre[2:0]` set to enabling SSTL_2 2.5V DDR1 mode, at the destination, have a rise/fall time (10–90%) between 1 ns and 2 ns over process, voltage, and temperature driving a 70 ohm transmission line with 0.167 ns td terminated at the destination with 70 ohms to Vtt ($0.5 \times v_{ddet}$) with 4.0 pf, representing the DDR input capacitance.

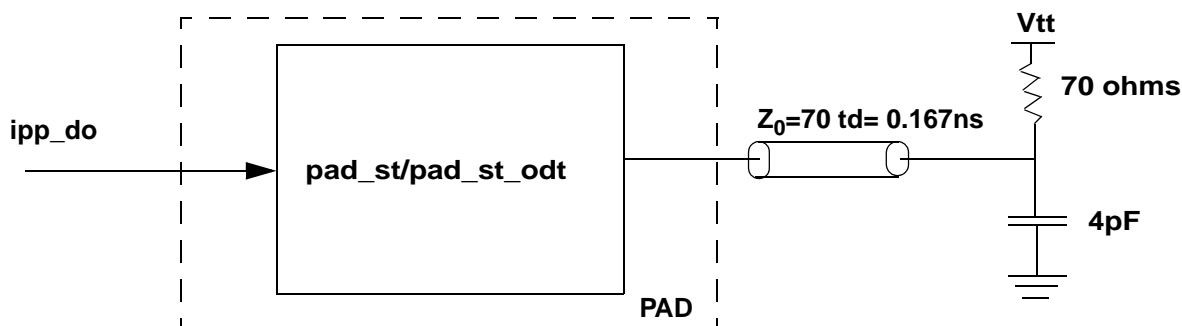


Figure 29. SSTL_2 Class II test load

4.18.5.2 1.8V DDR2

Table 60. SSTL_18 Class II 1.8V DDR2 DC specifications

| Symbol | C | Parameter | Condition | Min | Nom | Max | Units | Notes | SpecID |
|----------|---|------------------------------|------------|--------------|------|--------------|-------|--|--------|
| Vddet | P | I/O Supply Voltage | — | 1.7 | 1.8 | 1.9 | V | JESD8-15A | A5.14 |
| Vdd | P | Core Supply Voltage | — | 1.08 | 1.2 | 1.32 | V | — | A5.15 |
| Vref(dc) | P | Input Reference Voltage | — | 0.833 | 0.9 | 1.0869 | V | JESD8-15A | A5.16 |
| Vtt | P | Termination Voltage | — | Vref – 0.04 | Vref | Vref + 0.04 | V | JESD8-15A | A5.17 |
| Vih(dc) | C | DC Input Logic High | — | Vref + 0.125 | — | vddet + 0.3 | V | JESD8-15A | A5.18 |
| Vil(dc) | C | DC Input Logic Low | — | –0.3 | — | Vref – 0.125 | V | JESD8-15A | A5.19 |
| Vih(ac) | C | AC Input Logic High | — | Vref + 0.25 | — | — | V | JESD8-15A | A5.20 |
| Vil(ac) | C | AC Input Logic Low | — | — | — | Vref – 0.25 | V | JESD8-15A | A5.21 |
| Iin | P | Pad input Leakage Current | — | — | — | ±10 | µA | — | A5.22 |
| Voh | C | Output High Voltage Level | — | vddet – 0.28 | — | — | V | — | A5.23 |
| Vol | C | Output Low Voltage Level | — | — | — | 0.28 | V | — | A5.24 |
| Ioh(dc) | C | Output min source dc current | Vout = Voh | –13.4 | — | — | mA | JESD8-15A vddet = 1.7 V Voh = 1.42 V | A5.25 |
| Iol(dc) | C | Output min sink dc current | Vout = Vol | 13.4 | — | — | mA | JESD8-15A vddet = 1.7 V Vol = 0.28 V | A5.26 |

The SSTL_18 differential input switch point is at $V_{ref} = 0.50 \times V_{ddet}$.

Note that the Jeduc SSTL_18 specifications (JESD8-15a) for an SSTL interface for class II operation supersedes any specification in this document.

The SSTL_18 Class II output with ipp_sr[2:0] set to enabling sstl_2 1.8V DDR2 mode, at the destination, have a rise/fall time (10–90%) between 0.4 ns and 1.0 ns over process, voltage, and temperature driving a 70 ohm transmission line with 0.167 ns

td terminated at the destination with 70 ohms to Vtt (0.5 × Vddet) with 4.0 pf, representing the DDR2 input capacitance. See Figure 30 (SSTL_18 Class II test load).

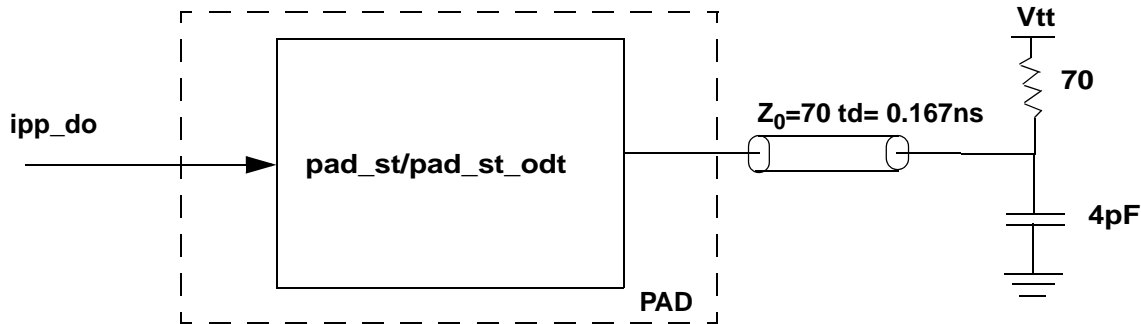


Figure 30. SSTL_18 Class II test load

4.18.5.3 1.8V LPDDR

Table 61. 1.8V LPDDR DC specifications

| Symbol | C | Parameter | Condition | Min | Nom | Max | Units | Notes | SpecID |
|---------------------------|---|---------------------------|--------------------------|-------------|-----|-------------|-------|----------|--------|
| vddet | P | I/O Supply Voltage | — | 1.7 | 1.8 | 1.9 | V | JESD79-4 | A5.27 |
| vdd | P | Core Supply Voltage | — | 1.08 | 1.2 | 1.32 | V | — | A5.28 |
| Data Inputs (DQ, DM, DQS) | | | | | | | | | A5.29 |
| V _{ih(dc)} | C | DC Input Logic High | — | vddet × 0.7 | — | vddet+0.3 | V | JESD79-4 | A5.30 |
| V _{il(dc)} | C | DC Input Logic Low | — | -0.3 | — | vddet × 0.3 | V | JESD79-4 | A5.31 |
| V _{ih(ac)} | C | AC Input Logic High | — | vddet × 0.8 | — | vddet + 0.3 | V | JESD79-4 | A5.32 |
| V _{il(ac)} | C | AC Input Logic low | — | -0.3 | — | vddet × 0.2 | V | JESD79-4 | A5.33 |
| Data Outputs (DQ, DQS) | | | | | | | | | A5.34 |
| V _{oh} | C | Output High Voltage Level | I _{oh} = -0.1mA | vddet × 0.9 | — | — | V | JESD79-4 | A5.35 |
| V _{ol} | C | Output Low Voltage Level | I _{ol} = 0.1mA | — | — | vddet × 0.1 | V | JESD79-4 | A5.36 |

Note that the final JEDEC LPDDR SDRAM specifications (JESD79-4) for LPDDR operation supersedes any specification in this document.

The SSTL_18 output with ipp_sre[2:0] set to enabling 1.8V LPDDR mode, at the destination, have a rise/fall time (10–90%) between 0.4 ns and 1.0 ns over process, voltage, and temperature driving a 70 ohm transmission line with 0.167 ns td terminated at the destination with 70 ohms to Vtt (0.5 × vddet) with 4.0 pf, representing the DDR input capacitance. See Figure 30 (SSTL_18 Class II test load).

4.18.6 Video Input Unit timing

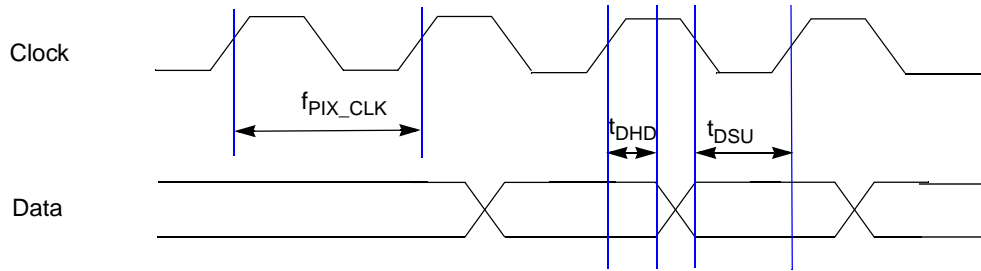


Figure 31. VIU2 timing diagram

Table 62. VIU2 timing parameters

| Parameter | C | Description | Min | Typ | Max | Unit | SpecID |
|---------------|---|----------------------------|-----|-----|-----|------|--------|
| f_{PIX_CK} | D | VIU2 pixel clock frequency | — | — | 64 | MHz | A6.1 |
| t_{DSU} | D | VIU2 data setup time | 4 | — | — | ns | A6.2 |
| t_{DHD} | D | VIU2 data hold time | 1 | — | — | ns | A6.3 |

4.18.7 External Interrupt (IRQ) and Non-Maskable Interrupt (NMI) Timing

Table 63. IRQ and NMI timing

| Num | Symbol | C | Characteristic | Min. Value | Max. Value | Unit | SpecID |
|-----|------------|-----------------|--|------------|------------|------|--------|
| 1 | t_{IPWL} | CC ¹ | IRQ/NMI Pulse Width Low | 200 | — | ns | A7.1 |
| 2 | t_{IPWH} | CC ¹ | IRQ/NMI Pulse Width High | 200 | — | ns | A7.2 |
| 3 | t_{ICYC} | CC ¹ | IRQ/NMI Edge to Edge Time ² | 400 | — | ns | A7.3 |

¹ Parameter values guaranteed by design.

² Applies when IRQ/NMI pins are configured for rising edge or falling edge events, but not both.

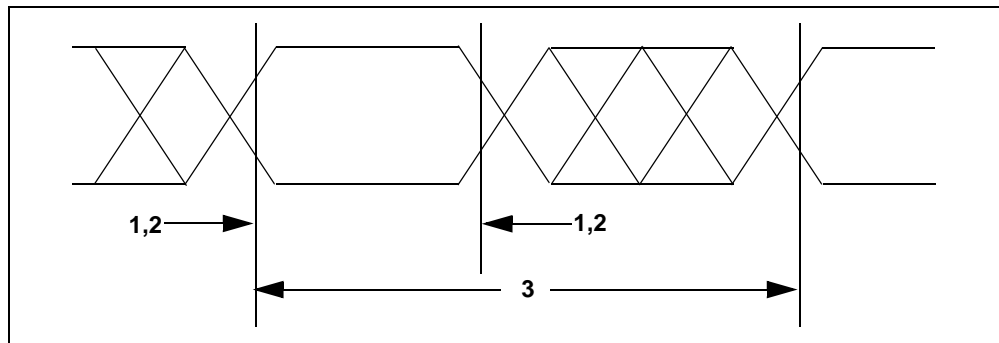


Figure 32. IRQ and NMI timing

4.18.8 eMIOS timing

Table 64. eMIOS timing¹

| Num | Symbol | C | Characteristic | Min. value ² | Max. value | Unit | SpecID |
|-----|-------------------|-----------------|----------------------------|-------------------------|------------|------------------|--------|
| 1 | t _{MIPW} | CC ³ | D eMIOS Input Pulse Width | 4 | — | t _{CYC} | A8.1 |
| 2 | t _{MOPW} | CC ³ | D eMIOS Output Pulse Width | 1 | — | t _{CYC} | A8.2 |

¹ eMIOS timing specified at f_{SYS} = 64 MHz, V_{DD12} = 1.14 V to 1.32 V, VDDE_x = 3.0 V to 5.5 V, T_A = -40 to 105 °C, and CL = 50 pF with SRC = 0b00.

² There is no limitation on the peripheral for setting the minimum pulse width, the actual width is restricted by the pad delays. Refer to the pad specification section for the details.

³ Parameter values guaranteed by design.

4.18.9 FlexCAN timing

The CAN functions are available as TX pins at normal I/O pads and as RX pins at the always on domain. There is no filter for the wakeup dominant pulse. Any high-to-low edge can cause wakeup if configured.

Table 65. FlexCAN timing¹

| Num | Symbol | C | Characteristic | Min. value | Max. value | Unit | SpecID |
|-----|--------------------|-----------------|---|------------|------------|------|--------|
| 1 | t _{CANOV} | CC ² | D CTNX Output Valid after CLKOUT Rising Edge (Output Delay) | — | 22.48 | ns | A10.1 |
| 2 | t _{CANSU} | CC ² | D CNRX Input Valid to CLKOUT Rising Edge (Setup Time) | — | 12.46 | ns | A10.2 |

¹ FlexCAN timing specified at f_{SYS} = 64 MHz, V_{DD12} = 1.14 V to 1.32 V, VDDE_x = 3.0 V to 5.5 V, T_A = -40 to 105 °C, and CL = 50 pF with SRC = 0b00.

² Parameter values guaranteed by design.

4.18.10 Deserial Serial Peripheral Interface (DSPI)

Table 66. DSPI timing¹

| Num | Symbol | C | Characteristic | Min | Max | Unit | SpecID |
|-----|------------------|-----------------|---|---------------------------|---------------------------|------|--------|
| 1 | t _{SCK} | CC ² | D SCK Cycle Time ^{3,4} | 60 ⁵ | — | ns | A11.1 |
| 2 | t _{CSC} | CC ² | D PCS to SCK Delay ⁶ | — | — | ns | A11.2 |
| 3 | t _{ASC} | CC ² | D After SCK Delay ⁷ | 20 | — | ns | A11.3 |
| 4 | t _{SDC} | CC ² | D SCK Duty Cycle | t _{SCK} /2 - 2ns | t _{SCK} /2 + 2ns | ns | A11.4 |
| 5 | t _A | CC ² | D Slave Access Time (PCSx active to SOUT driven) | — | 25 | ns | A11.5 |
| 6 | t _{DIS} | CC ² | D Slave SOUT Disable Time (PCSx inactive to SOUT High-Z or invalid) | — | 25 | ns | A11.6 |

Table 66. DSPI timing¹ (continued)

| Num | Symbol | C | Characteristic | Min | Max | Unit | SpecID | |
|-----|------------------|-----------------|-------------------------------|--|-----|------|--------|--------|
| 7 | t _{SUI} | CC ² | D Data Setup Time for Inputs | Master (MTFE = 0) | 20 | — | ns | A11.7 |
| | | | | Slave | 10 | — | ns | |
| | | | | Master (MTFE = 1, CPHA = 0) ⁸ | 5 | — | ns | |
| | | | | Master (MTFE = 1, CPHA = 1) | 35 | — | ns | |
| 8 | t _{HI} | CC ² | D Data Hold Time for Inputs | Master (MTFE = 0) | -4 | — | ns | A11.8 |
| | | | | Slave | 10 | — | ns | |
| | | | | Master (MTFE = 1, CPHA = 0) ⁸ | 26 | — | ns | |
| | | | | Master (MTFE = 1, CPHA = 1) | -4 | — | ns | |
| 9 | t _{SUO} | CC ² | D Data Valid (after SCK edge) | Master (MTFE = 0) | — | 15 | ns | A11.9 |
| | | | | Slave | — | 20 | ns | |
| | | | | Master (MTFE = 1, CPHA=0) | — | 30 | ns | |
| | | | | Master (MTFE = 1, CPHA=1) | — | 15 | ns | |
| 10 | t _{HO} | CC ² | D Data Hold Time for Outputs | Master (MTFE = 0) | -15 | — | ns | A11.10 |
| | | | | Slave | 5.5 | — | ns | |
| | | | | Master (MTFE = 1, CPHA = 0) | 0 | — | ns | |
| | | | | Master (MTFE = 1, CPHA = 1) | -15 | — | ns | |

¹ DSPI timing specified at VDDE_x = 3.0 V to 3.6 V, T_A = -40 to 105 °C, and CL = 50 pF with SRC = 0b10.

² Parameter values guaranteed by design.

³ The minimum SCK Cycle Time restricts the baud rate selection for given system clock rate.

⁴ The actual minimum SCK Cycle Time is limited by pad performance.

⁵ Maximum clock possible is System clock/2.

⁶ The maximum value is programmable in DSPI_CTARx[PSSCK] and DSPI_CTARx[CSSCK], program PSSCK=2 & CSSCK = 2

⁷ The maximum value is programmable in DSPI_CTARx[PASC] and DSPI_CTARx[ASC]

⁸ This delay value is corresponding to SMPL_PT=00b which is bit field 9 and 8 of DSPI_MCR register.

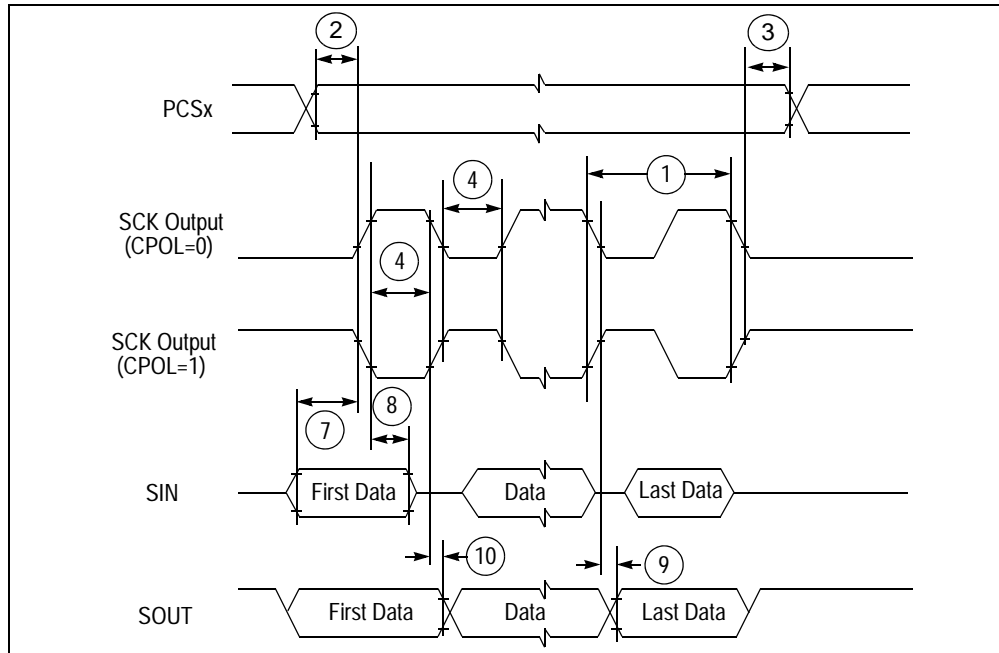


Figure 33. DSPI classic SPI timing — Master, CPHA = 0

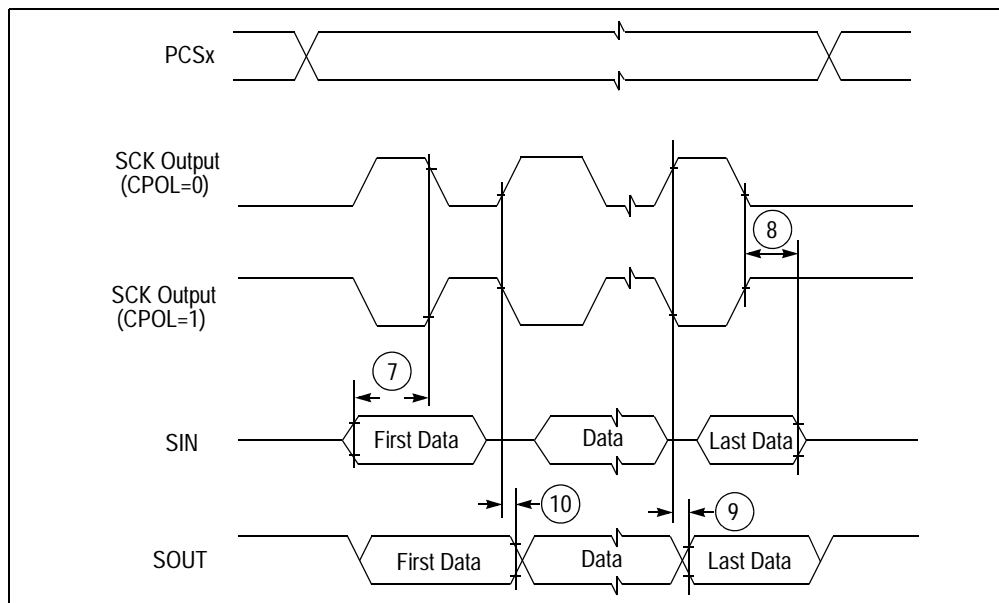


Figure 34. DSPI classic SPI timing — Master, CPHA = 1

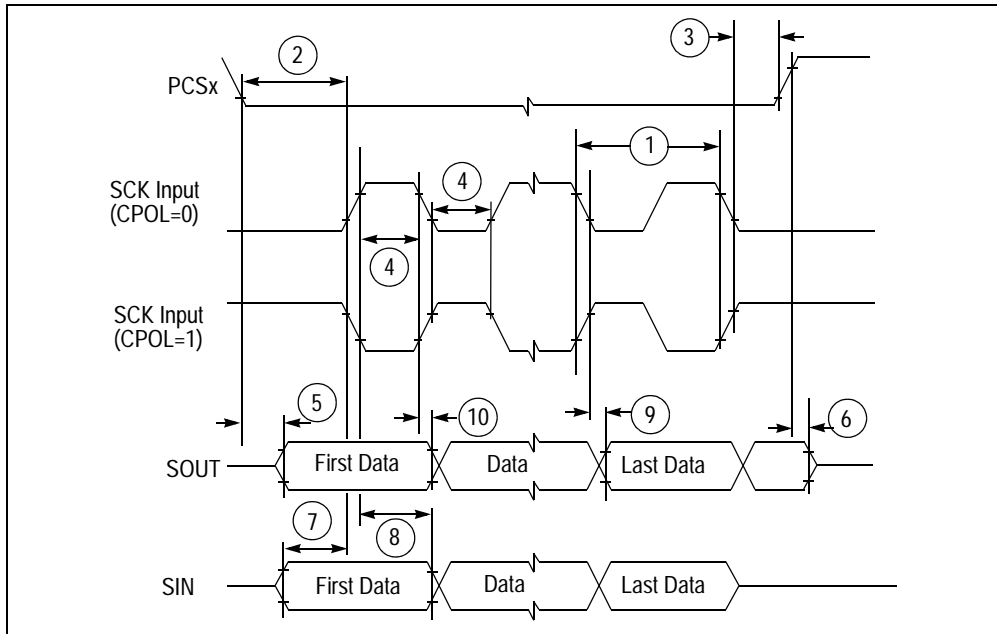


Figure 35. DSPI classic SPI timing — Slave, CPHA = 0

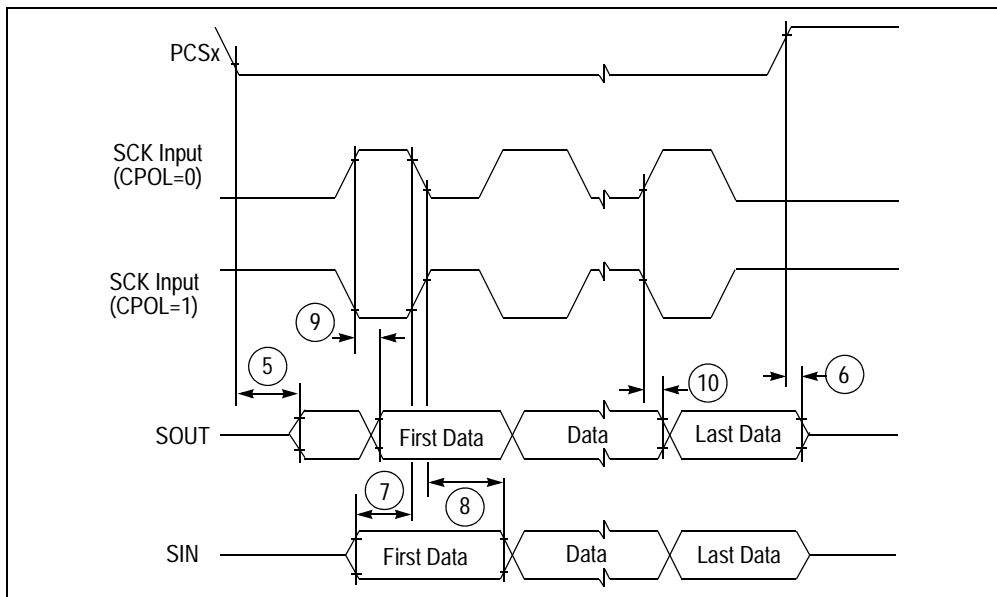


Figure 36. DSPI classic SPI timing — Slave, CPHA = 1

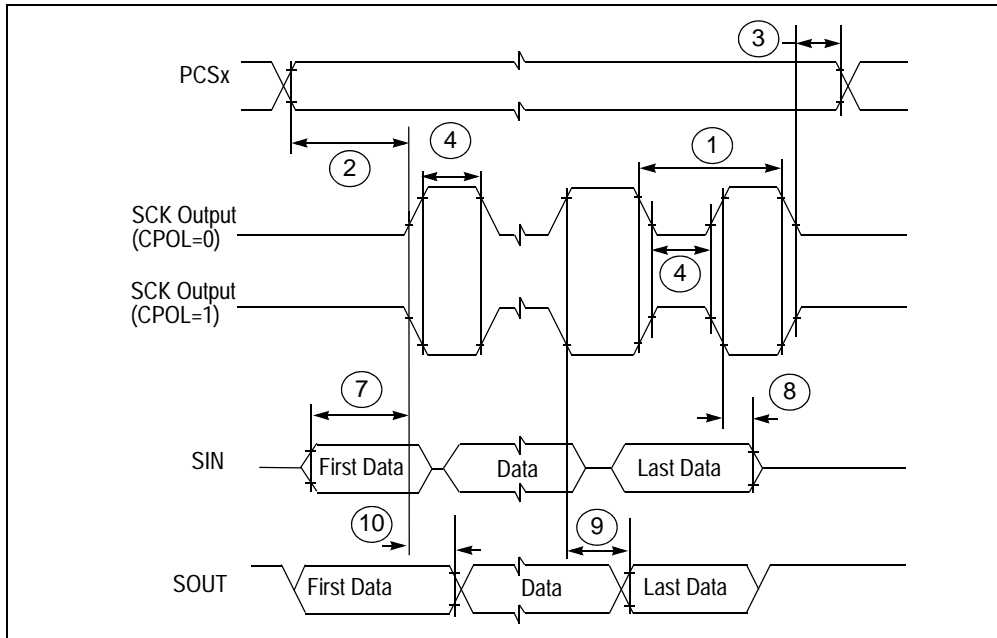


Figure 37. DSPI modified transfer format timing — Master, CPHA = 0

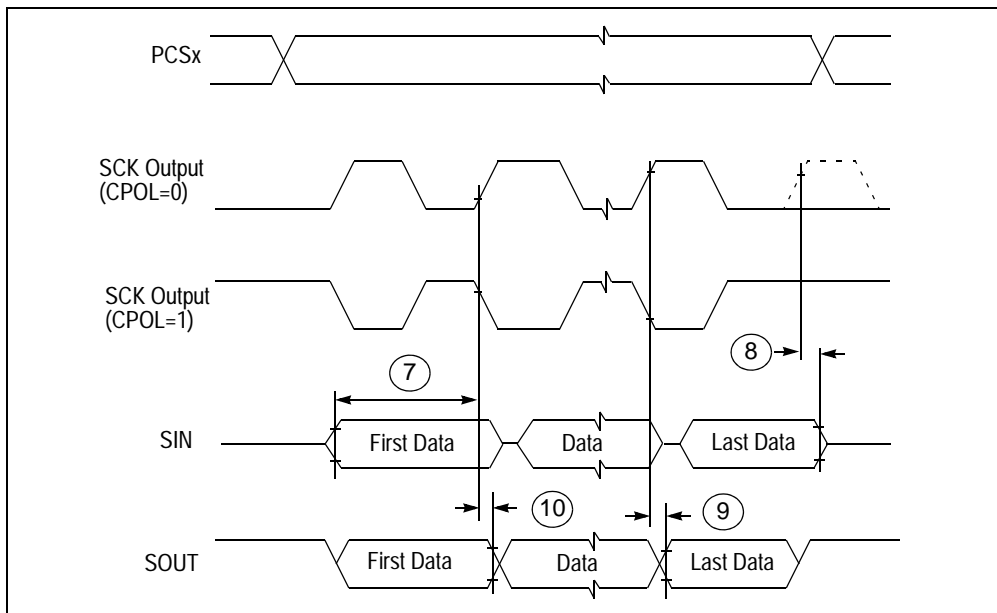


Figure 38. DSPI modified transfer format timing — Master, CPHA = 1

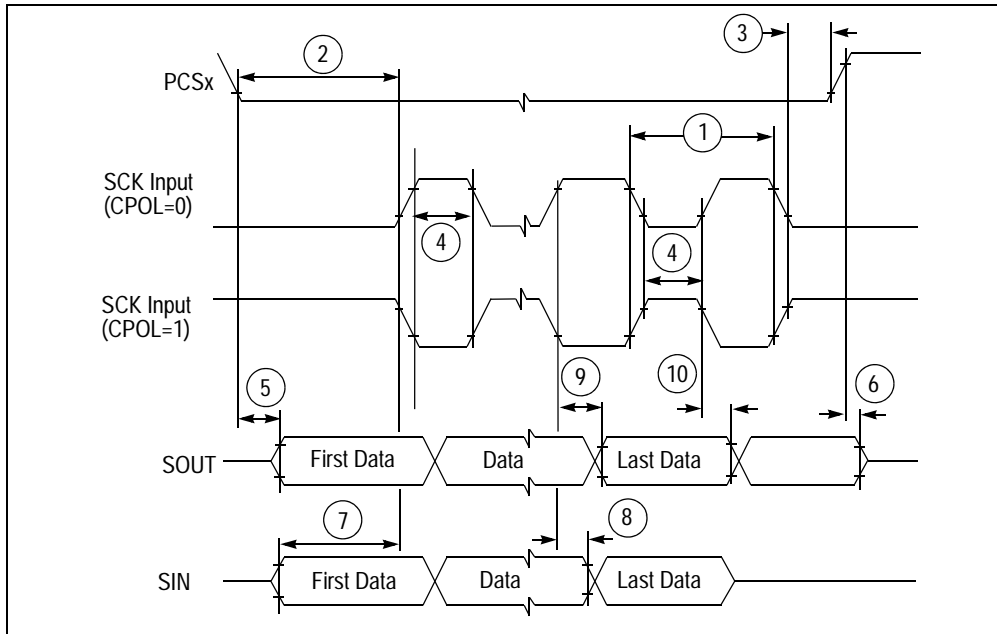


Figure 39. DSPI modified transfer format timing — Slave, CPHA = 0

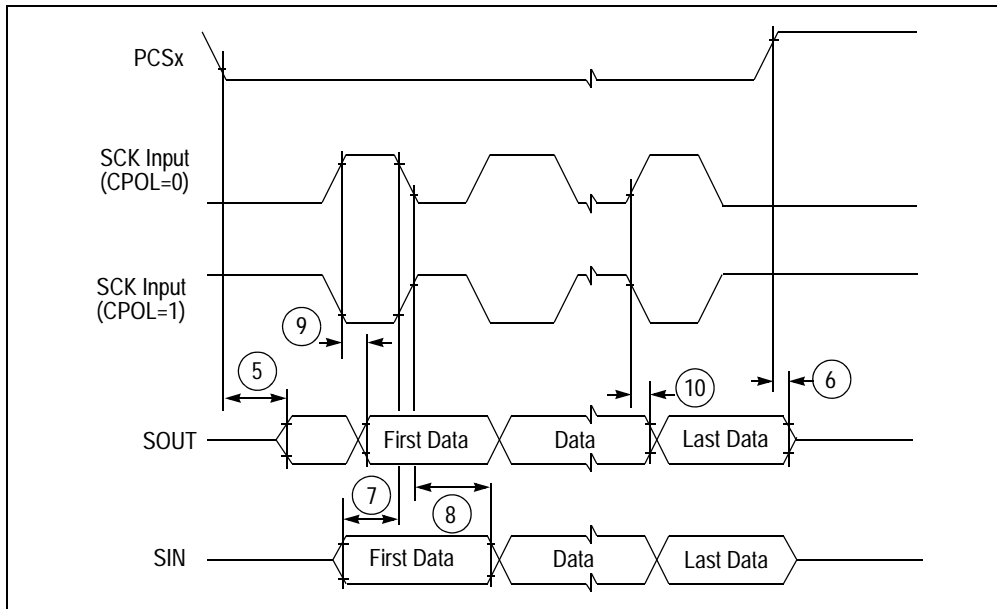


Figure 40. DSPI modified transfer format timing — Slave, CPHA = 1

4.18.11 I²C timing

Table 67. I²C input timing specifications—SCL and SDA

| Num | Symbol | C | Characteristic | Min. Value | Max. Value | Unit | SpecID |
|-----|--------|-----------------|--|------------|------------|---------------------------|--------|
| 1 | — | CC ¹ | D Start condition hold time | 2 | — | IP-Bus Cycle ² | A12.1 |
| 2 | — | CC ¹ | D Clock low time | 8 | — | IP-Bus Cycle ² | A12.2 |
| 4 | — | CC ¹ | D Data hold time | 0.0 | — | ns | A12.3 |
| 6 | — | CC ¹ | D Clock high time | 4 | — | IP-Bus Cycle ² | A12.4 |
| 7 | — | CC ¹ | D Data setup time | 0.0 | — | ns | A12.5 |
| 8 | — | CC ¹ | D Start condition setup time (for repeated start condition only) | 2 | — | IP-Bus Cycle ² | A12.6 |
| 9 | — | CC ¹ | D Stop condition setup time | 2 | — | IP-Bus Cycle ² | A12.7 |

¹ Parameter values guaranteed by design.

² Inter Peripheral Clock is the clock at which the I²C peripheral is working in the device

Table 68. I²C Output timing specifications—SCL and SDA

| Num | Symbol | C | Characteristic | Min. Value | Max. Value | Unit | SpecID |
|----------------|--------|-----------------|--|------------|------------|---------------------------|--------|
| 1 ¹ | — | CC ² | D Start condition hold time | 6 | — | IP-Bus Cycle ³ | A12.8 |
| 2 ¹ | — | CC ² | D Clock low time | 10 | — | IP-Bus Cycle ² | A12.9 |
| 3 ⁴ | — | CC ² | D SCL/SDA rise time | — | 99.6 | ns | A12.10 |
| 4 ¹ | — | CC ² | D Data hold time | 7 | — | IP-Bus Cycle ² | A12.11 |
| 5 ¹ | — | CC ² | D SCL/SDA fall time | — | 99.5 | ns | A12.12 |
| 6 ¹ | — | CC ² | D Clock high time | 10 | — | IP-Bus Cycle ² | A12.13 |
| 7 ¹ | — | CC ² | D Data setup time | 2 | — | IP-Bus Cycle ² | A12.14 |
| 8 ¹ | — | CC ² | D Start condition setup time (for repeated start condition only) | 20 | — | IP-Bus Cycle ² | A12.15 |
| 9 ¹ | — | CC ² | D Stop condition setup time | 10 | — | IP-Bus Cycle ² | A12.16 |

¹ Programming IBFD (I²C bus Frequency Divider) with the maximum frequency results in the minimum output timings listed. The I²C interface is designed to scale the data transition time, moving it to the middle of the SCL low period. The actual position is affected by the prescale and division values programmed in IFDR.

² Parameter values guaranteed by design.

³ Inter Peripheral Clock is the clock at which the I²C peripheral is working in the device

⁴ Because SCL and SDA are open-drain-type outputs, which the processor can only actively drive low, the time SCL or SDA takes to reach a high level depends on external signal capacitance and pullup resistor values.

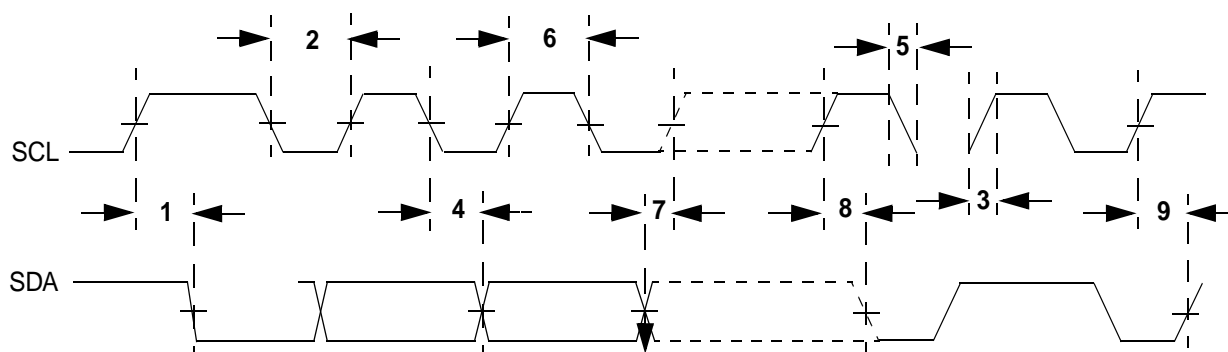


Figure 41. I²C input/output timing

4.18.12 QuadSPI timing

The following notes apply to [Table 69](#) and [Table 70](#):

- All data is based on a negative edge data launch from PXD20 and a positive edge data capture, as shown in the timing diagrams in this section.
- The supply conditions, over a temperature range of $-45\text{ }^{\circ}\text{C}$ to $125\text{ }^{\circ}\text{C}/150\text{ }^{\circ}\text{C}$, are as follows:
 - I/O voltage: 3.0 V, Core supply: 1.2 V
 - I/O voltage: 3.3 V, Core supply: 1.2 V
 - I/O voltage: 3.6 V, Core supply: 1.2 V
- The actual frequency at which the device can work will be a combination of this data and the clock pad profile.
- All measurements are considering 70% of VDDE levels for clock pin and 50% of VDDE level for data pins.
- Timings assume a setting of 0x0000_000x for QSPI_SMPR register (see the reference manual for details).
- A negative value of hold is an indication of pad delay on the clock pad (delay b/w actual edge capturing data in the device vs. edge appearing at the pin).
- Measurements are with a load of 50 pF on output pins
- The clock profile is measured at 30% to 70% levels of VDDE.

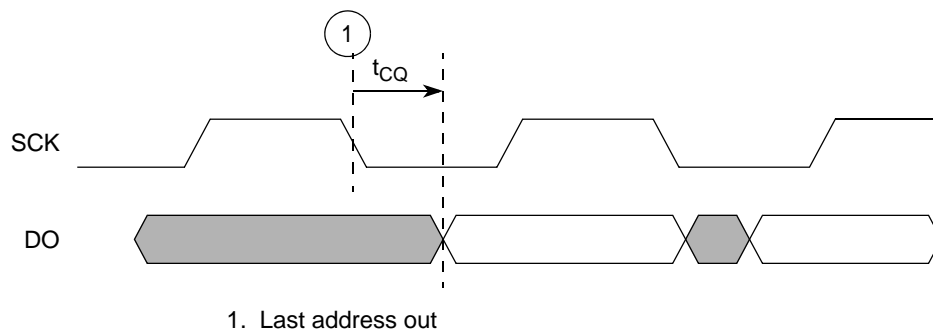
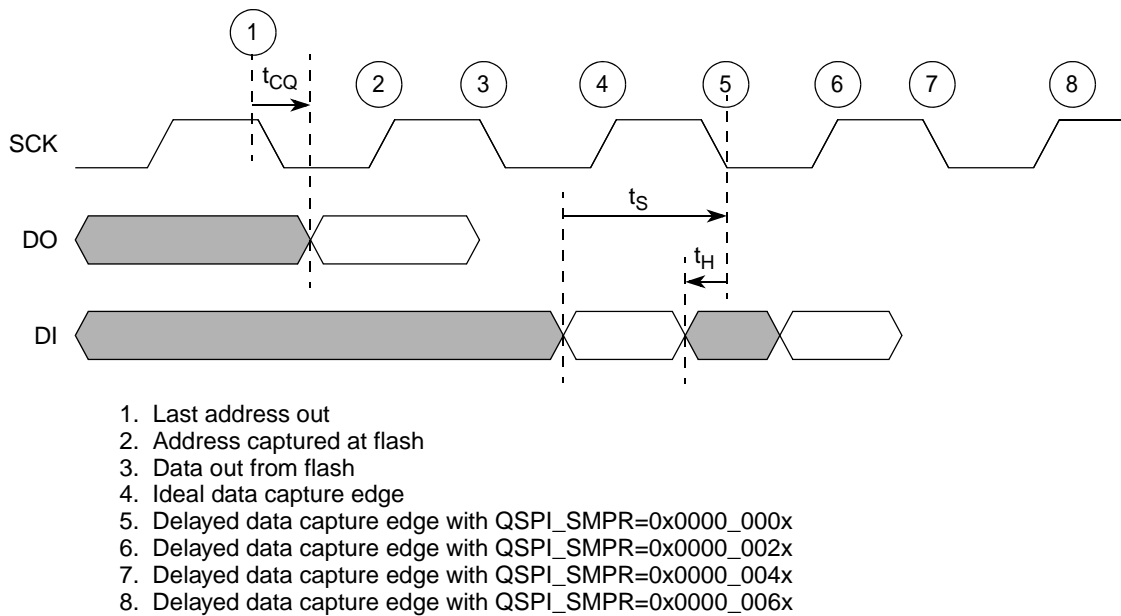
Table 69. QuadSPI timing specifications, maximum temperature 125 °C

| Symbol | C | Parameter | Value | | | Unit | SpecID |
|--------|----|-----------|-------|------|------|------|--------|
| | | | Min | Typ | Max | | |
| Tcq | CC | T | 3.8 | 5.3 | 12.1 | ns | A13.1 |
| Ts | CC | T | 7.6 | 9 | 13.2 | ns | A13.2 |
| Th | CC | T | -13 | -8.5 | -7.5 | ns | A13.3 |
| tr | CC | T | 0.5 | 0.7 | 1.0 | ns | A13.4 |
| tf | CC | T | 0.8 | 0.8 | 1.2 | ns | A13.5 |

The numbers in [Figure 42](#) and [Figure 43](#) correspond to events as described in [Table 70](#).

Table 70. QuadSPI timing events

| Number | Event |
|--------|--|
| 1 | Last address out |
| 2 | Address captured at flash memory |
| 3 | Data out from flash memory |
| 4 | Ideal data capture edge |
| 5 | Delayed data capture edge with QSPI_SMPR=0x0000_000X |
| 6 | Delayed data capture edge with QSPI_SMPR=0x0000_002X |
| 7 | Delayed data capture edge with QSPI_SMPR=0x0000_004X |
| 8 | Delayed data capture edge with QSPI_SMPR=0x0000_006X |


Figure 42. QuadSPI output timing

Figure 43. QuadSPI input timing

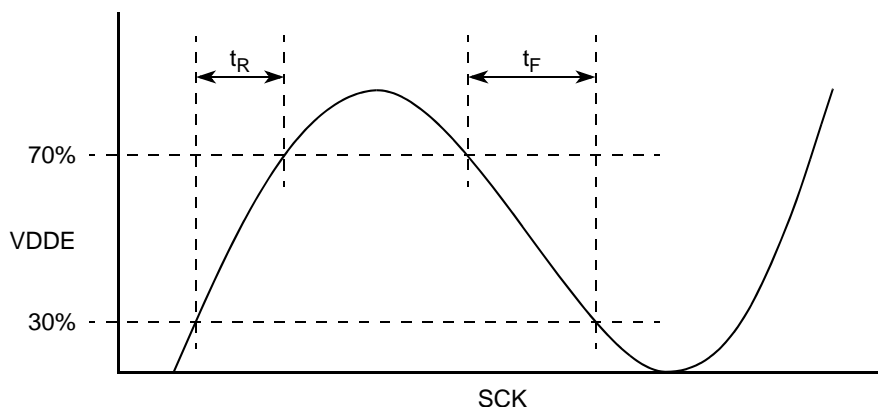


Figure 44. QuadSPI clock profile

4.18.13 TCON/RSDS timing

The following notes apply to Table 71:

- Measurement condition: $V_{dde}/V_{dd33} = 3.3 \text{ V} \pm 10\%$, $V_{dd} = 1.2 \text{ V} \pm 10\%$, $V_{ss}/V_{sse} = 0 \text{ V}$, $T = -40 \text{ to } 105^\circ\text{C}$
- Termination: $100 \Omega \pm 5\%$
- VREFH_RSDS terminations of $47 \mu\text{F}$

Table 71. TCON/RSDS timing

| Symbol | C | Parameter | Condition | Value | | | Unit | SpecID | |
|----------------------|----|-----------|-----------------------------------|--|------|------|------|---------------|-------|
| | | | | Min | Typ | Max | | | |
| V_{OD} | CC | C | Differential output voltage | RSDS mode | 391 | — | 471 | mV | A14.1 |
| V_{OS} | CC | C | Common mode voltage | 100 Ω termination between Pad_p and Pad_n | 1.17 | — | 1.4 | V | A14.2 |
| t_r | CC | C | Rise time | Transition from 20% to 80% | 606 | — | 844 | ps | A14.3 |
| t_f | CC | C | Fall time | Transition from 20% to 80% | 607 | — | 842 | ps | A14.4 |
| t_{plh} | CC | D | Propagation delay, low to high | — | — | 2.65 | — | ns | A14.5 |
| t_{phl} | CC | D | Propagation delay, high to low | — | — | 2.47 | — | ns | A14.6 |
| t_{dz} | CC | D | Start-up time | — | — | 200 | — | μs | A14.7 |
| $t_{skew}^{1\ 2\ 3}$ | CC | C | Skew between different RSDS lines | Max and min skew between clock and data pads | — | — | — | ps | A14.8 |

¹ There are eight programmable bits to provide 256 different skew numbers with various combinations of these bits.

² Default value of all the eight skew options are all “1”.

³ All “0” combination of eight bits is not valid.

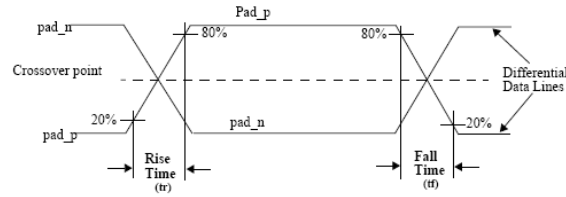


Figure 45. Rise/fall transition, part 1

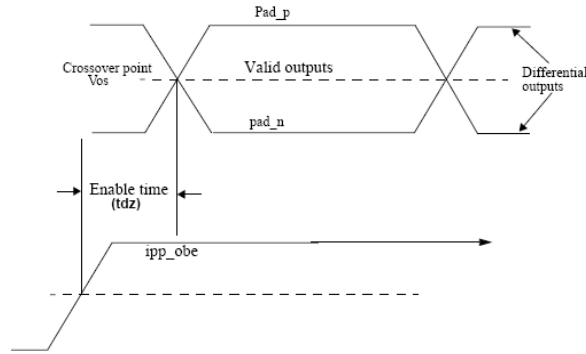


Figure 46. Rise/fall transition, part 2

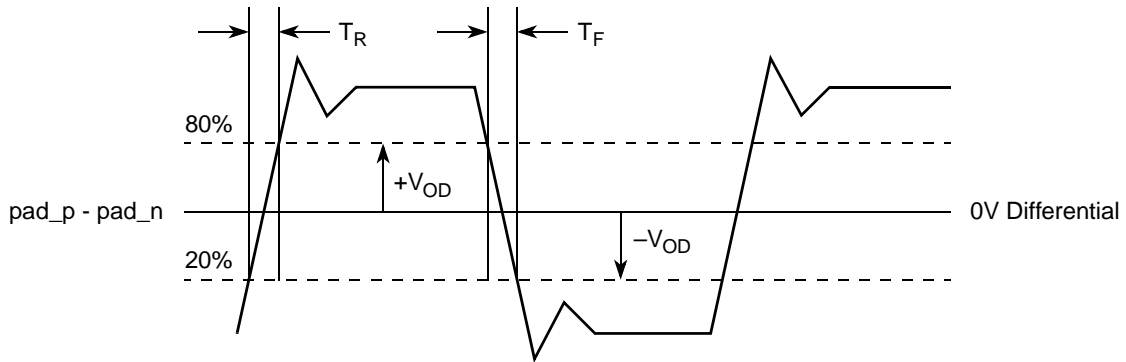
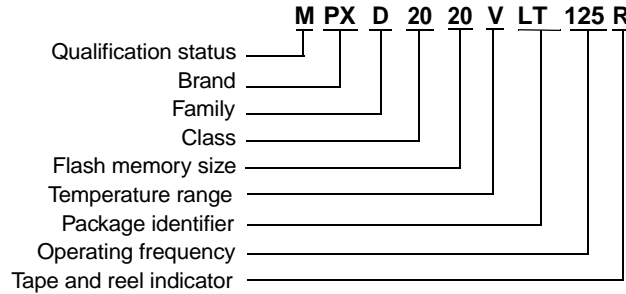


Figure 47. Illustration of t_r , t_f , and V_{OD}

5 Package mechanical data

6 Ordering information



Qualification status

P = Pre-qualification (engineering samples)
M = Fully spec. qualified, general market flow
S = Fully spec. qualified, automotive flow

Family

D = Display Graphics
N = Connectivity/Network
R = Performance/Real Time Control
S = Safety

Flash Memory Size

05 = 512 KB
10 = 1 MB

Temperature range

V = -40 °C to 105 °C
(ambient)

Package identifier

LU = 176 LQFP
LT = 208 LQFP
VU = 416 PBGA

Operating frequency

80 = 80 MHz
120 = 120 MHz

Tape and reel status

R = Tape and reel
(blank) = Trays

Note: Not all options are available on all devices. See [Table 72](#) for more information.

Figure 48. PXD20 orderable part number description

Table 72. PXD20 orderable part number summary

| Part number | Flash/SRAM | Package | Speed (MHz) |
|----------------|--------------|--------------------------|-------------|
| MPXD2020VLU125 | 2 MB / 64 KB | 176 LQFP (24 mm x 24 mm) | 125 |
| MPXD2020VVU125 | 2 MB / 64 KB | 416 PBGA (27 mm x 27 mm) | 125 |
| MPXD2020VLT125 | 2 MB / 64 KB | 208 LQFP (28 mm x 28 mm) | 125 |

7 Revision history

Table 73. Revision history

| Revision | Date | Description |
|----------|-------------|---|
| 1 | 30 Sep 2011 | Initial release. |
| 2 | 27 Apr 2012 | <p>Editorial updates and improvements throughout the document.</p> <p>In Figure 4 (416 TEPBGA pinout), corrected pin P25 to VSS.</p> <p>In Section 3, System design information, added Figure 6 (Power-up sequencing) and Figure 7 (Power-down sequencing).</p> <p>In Table 10 (Recommended operating conditions (3.3 V)), changed maximum T_j from 150 °C to 140 °C.</p> <p>In Table 11 (Recommended operating conditions (5.0 V)), changed maximum T_j from 150 °C to 140 °C.</p> <p>In Table 16 (Voltage regulator electrical characteristics):</p> <ul style="list-style-type: none"> — Changed maximum T_j from 150 °C to 140 °C. — Changed V_{DD12} post-trimming minimum value from 1.270 V to 1.26 V and maximum value from 1.280 V to 1.29 V. — Removed footnote: “All values in this table are PRELIMINARY.” <p>In Section 4.7.1, Voltage regulator electrical characteristics, added Table 17 (Low-power voltage regulator electrical characteristics) and Table 18 (Ultra low-power voltage regulator electrical characteristics).</p> <p>In Table 19 (Low voltage monitor electrical characteristics), updated the following values:</p> <ul style="list-style-type: none"> — V_{LVDHV3H} maximum from 2.8 V to 2.9 V — V_{LVDHV3L} minimum from 2.7 V to 2.5 V — V_{LVDHV5H} maximum from 4.37 V to 4.4 V — V_{LVDHV5L} minimum from 4.2 V to 3.9 V <p>In Table 20 (DC electrical characteristics):</p> <ul style="list-style-type: none"> — Updated I_{DDRUN} typical values for Dual Display Drive from 235 to 275 mA; for Single Display Drive from 306 to 240 mA. — Updated typical I_{DDHALT} current at 25 °C from 12.67 mA to 17.5 mA. — Updated typical I_{DDHALT} current at 105 °C from 33.1 mA to 35 mA. — Updated maximum I_{DDHALT} current at 25 °C from 18.26 mA to 21.5 mA. — Updated maximum I_{DDHALT} current at 105 °C from 36.41 mA to 43.5 mA. — In I_{DDHALT} specification, changed T_B = 105 °C to T_A = 105 °C. <p>In Table 40 (Fast internal oscillator electrical characteristics), removed ΔRCMTRIM specification.</p> <p>In Table 41 (Slow internal RC oscillator electrical characteristics), removed ΔRCMTRIM specification.</p> <p>In Table 44 (ADC electrical characteristics), added offset error value of 0.5 typical, and gain error value of 0.6 typical. Removed minimum and maximum values for both specifications.</p> <p>In Section 4.18.5, DRAM interface:</p> <ul style="list-style-type: none"> — Added Table 58 (LPDDR, DDR, and DDR2 (DDR2-250) SDRAM timing specifications). — Removed Table 56 (AC Specs for SDR mode (V_{DDE_DR} = 3.3 V)), Table 57 (AC Specs for DDR2 mode (V_{DDE_DR} = 1.8 V)), Table 58 (AC Specs for DDR1 mode (V_{DDE_DR} = 2.5 V)), and Table 59 (AC Specs for LPDDR mode (V_{DDE_DR} = 1.8 V)). |

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